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# **DIELECTRIC RELAXATION AND ROCK GEOPHYSICAL CHARACTERISTICS**

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Final Report

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13. ABSTRACT

Electric and dielectric rock parameters were measured using an analog/digital computer for rapid evolution and data display. In common with many dielectrics, the imaginary part of dielectric constant established a circular arc when plotted against the real part at a series of frequencies. A conformal arc with the same relaxation time was obtained when the reactive component of impedance was plotted as a function of the resistive component. The data were verified on various rock samples of basalt, granite and quartzite in the frequency range 1Hz to 2kHz. Effects of rock pretreatments in water and in sodium hydroxide solutions upon their electric and dielectric parameters were studied. The highest sensitivity for water detection in rocks was realized by extrapolating the circular arc to determine the real dielectric constant at zero frequency limit. Electrode polarization and double layer effects had been explained in terms of an electrical model that also simulated the rock impedance and dielectric relaxation behaviours.

14 KEY WORDS	LINK A		LINK B		LINK C	
	ROLE	WT	ROLE	WT	ROLE	WT
Dielectric						
Rock						
Impedance						
Resistivity						
Frequency						
Permittivity						
Relaxation						
Polarization						
Basalt						
Granite						
Quartzite						
Circular-arc						
Argand Diagram						
Cole-Cole						

**FINAL REPORT**  
**DIELECTRIC RELAXATION AND ROCK GEOPHYSICAL CHARACTERISTICS**

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The views and conclusions contained in this document are those of the author and should not be interpreted as necessarily representing the official policies, either express or implied, of the Advanced Research Projects Agency of the U. S. Government.

CONTENTS		Page
SECTION I	PROJECT OBJECTIVES AND SIGNIFICANT RESULTS	1-1
	Research Objectives	1-1
	Significant Results	1-1
SECTION II	EXPERIMENTAL TECHNIQUE	2-1
	Experimental Setup	2-1
	Procedure	2-4
	Sample Preparation	2-6
	Validation of the Measurement Technique	2-7
SECTION III	ROCK IMPEDANCE AND ELECTRODE EFFECTS	3-1
	Impedance Parameters of Dresser Basalt	3-1
	Impedance Parameters of Granite	3-4
	Impedance Parameters of Quartzite	3-5
	Effect of Humidity on Rock Impedance	3-6
	Electrode Effects in Impedance Measurement	3-7
	Electrode Impedance in Cylindrical Rocks	3-8
SECTION IV	TRANSFORMATION OF COMPLEX IMPEDANCE DATA TO COMPLEX PERMITTIVITY DATA	4-1
SECTION V	RESISTIVITY AND DIELECTRIC CONSTANT OF ROCKS	5-1
SECTION VI	EFFECT OF WATER AND SODIUM HYDROXIDE PRETREATMENT ON ROCK ELECTRIC AND DIELECTRIC PARAMETERS	6-1
	Water Treatment of Basalt	6-3
	Pretreatment of Basalt in Sodium Hydroxide	6-16
	Effect of Water Soaking on Quartz Electric Parameters	6-31
SECTION VII	MODELS TO SIMULATE THE ELECTRIC AND DIELECTRIC ROCK BEHAVIOR	7-1
	Electrical Analog With One Frequency Dependent Resistance	7-4
	Conversion of Impedance Data to Complex Permittivity in a Real System	7-9
	Evaluation of the Model Parameter, $r_1$ for Basalt	7-13
	Correlation of Impedance Polarization Artifacts with the Model	7-17

	Correlation of $r_1$ With the Warburg Polarization	7-18
	Physical Significance of $r_1$	7-22
SECTION VIII	TECHNICAL REPORT SUMMARY AND RECOM- MENDATIONS FOR FUTURE WORK	8-1
	Technical Report Summary	8-1
	Recommendations for Future Work	8-2
SECTION IX	COMPUTER ALGORITHMS	9-1
	Data Processing and Computer Programs	9-1
	Sampling and A-D Conversion	9-1
	Electrode Corrections	9-3
	Loading Experimental Data	9-6
	Data Selection	9-7
	Corrections to Data	9-8
	Fitting Circle to Data Points	9-9
	Miscellaneous Parameters	9-12
	Data Processing Flow Diagram Program Logic	9-13
SECTION X	REFERENCES	10-1
APPENDIX A	PARALLEL TO SERIES TRANSFORMATION OF ELECTRICAL MODELS WITH A SINGLE TIME CONSTANT AND FREQUENCY-INDEPENDENT COMPONENTS	
APPENDIX B	RELAXATION TIME AND TURNOVER FREQUENCY OF A MODEL WITH A SINGLE TIME CONSTANT AND ONE FREQUENCY-DEPENDENT POLARIZATION RESISTANCE	

## ILLUSTRATIONS

Figure		Page
1-1	Computer Display of the Impedance Circular Arc for a Dresser Basalt Sample	1-2
1-2	Computer Display of the Impedance Circular Arcs for Granite Samples	1-3
1-3	Computer Display of the Impedance Circular Arc for a Large Diameter Quartzite Disc Sample	1-4
1-4	Variation of the Polarization Constant $g$ for Basalt Rock with the Percentage of Sodium Hydroxide in the Pretreating Solution	1-6
2-1	Schematic of Experimental Setup	2-2
2-2	Computer Program - Sequence of Events	2-5
3-1	Argand Circular-Arc Plot for Dresser Basalt	3-3
3-2	Dispersion of Impedance Components of Dresser Basalt and the Relaxation Time(s)	3-3
3-3	Effect of Moisture on the Impedance Semicircle of Basalt (II)	3-7
3-4	Specific Impedance Parameters for: (A) Basalt; (B) Granite; and (C) Quartzite	3-13
4-1	Transformation of Parallel Circuit with Frequency Independent Parameters to Isoimpedic Series Circuit Gives a Semicircle in the Argand Diagram	4-5
5-1	Cole-Cole Plot of Dresser Basalt Data on 0.30-cm Slice	5-4
5-2	Dielectric Constant of Dresser Basalt as a Function of Frequency	5-4
5-3	Cole-Cole Plot of Dresser Basalt Data on 0.61-cm Slice	5-5
5-4	Dielectric Constant of Dresser Basalt as a Function of Frequency	5-5
6-1	Variation of Impedivity with Frequency for an Untreated Basalt Sample	6-14
6-2	Variation of Impedivity with Frequency for Basalt Samples Following a 23-hour Water Soak	6-14
6-3	Variation of Impedivity with Frequency for Basalt Samples Following a 77-hour Water Soak	6-15
6-4	Variation of Rock Impedivity with the Duration Time of Water Treatment for Three Samples of Basalt	6-15



6-5	Variation of Impedivity with Frequency for the Basalt Samples after 23-hour Pretreatment in 1% NaOH	6-26
6-6	Variation of Impedivity with Frequency for Basalt Samples Following a 23-hour Pretreatment in 5% NaOH	6-26
6-7	Variation of Impedivity with Frequency for Basalt Samples Following a 23-hour Pretreatment in 10% NaOH	6-27
6-8	Variation of Impedivity with Sodium Hydroxide Concentration in the Pretreating Solution	6-29
6-9	Semilogarithmic Plot of Basalt Impedivity with Concentration of Sodium Hydroxide in the Pretreating Solution	6-30
6-10	Variation of Parameter $\lambda$ with Rock Thickness	6-30
6-11	Variation of Impedivity with Frequency for the Untreated Quartz Samples	6-41
6-12	Variation of Impedivity with Frequency for the Quartz Following 24-hour Soak	6-41
6-13	Variation of Impedivity with Frequency for the Quartz (II) Following 75-hour Soak	6-42
6-14	Variation of Quartz Resistivity with the Duration of Soaking Time in Water	6-45
6-15	Variation of Quartz Dielectric Constant ( $\epsilon_0$ ) with Its Soaking Time in Water	6-46
7-1	Electrical Model That Produces a Circular Arc Plot	7-5
7-2	Circular Arc Plot Between Equivalent $X_S$ and $R_S$ of the Model	7-5
7-3	Variation of the Basalt Constant $g$ with the Percentage of Sodium Hydroxide in the Pretreating Solution	7-16
7-4	Effect of Length of Rock Cylinder on the Parameter $g$	7-16
7-5	Relationship of Model Resistor $r_1$ to the Warburg Polarization Resistance	7-19
8-1	Variation of Impedance Parameters with Log Frequency for Dresser Basalt (IV) at Room Temperature, 22°C	8-6
8-2	Variation of Impedance Parameters with Log Frequency for Dresser Basalt (IV) at 0°C	8-7

# TABLES

Table		Page
2-1	Frequency Variation of the Impedance Parameters of the $R_pC_p$ Unit	2-8
2-2	Frequency Variation of Basalt (I) Impedance Parameters	2-9
3-1	Electrode Corrections for Basalt (II)	3-11
3-2	Electrode Corrections for Granite	3-11
5-1	Impedance and Dielectric Data on Basalt (III). 0.53-cm Slice	5-2
5-2	Impedance and Dielectric Data on Basalt (III). 0.61-cm Slice	5-3
5-3	Electric and Dielectric Parameters of Dresser Basalt (III)	5-7
5-4	Impedance and Dielectric Data on Quartzite (II). 0.96-cm slice	5-8
6-1	Computer Output for Electric and Dielectric Data of Untreated Basalt (Sample $K_1$ )	6-4
6-2	Computer Output for Electric and Dielectric Data of Untreated Basalt (Sample $K_2$ )	6-5
6-3	Computer Output for Electric and Dielectric Data of Untreated Basalt (Sample $K_4$ )	6-6
6-4	Computer Output for Electric and Dielectric Data of Basalt Sample $K_1$ Following 23-Hour Water Soak	6-7
6-5	Computer Output for Electric and Dielectric Data of Basalt Sample $K_2$ Following 23-Hour Water Soak	6-8
6-6	Computer Output for Electric and Dielectric Data of Basalt Sample $K_4$ Following 23-Hour Water Soak	6-9
6-7	Computer Output for Electric and Dielectric Data of Basalt Sample $K_1$ Following 72-Hour Water Soak	6-10
6-8	Computer Output for Electric and Dielectric Data of Basalt Sample $K_2$ Following 72-Hour Water Soak	6-11
6-9	Computer Output for Electric and Dielectric Data of Basalt Sample $K_4$ Following 72-Hour Water Soak	6-12
6-10	Effect of Water Pretreatment on Selected Electric and Dielectric Parameters of Basalt	6-13
6-11	Effect of Water Soaking on Impedivity of Basalt at 1 Hz	6-16
6-12	Computer Output for Electric and Dielectric Data of Basalt Sample $K_1$ Pretreated in 1% NaOH for 23 Hours	6-17

6-13	Computer Output for Electric and Dielectric Data of Basalt Sample K <sub>2</sub> Pretreated in 1% NaOH for 23 Hours	6-18
6-14	Computer Output for Electric and Dielectric Data of Basalt Sample K <sub>4</sub> Pretreated in 1% NaOH for 23 Hours	6-19
6-15	Computer Output for Electric and Dielectric Data of Basalt Sample K <sub>1</sub> Pretreated in 5% NaOH for 23 Hours	6-20
6-16	Computer Output for Electric and Dielectric Data of Basalt Sample K <sub>2</sub> Pretreated in 5% NaOH for 23 Hours	6-21
6-17	Computer Output for Electric and Dielectric Data of Basalt Sample K <sub>4</sub> Pretreated in 5% NaOH for 23 Hours	6-22
6-18	Computer Output for Electric and Dielectric Data of Basalt Sample K <sub>1</sub> Pretreated in 10% NaOH for 23 Hours	6-23
6-19	Computer Output for Electric and Dielectric Data of Basalt Sample K <sub>2</sub> Pretreated in 10% NaOH for 23 Hours	6-24
6-20	Computer Output for Electric and Dielectric Data of Basalt Sample K <sub>4</sub> Pretreated in 10% NaOH for 23 Hours	6-25
6-21	Effect of Pretreatment in NaOH for 23 Hours	6-28
6-22	Exponential Decrease of Impedivity with Electrolyte Concentration	6-31
6-23	Computer Output for Electric and Dielectric Data of Untreated Quartz Sample M <sub>1</sub>	6-32
6-24	Computer Output for Electric and Dielectric Data of Untreated Quartz Sample M <sub>2</sub>	6-33
6-25	Computer Output for Electric and Dielectric Data of Untreated Quartz Sample M <sub>3</sub>	6-34
6-26	Computer Output for Electric and Dielectric Data of Untreated Quartz Sample M <sub>1</sub> Following a 24-Hour Water Soak	6-35
6-27	Computer Output for Electric and Dielectric Data of Untreated Quartz Sample M <sub>2</sub> Following a 24-Hour Water Soak	6-36
6-28	Computer Output for Electric and Dielectric Data of Untreated Quartz Sample M <sub>3</sub> Following a 24-Hour Water Soak	6-37
6-29	Computer Output for Electric and Dielectric Data of Quartz Sample M <sub>1</sub> Following a 75-Hour Water Soak	6-38
6-30	Computer Output for Electric and Dielectric Data of Quartz Sample M <sub>2</sub> Following a 75-Hour Water Soak	6-39

6-31	Computer Output for Electric and Dielectric Data of Quartz Sample M <sub>3</sub> Following a 75-Hour Water Soak	6-40
6-32	Effect of Water Pretreatment on Some Impedance and Dielectric Parameters of Quartz (II)	6-44
7-1	Equivalent Series Resistance and Reactance for Electrical Model of Figure 7-1	7-6
7-2	Basalt Parameters of the Equation $r_1 = g/f^n$	7-15
7-3	Basalt Parameters of the Equation $r_1 = \frac{g_1}{\sqrt{f}} + \frac{g_2}{f}$	7-21
8-1	Impedance Data on Basalt (IV) at 22°C	8-4
8-2	Impedance Data on Basalt (IV) at 0°C	8-5

## SECTION I

### PROJECT OBJECTIVES AND SIGNIFICANT RESULTS

#### RESEARCH OBJECTIVES

Objectives of this research were to adopt rock impedance and dielectric parameters as indicators as well as predictors of their geophysical characteristics, of presence of water, entrapped gases, and rock fractures. Dielectric relaxation mechanisms were utilized to describe the impedance and dielectric characteristics of representative rocks. Electrical models to simulate rock impedance and dielectric dispersion were used to correlate rock properties with the model parameters. Data taken at low frequencies ( $<2\text{kHz}$ ) yielded information that is pertinent to rock structure and geophysical characteristics, while the high-frequency data would contribute a valuable input to rock fragmentation by dielectric heating. Research covered in this report was confined to the low-frequency range and to the development of relationships between impedance and dielectric permittivity data on rocks.

#### SIGNIFICANT RESULTS

Rapid measurement and display of the low-frequency impedance parameters of basalt, granite, and quartzite was accomplished by a novel technique in which the rock under investigation was placed in the feedback path of an operational amplifier, and an analog/digital computer was used for rapid evolution and data display. The data obtained adhered closely to the theoretically predicted circular arc diagram when the equivalent series reactance was plotted as a function of the equivalent series resistance at various frequencies from 0.05 Hz to 2 kHz. The photographs in Figures 1-1, 1-2, and 1-3 show the actual output for the impedance parameters of basalt, granite, and quartzite rock samples as displayed in the Argand diagram.

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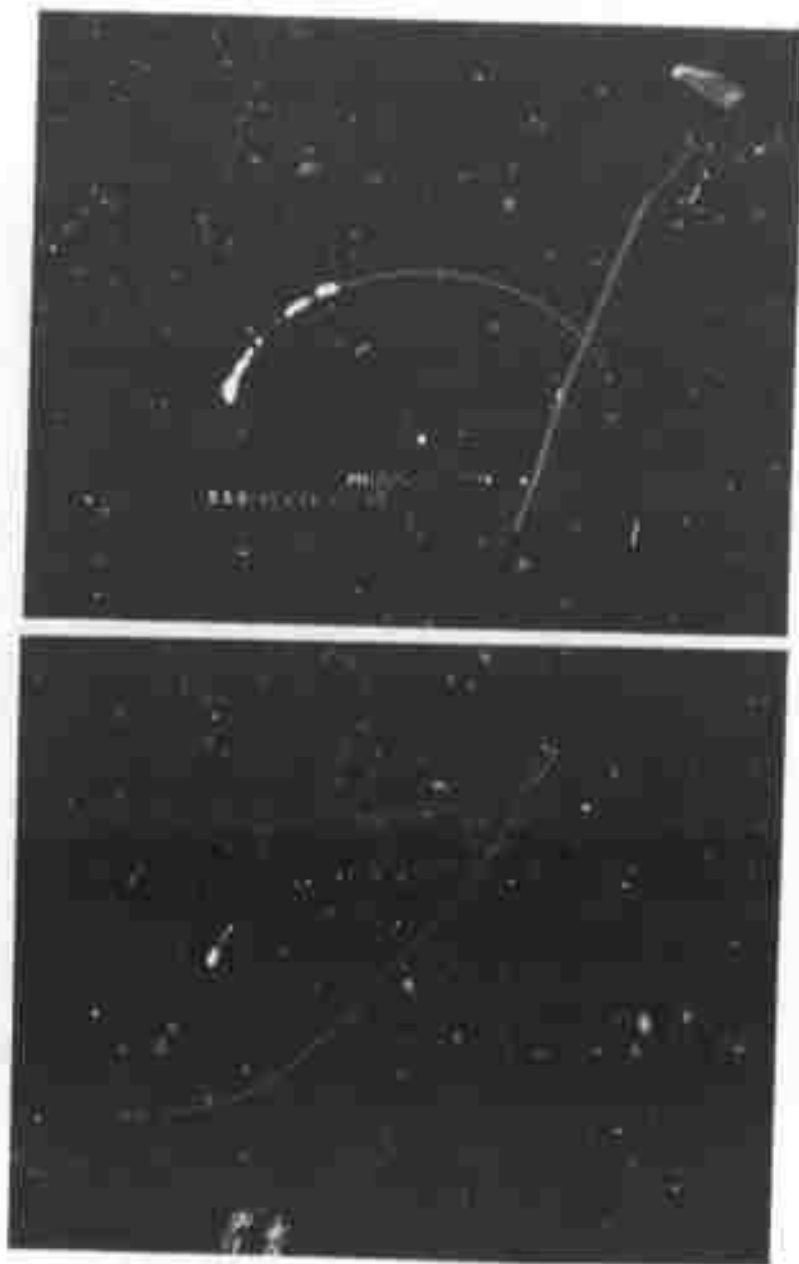


Figure 1-2. Computer Display of the Impedance Circular Arcs for Granite Samples. Top photograph is for a long granite cylinder (4.41 cm). Bottom photograph is for a thin slice of the granite cylinder (0.15 cm). Points (+) represent variation of reactance with resistance at a given frequency. Dotted curves are arcs of the computer data-fitted circle in the least square sense.

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Figure 1-3. Computer Display of the Impedance Circular Arc for a Large Diameter Quartzite Disc Sample. Points (+) represent experimental variation of reactance with resistance at a given frequency. Dotted curve is an arc of the computer data-fitted circle in the least square sense.

A new "bracketing" technique was developed to extract the rock dielectric constants from the corrected and normalized impedance parameters. Details of this novel technique are presented in Sections IV and VII.

An electrical model that describes the observed behavior of rock impedance data has been developed and is reported in Section VII. The model permits quantitative evaluation and correlation of observed rock impedance data and their geophysical characteristics. The model also elucidates for the first time the inherent complications that arise from electrode impedance and rock/electrode double layer polarization effects by defining a polarization parameter,  $g$ .

The highest sensitivity for water detection in rocks was obtained by extrapolating the real component of the dielectric constant to the zero frequency limit. The effects of rock pretreatment in water and in sodium hydroxide solutions upon their electric and dielectric parameters are covered in Section VI. Variation of the polarization constant,  $g$ , for a basalt rock with its sodium (mobile) ion content is shown in Figure 1-4. Lower polarization constants correspond to more significant electrode double-layer polarization artifacts, because this type of double-layer polarization impedance appears to be in parallel with the rock impedance components. Hence, the presence of larger quantities of sodium ions increases the double-layer polarization effects in addition to increasing the rock ohmic conductivity.



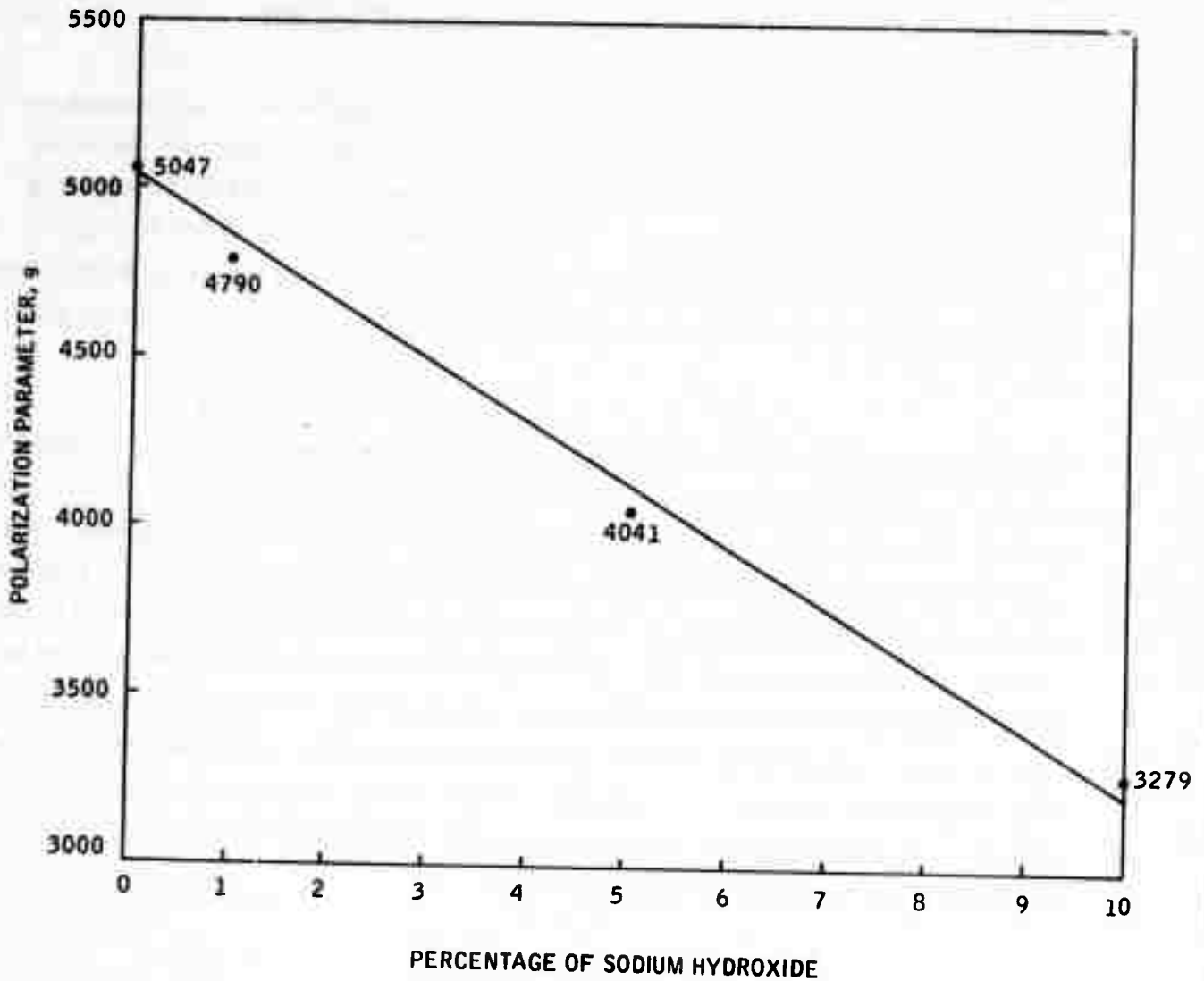


Figure 1-4. Variation of the Polarization Constant  $g$  for Basalt Rock with the Percentage of Sodium Hydroxide in the Pretreating Solution. Pretreatment Time = 23 hours.

## SECTION II

### EXPERIMENTAL TECHNIQUE

The most common methods of determining the electric and dielectric properties of rocks involve bridge, resonance, and heterodyne techniques. A comprehensive description of these and similar techniques is given in References 1 and 2.

During this program a new direct-comparison method was developed that involved placing the rock sample in the feedback loop of an operational amplifier. This method has the advantage that data can be taken at extremely low frequencies where conventional methods become too unstable. Furthermore, the data were processed by a computer and displayed directly. In this technique, impedance data processing involved time-domain sampling and a discrete Fourier transform to the frequency domain.

#### EXPERIMENTAL SETUP

The basic approach to the experimental determination of the rock impedance is the use of the rock as a feedback impedance in an operational amplifier. Thus, for a known input signal and resistance, the rock impedance can be determined from the amplifier output signal. This technique lends itself to convenient, on-line signal analysis through the use of analog-to-digital conversion equipment.

Figure 2-1 illustrates the experimental setup in simplified form. Basically, a sinusoid at known frequency drives the amplifier containing the rock, while an in-phase square wave generated simultaneously with the sinusoid is used to clearly define the period of the waveform.

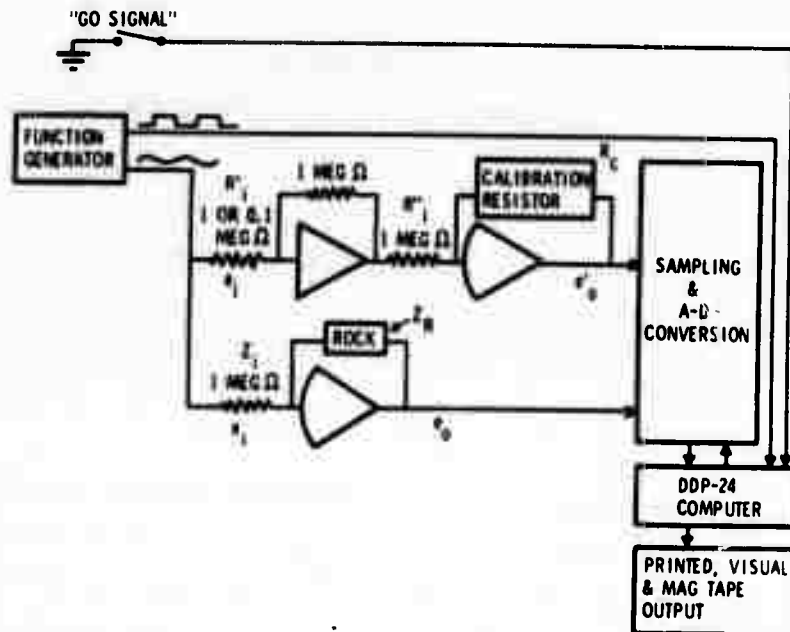


Figure 2-1. Schematic of Experimental Setup

The output from the rock amplifier is sampled over some interval consistent with the signal frequency and converted to digital form. At this stage a DDP-24 computer performs a discrete Fourier transform and computes the equivalent series resistance and reactance for the signal.

Included within the analog circuitry is an amplifier having a known fixed (calibration) resistor in its feedback loop. The signal from this amplifier is analyzed simultaneously with the rock signal and provides a reference signal of known amplitude and phase.

Another amplifier is provided just ahead of the calibration amplifier to provide a means of easily changing the gain through the calibration branch without changing the calibration resistor itself.

The voltage output,  $e_o$  (Figure 2-1), from the amplifier having the rock as its feedback impedance is given by

$$e_o = - \frac{Z_R}{Z_i} e_i, \quad e_o = -Z_R e_i \quad (2-1)$$

because  $Z_i = 1$  megohm and  $Z_R$  is in megohms.

Similarly, the output  $e_o'$  from the calibration amplifier is given by

$$e_o' = - \frac{R_c}{R_i' R_i''} e_i \quad (2-2)$$

The amplitude of the complex impedance  $Z_R$  is thus given by

$$|Z_R| = \frac{|e_o|}{|e_o'|} \left( \frac{R_c}{R_i' R_i''} \right) \quad (2-3)$$

where  $e_o$  and  $e_o'$  are determined from a Fourier analysis of the output voltages  $e_o$  and  $e_o'$ .

The Fourier analysis also provides the phase angle  $\phi$  between output voltage and current. Thus, the series resistance and reactance are calculated from

$$R_s = |Z_R| \cos \phi, \text{ and } X_s = |Z_R| \sin \phi \quad (2-4)$$

A least-squares circle fit is also automatically made for the  $R_s$  and  $X_s$  data and displayed along with the  $R_s$  and  $X_s$  data on a CRT screen. In addition, all data are permanently stored on magnetic tape for future call back.

## PROCEDURE

Sinusoidal signals from the function generator of a discrete frequency from 10 Hz to 1 MHz were used to drive the current electrodes. In addition, an in-phase square wave generated simultaneously with the sinusoid served to clearly delineate the period of the waveform so that its frequency could be easily measured. The excitation current, output voltage, square wave, and "go" signal were led directly to the computer for on-line processing, or else stored intermediately on FM magnetic tapes for subsequent playback when off-line processing becomes necessary. The results were printed, punched on paper tape, and digitally recorded on magnetic tape.

All computations were performed in the laboratory on a DDP-24 computer, which has an 8000-core storage memory bank of 24-bit words. Because this computer is oriented in design for process control, it is ideally suited for on-line measurements of the sort described here. Peripheral equipment contained sample and hold circuitry, a multiplexer, and an analog-to-digital converter as input channels, and a typewriter and paper tape punch for hard copy output.

The operation of the program is outlined in Figure 2-2. After the program was loaded and started, it awaited a "go" signal from the operator. Because complete freedom was desired in selecting frequency as an independent variable, it was necessary for the computer to adjust its own sampling rate accordingly every time the "go" signal was given. The excitation period was measured by determining the interval between successive positive sloped zero crossings, using machine cycles as the "yardstick". A minimum-measurement interval of a few milliseconds, measured to the nearest microsecond increment, was set and the number of cycles occurring in it was noted. With the excitation frequency and a sampling period "window" determined, it was possible to specify a sampling rate and the weighting coefficients of a discrete Fourier transform for harmonic analysis of the data. The waveforms across the

2-5

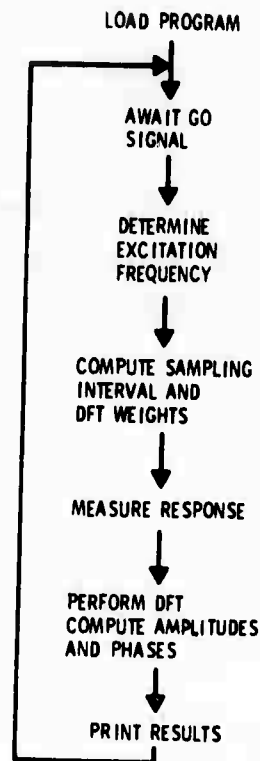


Figure 2-2. Computer Program - Sequence of Events

current source and the rock sample were measured simultaneously and stored internally. From these, the d-c first and second harmonic terms were computed using the above-determined discrete Fourier transform coefficients.

Having determined the frequency, resistance and reactance, a circle was fitted to the data under the condition of minimum deviation (least square calculation). The center of the circle ( $R_0$ ,  $X_0$ ) was found such that the square of the deviations,  $\Delta$ , was a minimum.

$$\Delta = \sum_{i=1}^n (r_i - \bar{r})^2 \quad (2-5)$$

where  $n$  is the number of sampling frequencies at which impedance was measured,  $\bar{r}$  is the average circle radius, and  $r_i$  is given by

$$r_i = \left[ (R_o - R_i)^2 + (X_o - X_i)^2 \right]^{1/2} \quad (2-6)$$

This was accomplished via a gradient descent in two-dimensional  $R_o$ ,  $X_o$  parameter space. For graphical display, the equivalent series resistances and reactances were computed at each of the sampling frequencies.

### Sample Preparation

With the exception of the application of electrode material and the pretreatment experiments in Section VI, all measurements have been made on rocks "as received" from the customer.

The electrodes were applied to the flat surfaces of the cylindrical samples. An epoxy-based conductive adhesive\* was applied in a thin coat and allowed to dry for at least two days at room temperature.

Copper leads made from thin sheet stock were laid on top of the electrode material and the rock was clamped tightly between two plates of printed circuit board to secure electrical contact with the rock.

The procedures described here for computing rock electric parameters are valid for isotropic specimens only. It was shown by Spinner and Tefft (Ref. 3) that rock elastic moduli equations can be applied to a polycrystalline material if the individual grains of the material are randomly oriented and distributed, and are not larger than one-third of the smallest dimension of the specimen. Such a material may be considered to be isotropic on a macroscopic scale, even though the individual grains themselves are anisotropic.

\*Eccobond Solder V-91, Emerson and Cumming, Inc., Dielectric Materials Division, Canton, Massachusetts.

### Validation of the Measurement Technique

To check the validity of rock impedance data obtained with the computer technique, some results were compared with those obtained with traditional compensation techniques using a General Radio-type 1650 CRL bridge. Measurements were performed on a basalt sample (I) at a frequency of 1 kHz. With the bridge technique a series capacitance of 28 picofarads and a dissipation factor,  $D$ , of 0.36 at 1 kHz were measured. Transformation from a series domain to an isoimpedic system in the parallel domain yields

$$R_s R_p = X_s X_p = R_s^2 + X_s^2 \quad (2-7)$$

The dissipation factor,  $D$ , is defined as

$$D = \frac{1}{\omega R_p C_p} = -\frac{X_p}{R_p} = -\frac{R_s}{X_s} \quad (2-8)$$

From Equations (2-7) and (2-8) one obtains

$$\frac{X_p}{X_s} = 1 + D^2 = \frac{C_s}{C_p} \quad (2-9)$$

Hence

$$C_p = \frac{C_s}{1 + D^2} \quad (2-10)$$

From these equations, one calculates a parallel capacitance,  $C_p$ , of 25 picofarads and a parallel resistance,  $R_p$ , of 17.7 megohms. The series parameters computed at 1 kHz would be -5.72 megohms for the reactance,  $X_s$ , and 2.04 megohms for the resistance,  $R_s$ .



Measurements with the direct comparison on-line computer technique for the same basaltic rock sample gave the values  $R_s = 2.77$ ,  $X_s = -5.28$  megohms and  $\phi = -62.3$  degrees, respectively. The series reactances,  $-5.72$  and  $-5.28$  megohms obtained with the bridge and the new techniques, respectively, differ by about 8 percent. However, the series resistance  $2.04$  megohms measured with the bridge deviates by about 26 percent from the value  $2.77$  megohms measured with the present technique.

Despite the large deviation in  $R_s$ , and considering the lead impedances and stray capacitances which were not taken into account, these results nevertheless lend credence to the general validity of the new measuring technique. It is generally recognized that bridge balancing methods are difficult at very low frequencies, and hence, their data would be susceptible to gross errors at these frequencies. It appears, therefore, that the new direct-comparison technique yields reliable data in the low-frequency range.

On the assumption that rock impedance can be represented by the simple parallel  $R_p C_p$  unit measured with the bridge, we constructed a model from the nearest available components in the laboratory of  $18$  megohms for  $R_p$  and  $25$  picofarads for  $C_p$ . A computer run was performed with this  $R_p C_p$  unit replacing the rock. This system gave the data in Table 2-1 for the series parameters at four frequencies.

Table 2-1. Frequency Variation of the Impedance Parameters of the  $R_p C_p$  Unit ( $R_p = 18$  megohms,  $C_p = 25$  picofarads)

Frequency (Hz)	$R_s$ (megohms)	$-X_s$ (megohms)	$-\phi$ (degrees)
1000	2.66	4.60	59.9
100	16.22	4.93	16.9
10	17.84	0.61	2.0
1	17.89	0.08	0.2

As predicted, the series resistance approaches the model  $R_p$  value of 18 megohms as the frequency approaches zero. The time constant of this unit is equal to  $R_p C_p = 45$  milliseconds. This corresponds to a turnover frequency of about 360 Hz. Around this characteristic frequency, the dispersion in  $R_s$  assumes rapidly decreasing values, while the dispersion in  $X_s$  assumes a flat maximum (see Figure 3-2). Hence,  $R_s$  will be subjected to the greatest error at frequencies between 100 and 1000 ohms by slight changes in the frequency of measurement, while  $X_s$  will be somewhat insensitive to such changes. Frequencies reported in this work are the nominal ones; for example, the 1000 Hz was actually sampled by the computer as 1007.33 Hz.

When the simple  $R_p C_p$  unit was replaced by the basaltic rock sample in the feedback of the operational amplifier, the data in Table 2-2 were obtained.

Table 2-2. Frequency Variation of Basalt (I) Impedance Parameters

Frequency (Hz)	$R_s$ (megohms)	$-X_s$ (megohms)	$-\phi$ (degrees)
1000	2.77	5.28	62.3
100	16.99	32.15	62.1
10	99.88	110.76	48.0
1	355.84	197.30	29.0

As expected, the values obtained at 1 kHz are in good agreement with those measured with the bridge method. The data at the lower frequencies of 100, 10, and 1 Hz deviated markedly. Thus, a simple  $R_p C_p$  model cannot describe the impedance behavior of rocks. More complicated models are therefore needed to simulate the electrical behavior of rocks. One such model is described in Section VII of this report.

### SECTION III

#### ROCK IMPEDANCE AND ELECTRODE EFFECTS

Room-temperature measurements were made on several dry samples of basalt, granite, and quartz. The following results show that impedance data on rocks at audiofrequencies adhere to a circular arc, or series of arcs, when displayed in the Argand diagram. Finite rock resistive and reactive dispersions were evident at characteristic frequencies, which permitted evaluation of rock relaxation time(s).

#### IMPEDANCE PARAMETERS OF DRESSER BASALT

A disc basaltic sample (II) containing  $\text{SiO}_2$ ,  $\text{Fe}_3\text{O}_4$ ,  $\text{Al}_2\text{O}_3$ ,  $\text{TiO}_2$ ,  $\text{CaO}$ , and  $\text{MgO}$  in the percents\* 48.42, 6.6, 15.23, 1.9, 8.35, and 6.4, respectively, and measuring 0.635 cm in length and  $6.41 \text{ cm}^2$  in cross-section was supplied to Honeywell by the Thermal Fragmentation Group, Twin Cities Mining Research Center, U.S. Bureau of Mines. Silver electrodes were painted to the circular surfaces of the rock and contact to the electrodes was made with copper wires. Replication of the impedance data at 14 different frequencies and at time intervals ranging from several minutes to three weeks, as well as with repeated electrode applications to the cleaned rock surface gave fairly reproducible results. The standard deviation at the high frequency of 2 kHz was 3.8 percent of the mean in  $R_s$ , and 2.6 percent of the mean in  $X_s$ . At the low frequency of 0.05 Hz, standard deviations of 3.7 and 8.1 of the mean in  $R_s$  and  $X_s$ , respectively, were calculated.

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\*Chemical analysis of the rock samples are taken from a recent report by Lindroth and Kranze (Reference 4).

The reactive component of the measured impedance is plotted in Figure 3-1 against its corresponding resistive component at a series of frequencies. The least-squares circle fit to the data was determined and plotted in the solid arc of Figure 3-1. The experimental points were found to deviate from the fitted arc by a standard deviation of 2.44 percent of the fitted radius. Inspection of the data in Figure 3-1 suggests a value of 16.4 megohm for the d-c resistance,  $R_0$ , of this basalt sample. A rock phase angle,  $\phi$ , of 29 degrees was also measured for this sample.

When the data were displayed in a log frequency plot, Figure 3-2 was obtained. Curves A and B have been drawn through the series reactance and resistance data, respectively. Careful examination of these curves indicates three dielectric relaxation peaks. The main peak appears at a frequency of 21.8 Hz, which corresponds to a turnover frequency,  $\omega_{\max}$ , of 136.9 radians per second, and to a relaxation time,  $\tau$ , of 7.3 milliseconds. A second, well-developed relaxation peak appears at a frequency of 1.7 Hz, corresponding to a relaxation time of 93.4 milliseconds. A third relaxation peak appears to be anticipated at frequencies less than 0.01 Hz. In agreement with these observations, the  $R_s$  curve shows two definite dispersion regions.

A major emphasis in this work was to represent the process(es) responsible for the impedance or dielectric circular arc by a single time constant, rather than a distribution of time constants. Splitting of the data into 3 overlapping circular arcs will obviously yield three characteristic times, each representing one of the circular arcs, and hence characterize a given relaxation process.

The first dispersion,  $\alpha_1$ , appears at a frequency which coincides with the first and main relaxation peak in the series reactance. A second dispersion,  $\alpha_2$ , occurs at a frequency of 0.05 Hz, somewhat displaced from the second relaxation peak. A third dispersion may be anticipated at frequencies below 0.01 Hz. In conformity with the adopted notations in dielectric dispersion, we will reserve the symbol  $\alpha$  for rock dielectric dispersion in the low-frequency range (below 10 kHz). The symbol  $\beta$  will be used for dispersions in the

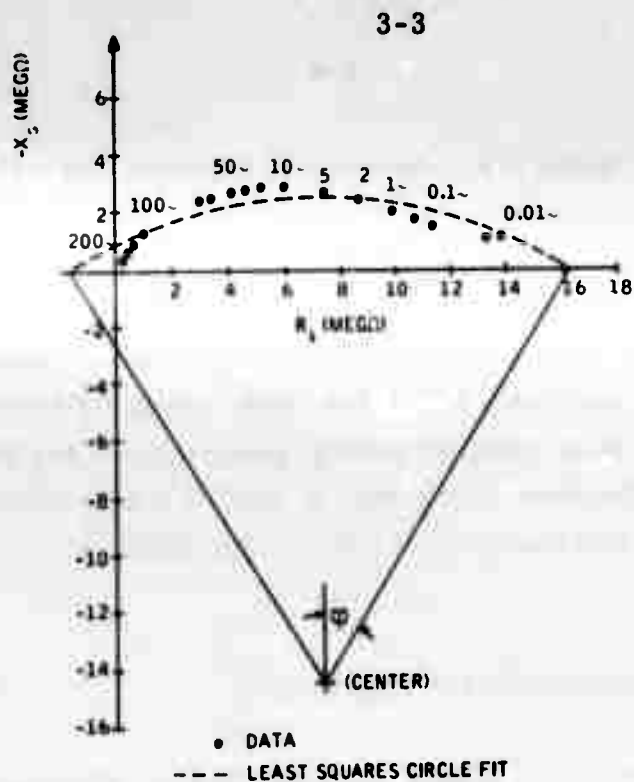


Figure 3-1. Argand Circular-Arc Plot for Dresser Basalt

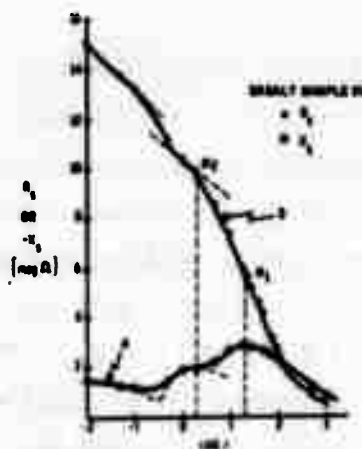


Figure 3-2. Dispersion of Impedance Components of Dresser Basalt and the Relaxation Time(s)

medium frequency range; i.e., between 10 kHz and 100 mHz. The symbol  $\gamma$  will be adopted for dispersions at frequencies beyond 100 mHz. Each of these dispersions may split into more than one subdispersion, such as the  $\alpha_1$ ,  $\alpha_2$ , . . . etc., of the  $\alpha$ -dispersion investigated in this project. Each of the discovered dispersions should correspond to a certain relaxation mechanism of a substructure or "structon" within the rock. Huggins and Huggins (Ref. 5) recommended the use of local structural groupings as the basic structural units. They used the term "structon" to signify a specific type of atom(s), with specific kinds and numbers of close neighbors.

### IMPEDANCE PARAMETERS OF GRANITE

A sample of charcoal gray granite from St. Cloud, Minnesota, was supplied to Honeywell by personnel from the Thermal Fragmentation Group of the Twin Cities Mining Research Center. The sample analyzed (Ref. 4) 63.5 percent  $\text{SiO}_2$ , 15.6 percent alumina, 4.1 percent  $\text{CaO}$ , 3.6 percent  $\text{Na}_2\text{O}$ , 3.6 percent  $\text{K}_2\text{O}$ , 4.2 percent  $\text{CaO}$ , 2.7 percent  $\text{FeO}$ , 1.8 percent  $\text{Fe}_2\text{O}_3$ , and smaller quantities of manganese and titanium.

The impedance data of granite followed the same pattern as that of basalt, except that the semicircular arc was not easy to close at the low-frequency side. Resistive and reactive components for a cylindrical granite sample 0.148 cm in length and  $3.67 \text{ cm}^2$  in cross-sectional area described a segment of a circular arc when plotted in an Argand diagram. Computer extrapolation of this arc to its point of intersection with the resistive axis yielded a value of  $4.8 \times 10^9$  ohm (about 5 gigaohm) for  $R_0$ . The preceding basaltic sample has an  $R_0$  value of 16.4 megohm. If a basalt sample of the same dimension of granite had been used, its  $R_0$  value would be

$$16.4 \left( \frac{0.148}{0.635} \right) \left( \frac{6.41}{3.67} \right) = 6.68 \text{ megohm}$$

The d-c resistance value,  $R_0$ , as determined by extrapolation of the impedance vector to zero frequency, is therefore about seven hundred times higher for granite than for basalt of similar shape and dimension. This result is consistent with the fact that granite contains 30 percent more of the covalently coordinated, and hence nonconductive, silica tetrahedra. Basalt has more iron, calcium, and titanium, although somewhat less sodium and potassium than granite.

### IMPEDANCE PARAMETERS OF QUARTZITE

Sioux quartzite, with a bulk density of  $2.64 \text{ gram cm}^{-3}$ , was used in the following experiments. The source location of this type of quartzite was Jasper, Minnesota. Its chemical analysis (Ref. 4) indicated 97.84 percent silica, 0.87 percent  $\text{Al}_2\text{O}_3$ , 0.81 percent  $\text{CaO}$ , 0.25 percent  $\text{FeO}$ , and 0.27 percent  $\text{Fe}_2\text{O}_3$ . As with granite, the impedance parameters of quartzite were very large, in the gigaohm range, at low frequencies. A quartzite disc sample of length 0.61 cm and cross-sectional area  $18.8 \text{ cm}^2$  gave an extrapolated  $R_0$  value of  $4.5 \times 10^9$  ohms. When corrected to the same dimensions of granite, this value should be modified to

$$4.5 \times 10^9 \left( \frac{0.148}{0.61} \right) \left( \frac{18.8}{3.67} \right) = 5.6 \times 10^9 \text{ ohms}$$

Hence, the quartz d-c resistance is about 20 percent higher than that of granite, and about three orders of magnitude higher than that of basalt. Thus, it appears that the rock's impedance parameters are not only affected by the quantity of silica that it contains, but also by the quantities of volatile oxides within the rock.

Under given environmental conditions, impedance results changed markedly by changes in the rock humidity, despite the reasonable repeatability of impedance data obtained with a given rock sample. In particular, impedance measurements on quartzite were found to be extremely sensitive to ambient air moisture, which contributed a great deal to d-c drifts. With basalt and granite, the data were not as sensitive to room moisture as quartz, and it was possible to study the effect of humidity on their impedance parameters.

#### EFFECT OF HUMIDITY ON ROCK IMPEDANCE

The effect of moisture content has been examined with a basaltic sample (II) and the data are shown in Figure 3-3. Curve A in this figure was obtained with the rock sample as received from the customer; no attempt was made to control the rock environment. Curve B in Figure 3-3 was obtained when the basalt sample was baked with electrodes attached in a 110°C oven for 19 hours. After baking, the sample was immediately placed in an airtight desiccator and allowed to cool to room temperature for the following 24 hours. The resulting measurements indicated a significant increase in impedance at frequencies up to 500 Hz. Above 500 Hz, the humidity effect on impedance parameters is not very pronounced. While the  $R_0$  value for the unbaked basalt was 16.4 megohm, the value determined when the rock was baked is about 45 megohm.

Chemical analysis of Dresser basalt (Ref. 4) indicated the presence of 0.14 percent water in the rock and a loss of ignition (LOI) of 2.26 percent. By contrast, the granite sample and the quartzite sample contained 0.11 and 0.08 percent water, respectively, and showed a loss on ignition of 0.59 and 0.32 percent, respectively. Upon ignition, not only water is lost, but some of the volatile oxides such as  $\text{Na}_2\text{O}$  and  $\text{K}_2\text{O}$  which are not bound in the silicate structure may also sublime. When these volatile oxides are attached to the nonvolatile silica tetrahedron, they are in the form of a solid solution of alkali silicate,



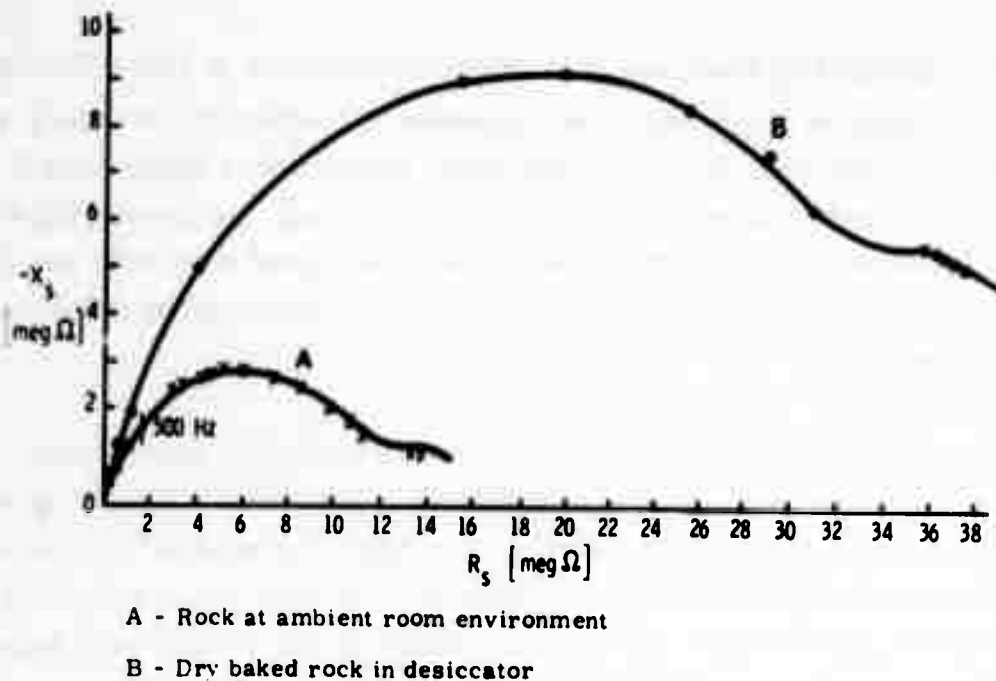


Figure 3-3. Effect of Moisture on the Impedance Semicircle of Basalt (II)

and the alkali will thereby be prevented from sublimation. A free alkali metal oxide unit in the rock will show a higher LOI ; will also be easily leachable with water, and thus will contribute significantly to the rock conductivity. Thus, the alkali content of a rock as shown by chemical analysis will not be the decisive factor in determining the rock conductivity; rather, the mode by which the alkali oxide enters the rock structure appears to play the predominant role. Because of its higher LOI, Dresser basalt appears to have more of the mobile sodium and potassium ions, which contributes greatly to its higher conductivity relative to granite and quartzite.

#### ELECTRODE EFFECTS IN IMPEDANCE MEASUREMENT

Measurement of electrical impedance by conventional, two-electrode techniques involves passage of a working current through the sample. At frequencies below 1 kHz, passage of current in the electrode-through-sample junction produces an interfacial phenomenon, which manifests itself as an additional frequency dependent electrode polarization impedance (Ref. 6).

The magnitude of electrode polarization impedance is generally inversely proportional to frequency or some power of frequency. Warburg electrochemical law (Ref. 7) is a special case in which this power is 0.5. In the four-electrode configuration, the current through the measuring electrodes can be minimized when they are properly designed with sufficiently large output impedance, and hence the electrode polarization artifacts can be minimized.

Shedlovsky (Ref. 8) attempted to eliminate electrode polarization by selecting different pairs of electrodes at different separations. Assuming constant polarization effects at each electrode, difference measurements can be made to determine the true sample impedance. At very low frequencies where electrode polarizations are severe, Shedlovsky's method may require finding differences of large numbers with resultant loss of accuracy.

#### ELECTRODE IMPEDANCE IN CYLINDRICAL ROCKS

Thin slices were cut from a long cylindrical rock sample. The same electrode material was applied to both sides of the rock sample (with the longer length  $d$ , and for the thinner rock sample whose length was  $d'$ ). The total impedance measured with either rock sample is

$$Z_m = Z + Z_e \quad (3-1)$$

where  $Z_m$  is the measured impedance,  $Z$  is the true impedance of the rock, and  $Z_e$  is the electrode impedance. For the long example,

$$Z = \xi \left( \frac{d}{A} \right) \quad (3-2)$$

and for the thin sample,

$$Z' = \xi \left( \frac{d'}{A} \right) \quad (3-3)$$

where  $\xi$  is the rock impedivity and  $A$  is the electrode area. Impedivity  $\xi$  is the vector summation of resistivity  $\rho$  and specific reactance  $\chi$ , thus

$$\xi = \rho + j\chi \quad (3-4)$$

By separating the real from the imaginary variables, identical relationships to those derived for  $Z_e$  will result for electrode resistance  $R_e$  and reactance  $X_e$ . Substituting from Equation (3-2) and (3-3) into (3-1), one obtains for the long sample

$$Z_m = \xi \left( \frac{d}{A} \right) + Z_e \quad (3-5)$$

and for the thin sample

$$Z_m' = \xi \left( \frac{d'}{A} \right) + Z_e \quad (3-6)$$

therefore,

$$\frac{Z_m - Z_e}{Z_m' - Z_e} = \frac{d}{d'} = \beta \quad (3-7)$$

where  $\beta$  is the ratio of the lengths of the two rock samples. Solving Equation (3-7) for  $Z_e$ , one obtains:

$$Z_e = \frac{\beta Z_m' - Z_m}{(\beta - 1)} \quad (3-8)$$

Separating Equation (3-8) into its real and imaginary parts gives

$$R_e = \frac{\beta R'_m - R_m}{(\beta - 1)} \quad (3-9)$$

and

$$X_e = \frac{\beta X'_m - X_m}{(\beta - 1)} \quad (3-10)$$

A thin slice of height 0.152 cm was cut from a basalt cylinder. The length of the remaining long cylinder was 4.08 cm. Hence,  $\beta = 26.8$ . Circular silver paste electrodes, each of area  $3.75 \text{ cm}^2$ , were fastened to each side of the two cylinders. The impedance data measured on these two rock specimens are shown in columns 2, 3, 4, and 5 of Table 3-1.  $R_e$  and  $X_e$  calculated from these data with the aid of Equations (3-9) and (3-10) are given in columns 6 and 7 of Table 3-1.

By subtracting the data in columns 6 and 7 point by point from the corresponding measured impedance data, and multiplying each resulting number into  $(A/d)$ , the basaltic specific resistance,  $\rho$ , and reactance,  $\chi$ , were calculated and recorded in columns 12 and 13 of Table 3-1.

A check on the validity of this technique was made by cutting a third section of the basalt sample with length 0.150 cm. Repeated measurements on this third sample gave data which agreed closely with those just reported. The specific impedance data for this third sample were calculated and found to be within a 1-percent error from those recorded in Table 3-1. This agreement supports the technique of correcting for the electrode-impedance artifacts and lends credence to the validity of our impedance measurements.

Table 3-1. Electrode Corrections for Basalt (II)

Frequency (Hz)	Long Cylinder		Small Disc		Electrode		Corrected Cylinder		Corrected Disc		$\rho = (R_S - R_e) \frac{A}{d}$		$\chi = (X_S - X_e) \frac{L}{d}$	
	$R_{S1}$	$-X_{S1}$	$R_{S2}$	$-X_{S2}$	$R_e$	$-X_e$	$R_{S1} - R_e$	$-(X_{S1} - X_e)$	$R_{S2} - R_e$	$-(X_{S2} - X_e)$	$\rho$	$\chi$	$\rho$	$\chi$
0.502	4059.23	2854.57	164.63	66.46	12.90	-42.17	4046.32	2896.74	151.74	108.63	37.10	26.56		
0.995	2661.09	2455.49	130.13	70.75	31.52	-22.16	2629.57	2477.65	98.61	92.91	24.11	22.72		
2.00	1731.15	2085.56	95.27	70.44	31.53	-8.07	1699.62	2093.63	63.74	78.51	15.59	19.20		
4.02	936.03	1441.44	63.12	59.37	29.10	5.53	906.93	1435.91	34.01	53.85	8.32	13.17		
6.03	652.78	1152.74	48.42	52.24	24.88	9.36	627.88	1143.37	23.55	42.88	5.76	10.48		
9.95	407.08	831.64	57.48	70.53	43.86	40.88	365.22	790.76	13.62	29.65	3.33	7.25		
20.06	286.68	493.76	19.71	29.22	9.31	11.12	277.38	482.65	10.40	18.10	2.54	4.43		
50.15	123.52	293.68	9.48	16.99	5.03	6.21	118.49	287.46	4.44	10.78	1.09	2.64		
99.50	46.56	200.34	5.26	10.83	3.65	3.45	42.91	196.59	1.61	7.38	0.39	1.81		
504	6.13	45.59	1.34	3.20	1.16	1.55	4.97	44.04	0.19	1.65	0.05	0.40		
1000	3.84	23.48	0.83	1.83	0.72	0.99	3.12	22.44	0.12	0.84	0.03	0.21		
2028	2.93	11.91	0.48	0.97	0.39	0.54	2.55	11.37	0.10	0.43	0.02	0.10		

Table 3-2. Electrode Corrections for Granite

Frequency (Hz)	Long Cylinder		Small Disc		Electrode		Corrected Cylinder		Corrected Disc		$\rho = (R_S - R_e) \frac{A}{d}$		$\chi = (X_S - X_e) \frac{L}{d}$	
	$R_{S1}$	$-X_{S1}$	$R_{S2}$	$-X_{S2}$	$R_e$	$-X_e$	$R_{S1} - R_e$	$-(X_{S1} - X_e)$	$R_{S2} - R_e$	$-(X_{S2} - X_e)$	$\rho$	$\chi$	$\rho$	$\chi$
5.027	921.7	3152	248.6	483.9	225.3	391.8	696.4	2760	23.3	92.1	6.40	25.6		
6.013	720.8	2755	205.8	430.5	188.0	350.3	532.8	2405	17.8	80.3	4.90	22.3		
7.96	544.0	2280	152.2	353.5	138.7	287.0	405.3	1993	13.5	66.5	3.80	18.5		
9.96	421.4	1775	119.5	297.5	109.1	246.5	312.3	1528.5	10.4	51.0	3.00	14.2		
20.07	465.8	944.9	63.01	173.8	49.1	147.2	418.7	797.7	13.9	26.6	3.90	7.4		
40.20	240.2	688.8	28.91	103.0	21.6	82.78	218.8	606	7.3	20.2	2.03	5.6		
60.10	183.0	525.8	17.07	73.69	12.0	58.1	151.0	467.7	5.04	15.6	1.40	4.3		
1000	1.172	31.71	1.503	5.65	---	4.7	---	26.96	---	0.9	---	0.3		
2028	1.920	15.91	1.154	2.97	1.128	2.5	0.792	13.39	0.026	0.4	0.01	0.1		

In nearly all the measurement in this report each rock sample was cut into two unequal lengths and the ratio  $\beta$  of the two lengths was accurately determined. The computer program was modified to automatically correct for electrodes by Equations (3-9) and (3-10) before the final data of  $\rho$  and  $\chi$  were displayed.

In a similar manner, the electrode corrections for granite were applied and the data in Table 3-2 were obtained. The plots of the specific reactance  $\chi$  against the specific resistance  $\rho$  at a series of frequencies for basalt, granite, and quartzite are shown in Figure 3-4. The impedivity of each of these three rocks expressed in (ohms x meter) is thus determined at frequencies between 1 and 2000 Hz.

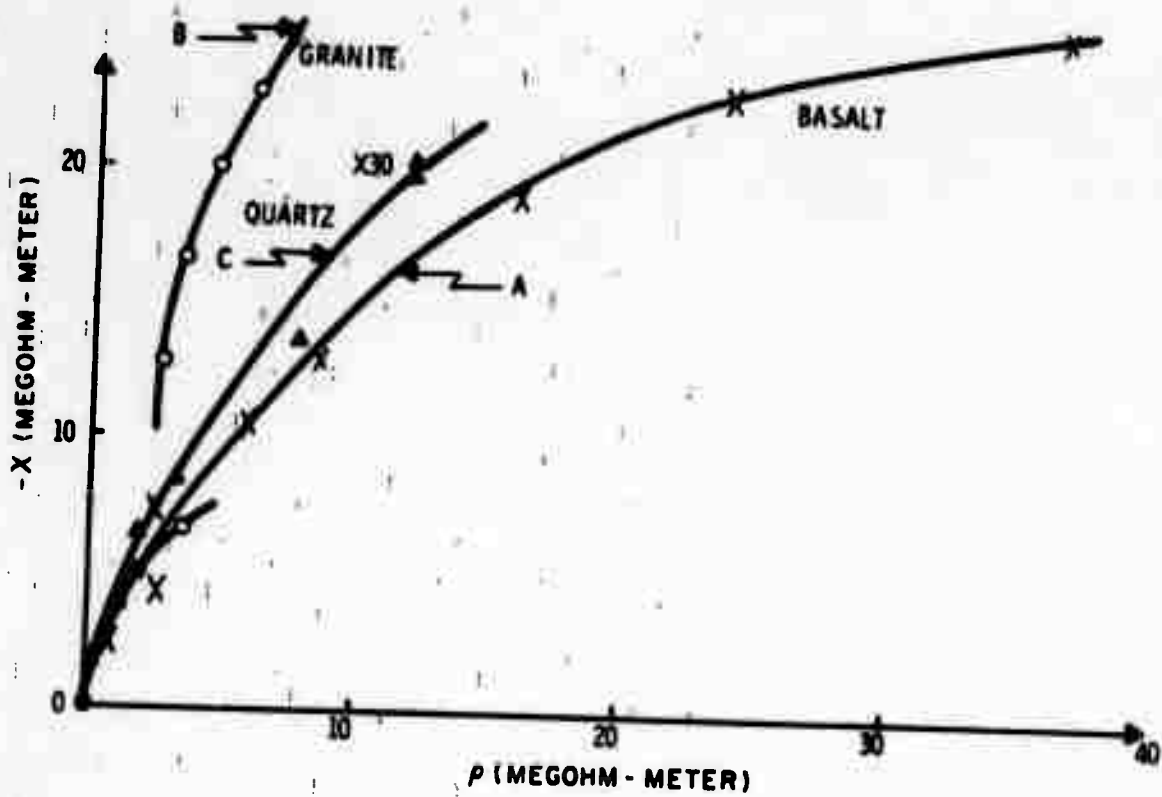


Figure 3-4. Specific Impedance Parameters for: (A) Basalt; (B) Granite; and (C) Quartzite

#### SECTION IV

### TRANSFORMATION OF COMPLEX IMPEDANCE DATA TO COMPLEX PERMITTIVITY DATA

An important phase of this research has been concerned with the development of techniques for the extraction of the real and imaginary parts of the complex permittivity,  $\epsilon^*$ , from their impedance counterparts, namely the imaginary and real parts of the electric impedance,  $Z$ .

The admittance vector,  $\vec{Y}$ , is defined as

$$\vec{Y} = G + j\omega C_p \quad (4-1)$$

where  $G$  is the conductance,  $\omega$  is the angular frequency, and  $C_p$  is the parallel capacitance of the medium. Hence, admittance is conceptually related to parallel circuit components. In terms of this vector, one can define the admittivity,  $\vec{y}$ , of the medium by

$$\vec{I} = \vec{y} E = (\sigma + j\omega\epsilon') E \quad (4-2)$$

Admittivity, therefore, relates the current density vector,  $\vec{I}$ , to the scalar potential difference,  $E$ . If the medium is simulated by a simple parallel  $R_p C_p$  combination, then the parallel resistance,  $R_p$ , would be inversely related to the rock conductance,  $G$ , and per unit volume to the rock conductivity,  $\sigma$ . The parallel capacitance,  $C_p$ , is similarly related to the dielectric permittivity (its real component  $\epsilon'$ ). In this report the dielectric constant,  $K$ , of the rock is defined as the ratio of its dielectric permittivity,  $\epsilon$ , to the dielectric permittivity of free space,  $\epsilon_r$ .



By contrast, the impedance vector,  $\vec{Z}$ , is related to the series resistance,  $R_s$ , and series reactance,  $X_s$ , of the medium; thus,

$$\vec{Z} = R_s + jX_s \quad (4-3)$$

Ohm's law may be written in terms of an impedivity vector,  $\vec{\xi}$ ; thus,

$$\vec{I} \cdot \vec{\xi} = E \quad (4-4)$$

where  $\vec{\xi} = \rho + j\chi$ ,  $\rho$  being the rock resistivity, and  $\chi$  its specific reactance. Impedance is, therefore, defined as that vector whose dot product into the current vector yields the potential difference, a scalar quantity. Comparing Equations (4-1) and (4-3), and remembering that impedance is the inverse vector of admittance, it becomes apparent that both  $R_s$  and  $X_s$  are necessarily frequency dependent.

Rock impedance data are presented in terms of the series equivalent circuit parameters because these are the parameters that are easy to measure without previous commitment to an exact electrical analog or model to simulate the medium. In addition, the series parameters can elegantly display a circular arc in the Argand diagram when  $X_s$  is plotted as a function of  $R_s$ , both measured at the same frequency.

The parallel-to-series transformation with frequency-independent components of an R-C network provides the proof of the determined semicircular arc in the Argand diagram. This is explained in detail in Appendix A.

In the transformation of complex impedance to complex permittivity data for an ideal system (Debye case), the impedance vector for the system is given by Equation (4-3).

Assuming that the rock system can be represented by the simple  $R_p C_p$  unit, one can use Equation (A4) in Appendix A and (4-3) to obtain

$$\begin{aligned}\bar{Z} &= \frac{R_s^2 + X_s^2}{R_p} + j \frac{R_s^2 + X_s^2}{X_p} \\ &= (R_s^2 + X_s^2) \left[ \frac{1}{R_p} + j \frac{1}{X_p} \right]\end{aligned}$$

$$\therefore \bar{Z} = |Z|^2 [G_p + j\omega C_p] \quad (4-5)$$

For normalization purposes, one must use specific quantities for the rock system. This is achieved by multiplying both sides of Equation (4-5) into  $A/d$ , where  $A$  is the area of the electrodes attached to the rock and  $d$  is their distance apart. This will transform impedance to impedivity  $\xi$ ; thus,

$$\begin{aligned}\bar{\xi} &= |\xi|^2 \left[ G_p \left( \frac{d}{A} \right) + j\omega C_p \left( \frac{d}{A} \right) \right] \\ &= |\xi|^2 [\sigma + j\omega \epsilon'] \\ &= j\omega |\xi|^2 [-j\kappa'' \epsilon_r + \kappa' \epsilon_r] \\ &= j\omega |\xi|^2 [\epsilon' - j\epsilon''] \\ &= j\omega |\xi|^2 \epsilon_r [\kappa'' - j\kappa']\end{aligned} \quad (4-6)$$

Here  $\epsilon_r$  is the permittivity of free space ( $8.85 \times 10^{-12}$  farad per meter), and the rock conductivity  $\sigma$  defines (Ref. 9) the imaginary part of the dielectric permittivity,  $\epsilon''$ , according to

$$\sigma = \omega \epsilon'' = \omega \kappa'' \epsilon_r \quad (4-7)$$

Using the complex dielectric permittivity,  $\epsilon^*$ , as

$$\epsilon^* = \epsilon' - j\epsilon'' \quad (4-8)$$

and complex dielectric constant,  $\kappa^*$ , as

$$\kappa^* = \kappa' - j\kappa'' \quad (4-9)$$

Equation (4-6) becomes

$$\begin{aligned} \vec{Z} &= j\omega |\xi|^2 (\epsilon' - j\epsilon'') \\ &= j\omega |\xi|^2 \epsilon^* \end{aligned}$$

Equation (4-10) gives the relation between the impedivity vector and the dielectric permittivity vector. Using the vectorial notation

$$\vec{\xi} = |\xi| e^{j\theta} \quad (4-10)$$

Into Equation (4-10) one obtains

$$\begin{aligned} \epsilon^* &= \frac{\xi}{j\omega |\xi|^2} = -\frac{j e^{j\theta}}{\omega |\xi|} \\ &= \frac{j^3 e^{j\theta}}{\omega |\xi|} \end{aligned} \quad (4-11)$$

Equation (4-11) signifies that the permittivity vector can be obtained from the impedivity vector by rotating the latter through  $(3\pi/2)$  and dividing through  $\omega |\xi|^2$ . These operations are diagrammatically illustrated in Figure 4-1.

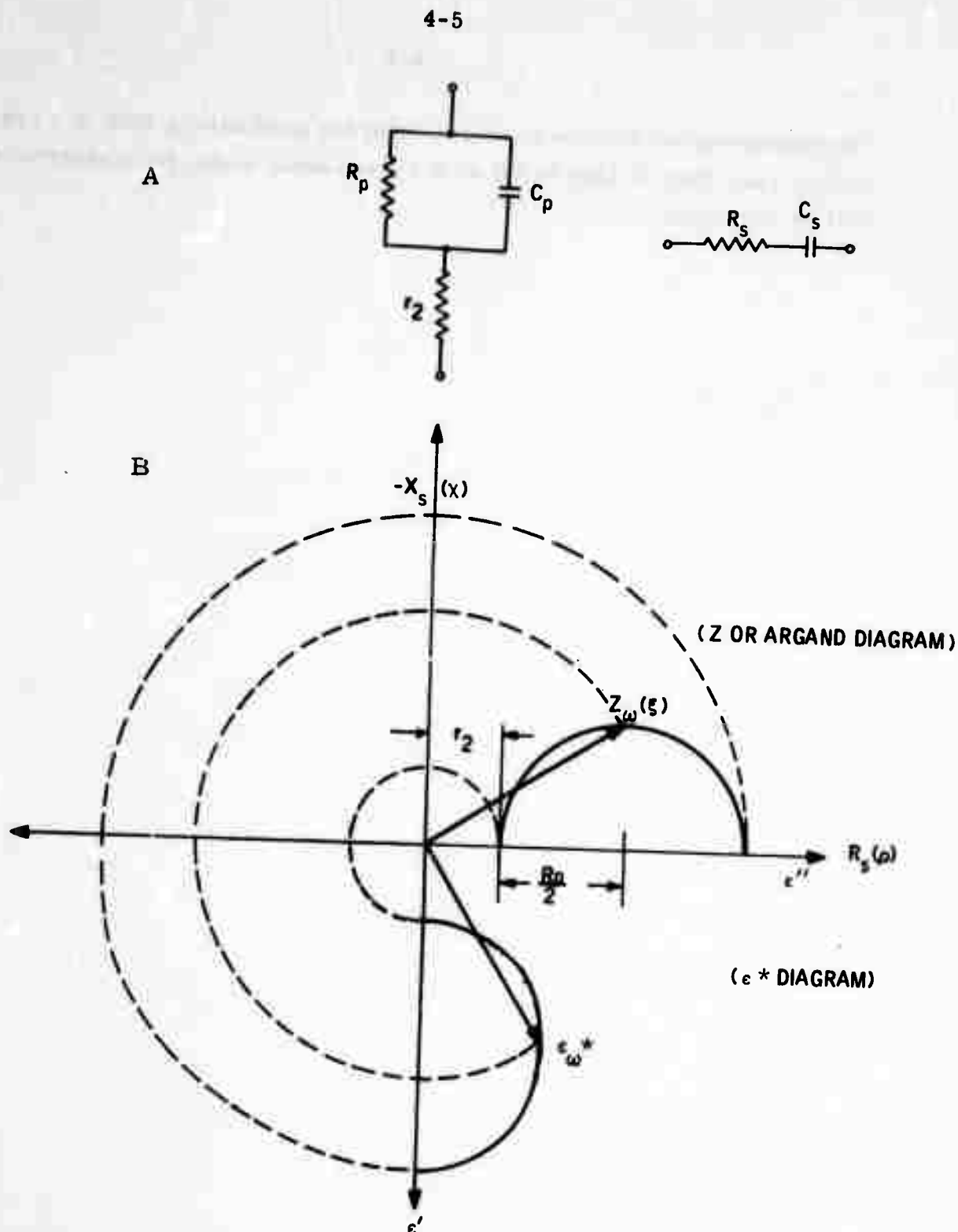


Figure 4-1. A. Transformation of parallel circuit with frequency independent parameters to isoimpedetic series circuit gives a semicircle in the Argand diagram.  
 B. Diagram to show rotation of impedance vector to give dielectric permittivity vector.

The conversion of impedivity data to complex permittivity data in a real system will be described in Section VII where a workable model for dielectric relaxation will be developed.

## SECTION V

### RESISTIVITY AND DIELECTRIC CONSTANT OF ROCKS

The principles presented in Section IV and implemented in Section VII to include real systems, were used to compute values for the dielectric constant of two basaltic rock samples and one quartzite rock from the experimentally measured impedance parameters.

Basaltic sample (III) was obtained in the form of a cylinder with diameter 2.17 cm. Thin slices that measured 0.30 and 0.61 cm in length were cut from this sample. The ratio  $A/d$  for the thinner slice was 0.1232 meter and for the thicker slice 0.0618 meter. The electrode impedances were calculated with the aid of Equations (3-9) and (3-10) for the two slices. The electrode impedances were subtracted point by point from the corresponding measured impedance values. The resulting data were then multiplied into  $(A/d)$  to give the specific resistance and reactance of basalt. Photostatic copies of the computer output for the two basaltic slices are shown in Tables 5-1 and 5-2.

Dielectric permittivity at each frequency was calculated by the procedure described in Section VII. The Cole-Cole plots resulting from these data are shown in Figures 5-1 and 5-3 for the 0.30- and 0.61-cm slices of basalt, respectively. These figures can be considered to be in satisfactory agreement within experimental error. The dielectric dispersion curves for basalt are shown in Figures 5-2 and 5-4 for the 0.30- and 0.61-cm slices of basalt. The relaxation times calculated from either the maximum in the loss factor,  $\epsilon''$ , or the inflection point in the  $\epsilon'$  curve were found to be 16.6 and 13.4 milliseconds for the two basalt slices. Since the experimental measurements on both slices were completely independent of each other, the derived values of relaxation time are considered to be in reasonable agreement.

Table 5-1. Impedance and Dielectric Data on Basalt (III).  
0.30 cm slice

ENTER NS,AOD PUT SSW1 UP FOR ELECTRODE CORRECTION  
#69.12317

K4-1 7/2/71			AOD= #.12317		PHASE AND AMPLITUDE CORRECTED		
FRQ	RS	XS	RAOD	XAOD	PM1	Z	
#.099	931.0156	-122.4131	114.6732	-13.0776	-7.4910	939.0200	
#.130	433.0498	-197.6160	33.3307	-24.3404	-24.5307	476.0006	
#.201	376.8926	-214.2601	46.4219	-26.3904	-29.6201	433.3303	
#.403	307.3906	-273.3842	37.8839	-33.9437	-41.8617	412.9874	
#.601	227.0444	-224.0116	27.9631	-27.3913	-44.6181	318.9320	
#.801	267.1763	-253.4711	32.9001	-31.4664	-43.7203	369.6602	
1.002	236.3063	-210.7373	29.1303	-23.9363	-41.7033	316.7733	
2.012	131.						
	219	-169.7444	18.6014	-20.9074	-48.3440	227.2020	
4.022	89.2898	-120.6417	10.9978	-14.8394	-33.4979	130.0903	
6.009	66.2687	-99.1330	8.1623	-12.2129	-36.2480	119.2613	
10.032	41.1296	-67.2230	3.0639	-8.2799	-38.3444	78.8073	
20.072	20.0718	-41.7003	3.4376	-3.1372	-36.0617	30.2753	
60.096	10.7001	-23.1228	1.3189	-2.8480	-65.1361	25.4819	
100.604	7.0602	-17.3937	0.8696	-2.1426	-67.9147	18.7739	
201.342	3.4133	-10.0660	0.				
			207	-1.2398	-71.2624	10.6297	
603.448	1.3968	-3.7563	0.1720	-0.4627	-69.6079	4.0076	
1009.174	1.1344	-2.2427	0.1422	-0.2762	-62.7682	2.5223	
1309.434	1.0003	-1.3610	0.1291	-0.1923	-36.1132	1.8804	
2023.783	0.9039	-1.1397	0.1113	-0.1404	-31.3030	1.4346	

RS,XS CIRCLE FIT RESULTS- CIRCLE CENTER = 311.1931 370.7300  
RADIUS = 638.4723  
FIT = 3.4732

R0 = 1030.9866 RINF = -0.6003

MODEL PARAMETERS - R1 = 1343.4873/FRQ  
RP = 1039.3872  
CP = 0.1701E-03

CP = 0.130032E-04

TAU = 16.60434MSEC E0 = 1771.1337 EINF = 14.77477

FRQ	EP	EPP
#.099	-0.168186E 04	-0.831248E 02
#.130	-0.163781E 04	-0.106640E 03
#.201	-0.163703E 04	-0.124742E 03
#.403	-0.137142E 04	-0.170948E 03
#.601	-0.132132E 04	-0.217142E 03
#.801	-0.147941E 04	-0.247313E 03
1.002	-0.144237E 04	-0.272144E 03
2.012	-0.130321E 04	-0.352604E 03
4.022	-0.112932E 04	-0.422121E 03
6.009	-0.101618E 04	-0.448484E 03
10.032	-0.864007E 03	-0.459783E 03
20.072	-0.662333E 03	-0.432068E 03
60.096	-0.393816E 03	-0.320979E 03
100.604	-0.298123E 03	-0.261763E 03
201.342	-0.199427E 03	-0.190306E 03
603.448	-0.994948E 02	-0.107468E 03
1009.174	-0.697422E 02	-0.807933E 02
1309.434	-0.318329E 02	-0.642934E 02
2023.783	-0.411467E 02	-0.342893E 02

\*\*\*\*\* STOP \*\*\*\*\*

Table 5-2. Impedance and Dielectric Data on Basalt (III).  
0.61 cm slice.

MORE  
DONE

ENTER NS, AOD PUT SSW1 ☒ FOR ELECTRODE CORRECTION  
060.06104

K2-1 7/2/71			ADD= 0.06104	PHASE AND AMPLITUDE CORRECTED		
FRQ	RS	XS	RAOD	XAOD	PHI	Z
0.099	1400.6572	-292.5101	86.6166	-18.0765	-11.7090	1450.8542
0.201	650.5455	-296.0410	50.9804	-18.3072	-25.1590	696.5999
0.402	551.9665	-568.5069	32.8968	-22.7761	-54.6994	647.0226
0.602	552.7695	-412.9792	52.9464	-25.5506	-57.7840	674.0804
0.801	459.8779	-345.4170	27.2020	-21.2569	-57.9075	550.0571
1.005	542.4744	-552.4679	55.5466	-54.1646	-45.5262	774.2755
2.000	510.4526	-425.5140	19.6951	-26.1902	-55.0654	529.8050
4.025	104.9092	-297.8154	11.4540	-18.4169	-50.1607	350.5502
6.010	150.7422	-220.6071	0.0051	-14.1420	-60.2475	265.4224
7.999	90.7915	-172.0500	5.6145	-10.6070	-62.2906	195.2262
10.026	80.4771	-151.9040	4.9767	-9.5957	-62.0904	171.9052
20.040	54.5092	-80.4660	5.5700	-5.4700	-50.5640	105.9116
60.096	20.5604	-46.5154	1.2719	-2.0641	-66.0591	50.6771
100.200	14.1226	-55.6055	0.0755	-2.2067	-60.4127	50.5766
200.555	5.9605	-19.9417	0.5691	-1.2552	-75.5451	20.0157
605.440	2.4719	-7.5750	0.1529	-0.4561	-71.4755	7.7705
1009.174	2.0572	-4.4140	0.1260	-0.2750	-65.2502	4.0614
1512.200	1.9527	-5.0550	0.1200	-0.1077	-57.2467	5.6089
2025.705	1.0259	-2.1429	0.1129	-0.1525	-49.5692	2.0155

RS, XS CIRCLE FIT RESULTS- CIRCLE CENTER = 817.1544 512.9140  
RADIUS = 970.6765  
FIT = 5.4205

R0 = 1650.6567 RINF = -16.5679

MODEL PARAMETERS - R1 = 4016.5664/FRQ  
RP = 1667.0046  
CP = 0.0516E-04

CP = 0.605079E-05

TAU = 15.40942MSEC E0 = 1496.9577 EINF = 14.04502

FRQ	EP	PPP
0.099	-0.144029E 04	-0.555150E 02
0.201	-0.140910E 04	-0.845050E 02
0.402	-0.136220E 04	-0.126064E 05
0.602	-0.152522E 04	-0.150669E 05
0.801	-0.129566E 04	-0.104666E 05
1.005	-0.126515E 04	-0.207210E 03
2.000	-0.115659E 04	-0.204105E 05
4.025	-0.101591E 04	-0.561500E 05



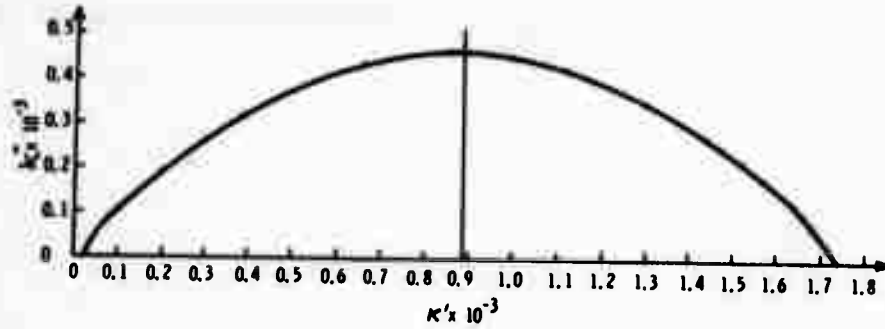


Figure 5-1. Cole-Cole Plot of Dresser Basalt Data on 0.30-cm Slice

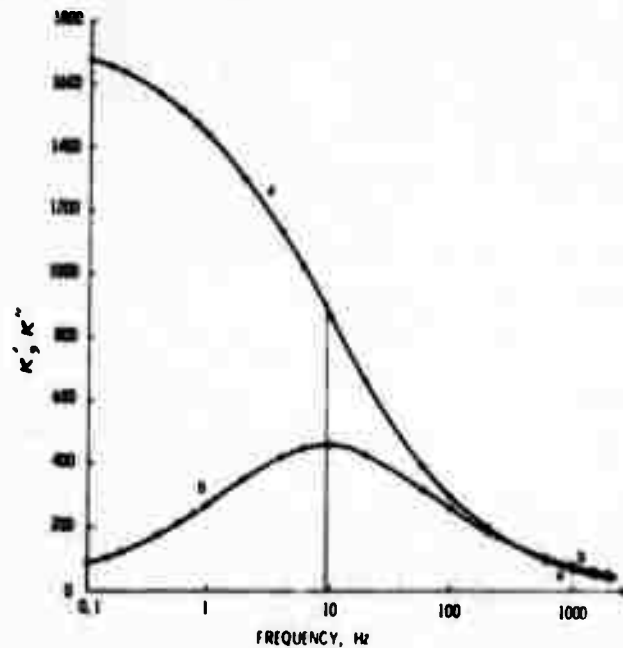


Figure 5-2. Dielectric Constant of Dresser Basalt as a Function of Frequency [(a) Real Part of Dielectric Constant,  $\kappa'$ ; (b) Imaginary Part,  $\kappa''$ ]. Data on the 0.30-cm Slice; Relaxation Time,  $\tau = 16.6$  msec.

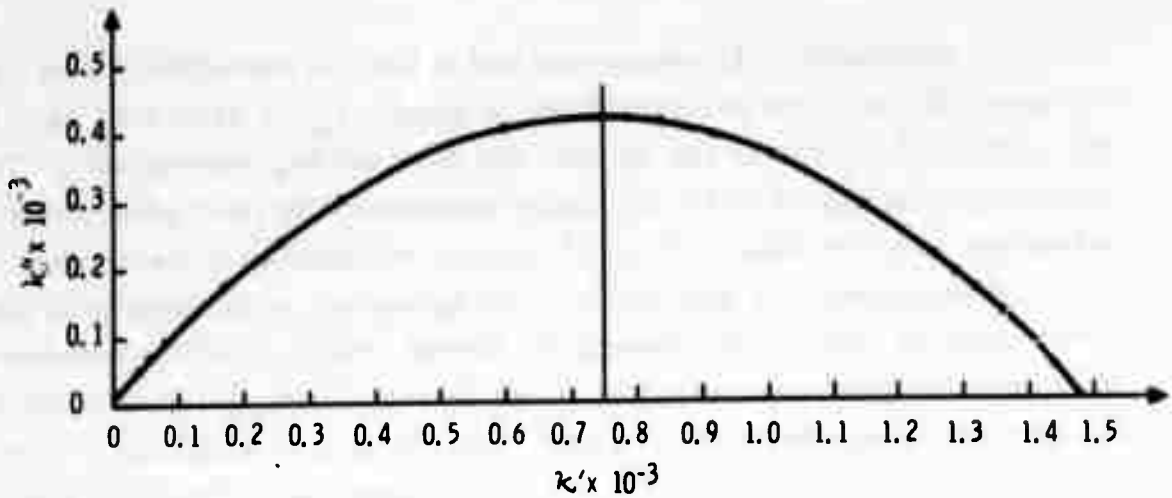


Figure 5-3. Cole-Cole Plot of Dresser Basalt Data on 0.61-cm Slice

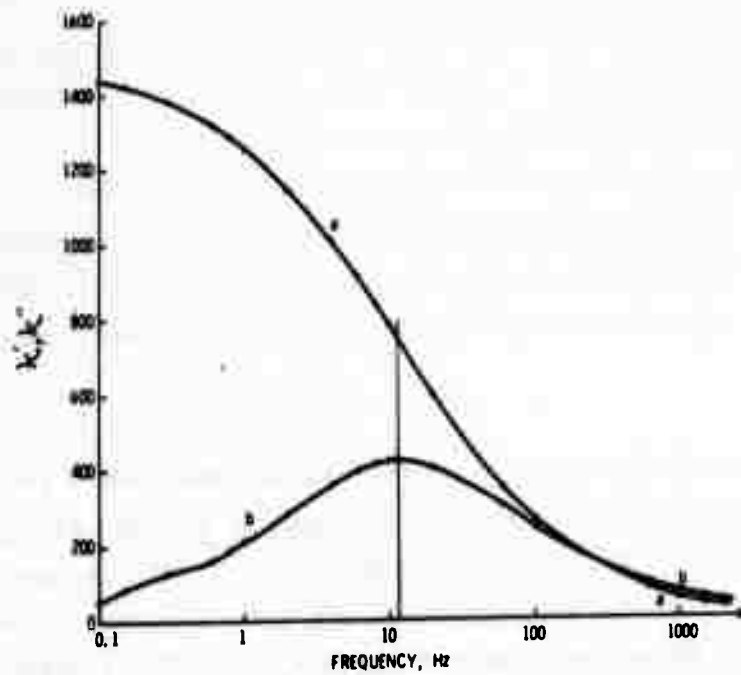


Figure 5-4. Dielectric Constant of Dresser Basalt as a Function of Frequency [(a) Real Part of Dielectric Constant,  $\kappa'$ ; (b) Imaginary Part,  $\kappa''$ ]. Data on the 0.61-cm Slice; Relaxation Time,  $\tau = 13.4$  msec.

Table 5-3 summarizes the impedivity and dielectric permittivity data on the two basalt slices. The d-c resistivity of basalt,  $\rho_o$ , is estimated as  $1.27 \times 10^8$  and  $1.00 \times 10^8$  ohmmeter for the thin and thick slices, respectively. These resistivity data appear to be internally consistent with each other and are in agreement with the value  $1.26 \times 10^8$  ohmmeter reported in Parkhomenko (Ref. 10) monograph for dry basalt. The agreement is surprising in view of the anticipated differences between the Dresser basalt and Parkhomenko's most probably Russian basalt (origin not given). Table 5-3 also shows that the zero frequency dielectric constant of basalt is  $1.77 \times 10^3$  and  $1.50 \times 10^3$  for the thin and thick slices. The internal agreement in this case is also acceptable. Parkhomenko (Ref. 10) reports that at low frequencies of  $10^2$  to  $10^4$  Hz the dielectric constant may assume very large values ( $10^3$  to  $10^5$ ).

Keller (Ref. 11) observed that the product of the dielectric permittivity at low frequency,  $\epsilon_o$ , into the resistivity at low frequency,  $\rho_o$ , is nearly a constant characteristic of a particular type of rock. For rhyolite and basalt, the average value of  $\rho_o \epsilon_o$  is 0.63 sec with the range of 19 values from 0.25 to 26 sec. Average values of this product varied from  $1.4 \times 10^{-3}$  for basic igneous rocks such as gabbro and chromite to 10.8 for the hematite ore from Minnesota, which contains appreciable quantities of electronically conducting materials. The data in Table 5-3 also show that the products  $\rho_o \kappa'_\infty \epsilon_r$  and  $\rho_\infty \kappa_o \epsilon_r$  are equal to the relaxation time for both the thin and thick samples of basalt.

Similar experiments to those performed on basalt were run on a cylindrical quartzite sample (II) of 2.22 cm diameter, 0.955 cm length, and an (A/d) ratio of 0.0406 meter. The computer output data on this sample are shown in Table 5-4. From the present data, one can calculate the d-c resistivity of quartzite,  $\rho_o$ , from the observed value  $R_o$  of 31737.9 megohm, thus

$$\rho_o = R_o \left( \frac{A}{d} \right) = 3.17 \times 0.041 \times 10^{10} = 1.29 \times 10^9 \text{ ohm-meter}$$

The relaxation time of this quartzite sample is also calculated to be 60.3 milliseconds. The real component of the dielectric constant at infinite frequency,  $\kappa'_{\infty}$ , is determined as 5.29. Also, the real component of the quartzite dielectric constant at the time of zero frequency,  $\kappa'_0$ , is found to be  $3.95 \times 10^3$ .

Table 5-3. Electric and Dielectric Parameters of Dresser Basalt (III)

Parameter	0.30 cm Slice	0.61 cm Slice
dc resistivity, $\rho_0$ , ohm meter	$1.27 \times 10^8$	$1.00 \times 10^8$
infinite frequency resistivity, $\rho_{\infty}$ , ohm meter	$1.06 \times 10^6$	$1.01 \times 10^6$
model parallel resistance, $R_p$ , ohm/(meter) <sup>3</sup>	$8.89 \times 10^{14}$	$6.87 \times 10^{14}$
model capacitance, $C_p$ , farad	$1.3 \times 10^{-5}$	$6.8 \times 10^{-6}$
relaxation time, $\tau$ , second	$16.6 \times 10^{-3}$	$13.4 \times 10^{-3}$
zero frequency dielectric constant, $\kappa_0$	$1.77 \times 10^3$	$1.50 \times 10^3$
infinite frequency dielectric constant, $\kappa_{\infty}$	14.8	14.8
maximum dielectric constant, $\kappa''_{\max}$	$4.6 \times 10^2$	$4.2 \times 10^2$
$\rho_0 \kappa'_{\infty} \epsilon_r$ , second	$16.4 \times 10^{-3}$	$13.1 \times 10^{-3}$
$\rho_{\infty} \kappa'_0 \epsilon_r$ , second	$16.6 \times 10^{-3}$	$13.2 \times 10^{-3}$

Table 5-4. Impedance and Dielectric Data on Quartzite (II).  
0.96 cm Slice

ENTER NS,AOD PUT SSW1 UP FOR ELECTRODE CORRECTION  
076.04062

M3 08/26/71

AOD= 0.04062

PHASE AND AMPLITUDE CORRECTED

FRQ	RS	XS	RAOD	XAOD	PH1	Z
1.001	906.0527	-4305.7520	36.8039	-174.8996	-78.1225	4400.0498
2.004	858.0356	-3565.0869	34.8534	-144.8138	-76.4732	3666.8882
4.030	473.6096	-1959.4707	19.2380	-79.5937	-76.4177	215.8948
6.017	329.4869	-1296.3813	13.3838	-52.6590	-75.7453	1337.5072
8.026	299.3496	-1046.7861	12.1596	-42.5205	-74.0465	1088.7478
10.008	285.1741	-825.8511	11.5838	-33.5461	-70.9549	873.7014
20.153	294.2329	-513.6184	11.9517	-20.8632	-60.1976	591.9265
40.161	137.3826	-395.5394	5.5805	-16.0668	-70.8516	418.7188
60.168	26.0835	-291.0387	1.0595	-11.0220	-84.8850	292.2051
79.872	-43.7361	-229.9436	-1.7766	-9.3403	-100.7766	234.0660
99.800	-32.5157	-183.0712	-1.3208	-7.4364	-100.0787	185.0364
201.884	-14.8709	-75.4577	-0.6041	-3.0651	-101.1562	76.9091
504.202	-2.9886	-24.6946	-0.1214	-1.0031	-96.9075	24.8748
998.185	0.6537	-11.1146	0.0265	-0.4515	-86.6404	11.1338
1506.591	1.7666	-7.0809	0.0717	-0.2076	-75.0968	7.2979
2022.059	2.0117	-5.2798	0.0817	-0.2145	-69.1470	5.6501
2537.594	1.2796	-4.3307	0.0519	-0.1759	-73.5441	4.5158

RS,XS CIRCLE FIT RESULTS- CIRCLE CENTER = 15890.1699 1622.5833  
RADIUS = 15930.5625  
FIT = 0.6057

R0 = 31737.8828  
MODEL PARAMETERS - RINF = 42.4551  
R1 = 268343.750/FRQ  
RP = 31695.4258  
CP = 0.9060E-05

CP = 0.189275E-05

TAU = 60.30515MSEC

ED = 3951.31494

RINF = 5.28559

FRQ	EP	EPP
1.001	0.281805E 04	0.127285E 04
2.004	0.223135E 04	0.172910E 04
4.030	0.259191E 04	0.166165E 04
6.017	0.125202E 04	0.138837E 04
8.026	0.103396E 04	0.115927E 04
10.008	0.884613E 03	0.989096E 03
20.153	0.516610E 03	0.557240E 03
40.161	0.291078E 03	0.301209E 03
60.168	0.205644E 03	0.208085E 03
79.872	0.160841E 03	0.160254E 03
99.800	0.132528E 03	0.130402E 03
201.884	0.721628E 02	0.677588E 02
504.202	0.339802E 02	0.288582E 02
998.185	0.204895E 02	0.152495E 02
1506.591	0.156443E 02	0.103800E 02
2022.059	0.131578E 02	0.788417E 01
2537.594	0.116534E 02	0.637630E 01

\*\*\*\*\* STOP \*\*\*\*\*

## SECTION VI

### EFFECT OF WATER AND SODIUM HYDROXIDE PRETREATMENT ON ROCK ELECTRIC AND DIELECTRIC PARAMETERS

The presence of underground water ahead of excavation can be detected in principal by electrical resistivity probes. A major emphasis of Honeywell's rock impedance research is to determine the impedance or dielectric parameter that exhibits the largest change in value by the presence of small quantities of entrapped water. To define these parameters, basaltic rock samples were subjected to planned water treatments. Their impedance and dielectric parameters were measured before and after these pretreatments, so that each sample acted as its own control standard.

Previous workers (Refs. 12 and 15) have shown that the resistivity of a rock completely saturated with saline is determined by the rock porosity to a first approximation. However, the pore spaces in a rock may not always be saturated with aqueous electrolytes. In oil reservoirs, for example, oil may partially replace water in the pore spaces. The presence of oil, natural gas, or air in the pore structure of a rock may increase the resistivity significantly over what it would be in a completely water-saturated rock.

Rock resistivity is greatly affected by the quantity of water present. Letting  $\rho$  be the bulk resistivity of the rock,  $\rho_w$  the resistivity of water as it actually exists in the pore space of the rock, and  $\theta$  the rock porosity, then

$$\rho = \rho_w / \theta^n \quad (6-1)$$

This relationship is commonly known as Archies' law (Ref. 12). The exponent  $n$  is an empirically derived parameter characteristic of the texture of the rock. Its value varies from about 1.3 in loosely packed granular material to about 2.2 in well-cemented granular rocks (Refs. 13 and 14).

Pirson (Ref. 15) modified Archies' relationship by introducing a second empirical parameter,  $m$ , which multiplies the porosity term; thus,

$$\rho/\rho_w = m \theta^{-n} \quad (6-2)$$

The value of  $m$  varies from 0.6 to 1.3 in marine sedimentary rocks, and appears to be related to the texture of the rock. For rocks with less than 4 percent porosity, including dense igneous rocks and metamorphosed sedimentary rocks,  $m = 1.4$  and  $n = 1.6$ . These expressions apply only when a rock is completely saturated with water. Keller (Ref. 16) observed that the resistivity of a rock increases proportionately to the inverse square of the fraction,  $S$ , of the pore space filled with water, provided the water which remains coats the grains uniformly. Accordingly, Archies' relationship becomes

$$\rho = \rho_w \theta^{-n} S^{-2} \quad (6-3)$$

Scott et al. (Ref. 17) used this relationship in the form

$$\sigma = \sigma_w \theta^n S^m \quad (6-4)$$

where  $\sigma$  is the rock conductivity,  $\sigma_w$  is the conductivity of the pore fluid at the same frequency, and the constants  $m$  and  $n$  are approximately equal to 2. The product of the fractional saturation of the rock,  $S$ , into the fractional porosity,  $\theta$ , should yield the fractional water content of the rock,  $w$ . Under these conditions, Archies' law becomes

$$\sigma \sim \sigma_w \times w^2 \quad (6-5)$$

It should also be remembered that  $\sigma_w$  is approximately proportional to the salinity of the pore fluid.

## WATER TREATMENT OF BASALT

To investigate the effect of rock water content on its electric properties, a series of experiments were performed with three slices of basalt. The slices were cut from the one long cylinder of basalt (III), hence they possessed the same diameter of 2.18 cm, but were of different lengths. Slices  $K_1$ ,  $K_2$ , and  $K_4$  were of lengths 0.956, 0.605, and 0.304 cm, respectively. The rock samples were pretreated simultaneously in distilled water for periods of 23 and 77 hours. After each soak, the rocks were dried in an 80°C oven for two hours, then cooled in a dessicator before the impedance circular arcs were determined.

Typical results on samples  $K_1$ ,  $K_2$ , and  $K_4$  before and after the water pretreatment are shown in Tables 6-1 to 6-9. These results show that  $R_0$  decreased, after soaking the sample in water for 23 hours, to about one third of its value before soaking. Further soaking to 77 hours increased  $R_0$  slightly, but it still remained smaller than the baseline value before water pretreatment. Typical values of  $R_0$  for sample  $K_1$  before water pretreatment, after 23 hours, and after 77 hours of pretreatment were 1031, 328, and 447 megohms, respectively. This same trend can be noticed in the results obtained with the rest of the basaltic rock samples.

By contrast, the dielectric constant at zero frequency,  $\kappa_0$ , increased monotonically with increase in water soak time. Typical values of  $\kappa_0$  were 1770, 60200, and 146000 before water soak, after 23 hours, and after 77 hours of water pretreatment, respectively. The infinite frequency parameters  $R_\infty$  and  $\kappa_\infty$  did not change significantly with the water pretreatments. Furthermore, the impedance arc plots were very close and actually tangential to each other down to a frequency of 300 Hz. Below that frequency, the arcs began to separate from each other following each water soak. Typical data on sample



**Table 6-1. Computer Output for Electric and Dielectric Data of Untreated Basalt (Sample K.)**

ENTER NO. AND PUT 36W1 UP FOR PLUGTUBE CONNECTION  
 007.03410

48-1 77471		AOD= 0.03916		PHAS# AND AMPLITUDE CORR'CT'D			
PH#	Rs	Xs	RAOD	XAOD	PH1	Z	ZADD
0.0000	304.4177	-1115.1220	30.5490	-45.6402	-40.5059	1487.4731	30.2494
4.0000	355.4240	-043.5304	20.9041	-32.3289	-37.0304	903.7445	30.0344
8.0000	304.7719	-300.2530	11.9500	-22.1757	-61.7056	64.7020	22.1033
12.0000	255.1130	-410.5913	0.0322	-10.3920	-63.0994	466.1440	10.2542
16.0000	195.0100	-335.6290	0.0240	-23.1432	-65.3011	369.2820	14.4500
20.0000	121.6207	-270.3245	4.7620	-10.5937	-63.7967	296.6077	11.6152
24.0000	66.5050	-134.4740	3.2320	-0.8414	-61.0521	174.9731	6.0520
28.0000	45.7050	-100.0014	1.7115	-3.9396	-60.5232	109.6047	4.2053
32.0000	40.0000	-75.3633	1.1313	-2.0007	-60.0051	79.2969	3.1053
36.0000	44.0000	-50.1192	0.5900	-2.0010	-60.2030	71.0316	2.7016
40.0000	44.0000	-30.4024	0.3935	-2.1131	-60.0003	60.0000	2.3000
44.0000	44.0000	-31.0034	0.3932	-2.1131	-73.7050	32.0317	1.9544
48.0000	4.0000	-15.0000	0.1350	-0.6100	-73.3267	16.2122	0.6391
52.0000	3.0013	-11.1012	0.1495	-0.4401	-73.7050	11.0120	0.6056
56.0000	3.0034	-0.4064	0.1194	-0.3347	-70.2373	9.0202	0.5553
60.0000	4.0011	-0.0031	0.1136	-0.2606	-70.1563	7.4713	0.2926
64.0000	4.0049	-0.4001	0.1037	-0.1739	-39.4640	5.2110	0.2641
68.0000	4.3737	-3.1301	0.0929	-0.1220	-30.0025	3.9331	0.1500

```

ND,42 CIRCLE FIT RESULTS-  CIRCLE CENTER = 1034.5062  610.6073
                             RADIUS = 1933.5234
                             FIT = 0.2607

```

AN# 3666.4336      RIF# 2.7163

MOORE PARAMETERS - RI = 16342.4169/FRQ  
RP = 3663.7349

RMU - p. 145500 11 URM-C14

CP# 8.443307E-04

TAW# 94.0002716LC      #2=3399000.107      #INF# 7+.04716

[illegible]

DET. 6, 14 FOR RING/FORTH

NO. 45 CIRCLE PIT RESULTS- CIRCLE CHUTOR = 1977.8406 735.4393  
RAULUS = 2106.7949  
PIT = 0.2964

REF ID: A654713      2114Pb      3.5452

MODEL PARAMETERS - K1 = 26449.4651/FRQ  
RP = 3340.3234

F	F-2/F	R1	XP
0.9935	2.0935	0.5047/7.74	-2365.5615
4.0000	0.1000		-1407.0523
0.1000	0.9999	2356.7637	-0.333990-04
0.0100	0.9900	1749.5364	-0.07.1501
0.0000	0.9999	1505.0000	-353.1170
10.0000	0.1000	1126.0092	-457.0725
100.0000	0.2432	0.00.4770	-266.4635
0.00.1000	0.1578	0.02.5306	-164.6505
0.00.1200	0.1200	357.3106	-110.4162
79.4742	0.1111	531.1262	-100.1311
100.7000	0.0900	471.9167	-02.2441
0.00.7000	0.0700	215.5267	-03.9014
0.00.7000	0.0700	156.3093	-23.0981
0.00.7007	0.0707	156.3097	-15.7074
0.00.1300	0.0303	100.0510	-11.0027
200.3.0000	0.0310	100.0202	-10.1000
1512.2070	0.0237	101.2304	-4.1150
104.4.1000	0.0222	904.2100	-4.3263

60 M. 564640 M4 H0 M. 474450 M0

Table 6-2. Computer Output for Electric and Dielectric Data of Untreated Basalt (Sample K<sub>2</sub>)

ENTER NO, AUC PUT 55W1 UP FOR ELECTRODE CORRECTION  
NO. 00104

K2-1 7/2/71 AUC= 0.06104 PHASE AND AMPLITUDE CORRECTED

FRQ	RS	XS	RADD	XADD	PHI	2	2A00
0.000	1400.0572	-292.3101	86.6100	-18.8765	-11.7800	1450.8342	88.4828
0.001	0.000555	-290.0410	58.9804	-18.5072	-25.1590	696.5990	43.0654
0.002	531.9065	-368.5009	52.8960	-22.7761	-54.6994	647.0226	40.0119
0.003	532.7895	-412.9792	52.9464	-25.5386	-37.7840	674.0804	41.6856
0.004	439.0779	-345.4170	27.2020	-21.2369	-37.9823	550.0571	34.5105
0.005	342.4744	-532.4679	53.5466	-34.1646	-45.5262	774.2733	47.0011
0.006	318.4520	-425.3140	19.8951	-26.1902	-53.0634	529.8838	32.7600
0.007	180.9992	-297.0154	11.4348	-18.4169	-58.1687	350.5502	21.6700
0.008	130.7422	-248.6071	8.0051	-14.1420	-60.2475	265.4224	16.2900
0.009	90.7913	-172.8300	5.6145	-10.6078	-62.2906	193.2262	12.7200
0.010	60.4771	-151.9040	4.9767	-9.5937	-62.8904	171.9052	10.6300
0.012	40.5094	-88.4668	3.5708	-5.4700	-58.3648	105.9116	6.4259
0.015	20.3604	-46.5154	1.2719	-2.8641	-66.0591	50.6771	3.1339
0.020	14.1240	-35.6835	0.8735	-2.2067	-68.4127	38.5766	2.3752
0.025	5.9085	-19.9417	0.5691	-1.2332	-73.3431	20.0157	1.2872
0.030	2.4719	-7.5730	0.1529	-0.4561	-71.4755	7.7703	0.4810
0.035	1.0372	-4.4140	0.1260	-0.2730	-65.2302	4.0614	0.3006
0.040	1.0527	-3.0035	0.1200	-0.1077	-57.2467	3.6809	0.2232
0.045	1.0559	-2.1429	0.1129	-0.1325	-49.5692	2.0155	0.1741

NO, XS CIRCLE FIT RESULTS- CIRCLE CENTER = 017.1344 512.9140  
RADIUS = 970.6765  
FIT = 5.4205

RP = 1050.0507 RINF = -10.5679

MODEL PARAMETERS - N1 = 4016.5864/FRQ  
RP = 1007.0046

RHO = 0.1020E 11 UHN-CII

CP = 0.005079E-05

TAU = 15.400405E-05 EP=1496.9577 EINF = 14.04302.

FRQ	EP	EPP
0.000	-0.144429E 04	-0.555150E 02
0.001	-0.140510E 04	-0.845300E 02
0.002	-0.150220E 04	-0.120064E 03
0.003	-0.152524E 04	-0.138006E 03
0.004	-0.129300E 04	-0.144006E 03
0.005	-0.120515E 04	-0.207210E 03
0.006	-0.115059E 04	-0.204485E 03
0.007	-0.101591E 04	-0.301508E 03
0.008	-0.917750E 03	-0.390610E 03
0.009	-0.444870E 03	-0.415440E 03
0.010	-0.705090E 03	-0.420734E 03
0.012	-0.003847E 03	-0.400005E 03
0.015	-0.554357E 03	-0.502114E 03
0.020	-0.205449E 03	-0.243390E 03
0.025	-0.175504E 03	-0.172403E 03
0.030	-0.015973E 02	-0.924910E 02
0.035	-0.530925E 02	-0.078099E 02
0.040	-0.305240E 02	-0.520500E 02
0.045	-0.501547E 02	-0.441023E 02

DET. G, H FOR N1=0/FH0

NO, XS CIRCLE FIT RESULTS- CIRCLE CENTER = 2065.1525 1464.8105  
RADIUS = 2548.6143  
FIT = 1.5794

RP = 4140.7007 RINF = -22.4565

MODEL PARAMETERS - N1 = 5459.4727/FRQ  
RP = 4171.2178

F	F-1/2	R1	XP	GP
0.000	5.1630	15958.5010	-8406.1975	-0.1894E-03
0.001	4.2327	4099.2344	-4024.6152	-0.1971E-03
0.002	1.5700	5700.7007	-2759.7119	-0.1415E-03
0.003	1.4001	5324.5472	-2553.1325	-0.1150E-03
0.004	1.1174	4305.0308	-1845.0853	-0.1077E-03
0.005	0.9978	2524.4044	-1015.1167	-0.9810E-04
0.006	0.7000	1050.0144	-1054.5010	-0.7515E-04
0.007	0.4988	1095.6938	-650.9392	-0.6022E-04
0.008	0.4079	405.5264	-502.3809	-0.5271E-04
0.009	0.3556	000.0050	-503.4000	-0.5057E-04
0.010	0.3158	001.5001	-544.4452	-0.4009E-04
0.012	0.2233	547.5122	-225.6909	-0.3549E-04
0.015	0.1290	171.4776	-115.0650	-0.2302E-04
0.020	0.0999	115.9562	-85.8075	-0.1040E-04
0.025	0.0700	02.5205	-65.5055	-0.1214E-04
0.030	0.0407	52.0042	-74.6001	-0.5552E-05
0.035	0.0314	47.9400	-105.0000	-0.1510E-05
0.040	0.0257	20.5571	-142.1658	-0.7403E-06
0.045	0.0222	25.9122	-189.1053	-0.4155E-06

G = 0.45/51E 04 N = 0.05421E 00  
\*\*\*\*\* STOP \*\*\*\*\*

Table 6-3. Computer Output for Electric and Dielectric Data of Untreated Basalt (Sample K<sub>4</sub>)

ENTER NS,AUD PUT SSW1 UP FOR ELECTRODE CORRECTION #49.12317											
N4-1 7/2/71											
AUD# 4.12317 PHASE AND AMPLITUDE CORRECTED											
FNQ	NS	XS	RAOD	XAOD	PH1	Z	ZAOD				
#.999	931.0130	-122.4131	114.6732	-13.0776	-7.4910	939.0200	113.6000				
#.150	433.0450	-197.8160	33.3307	-24.3404	-24.3307	476.0000	30.6300				
#.201	376.0920	-214.2001	46.4219	-26.3904	-26.3904	433.5303	33.3900				
#.403	307.3900	-273.3042	37.8039	-33.9437	-41.0617	412.0074	30.0677				
#.601	227.0444	-228.0711	27.9031	-27.3013	-44.6101	310.0350	30.0000				
#.801	207.1703	-210.7573	32.0001	-31.4064	-43.7203	369.6002	40.3310				
1.#12	230.3003	-210.7573	29.1303	-23.9363	-41.7033	316.7733	30.0370				
2.#12	131.0219	-169.7444	18.0014	-20.0074	-40.3440	227.2000	07.0000				
4.#22	00.2000	-120.6417	10.9070	-10.0000	-33.4070	130.0000	10.0000				
6.#09	00.2000	-09.1300	8.1023	-12.2129	-36.2000	119.0013	10.0000				
10.#52	41.1200	-07.2230	3.0000	-8.2700	-50.3000	70.0000	0.0000				
20.#72	20.0710	-01.7003	3.4370	-3.1372	-56.0017	50.0000	0.0000				
40.#00	10.7001	-23.1220	1.3100	-2.0000	-83.1301	20.0000	0.0000				
80.#00	3.4133	-17.3057	0.8600	-2.1420	-87.9147	10.7730	0.0000				
160.#00	1.3000	-10.0000	0.4200	-1.2300	-71.2000	0.0000	0.0000				
320.#00	1.3000	-2.7000	0.1720	-0.4027	-69.0070	0.0000	0.0000				
640.#00	1.3000	-2.0000	0.1420	-0.2000	-62.7000	0.0000	0.0000				
1280.#00	1.3000	-1.3000	0.1113	-0.1000	-51.3000	1.4340	0.1700				
NS,AS CIRCLE FIT RESULTS- CIRCLE CENTER = 311.1931 370.7300											
RADIUS = 630.4723											
FIT = 3.4732											
RM = 1030.0000 RINF = -0.0000											
MODEL PARAMETERS - K1 = 1545.4073/FNQ											
RP = 1030.3072											
KHO = 0.120000 11 OHM-CM											
CP = 0.130000E-04											
TAU = 10.000000 SEC EINF = 14.77477											
FNQ	EP	EPP									
#.999	-0.100000E+00	-0.000000E+00									
#.150	-0.100000E+00	-0.100000E+00									
#.201	-0.100000E+00	-0.100000E+00									
#.403	-0.100000E+00	-0.100000E+00									
#.601	-0.100000E+00	-0.100000E+00									
#.801	-0.100000E+00	-0.100000E+00									
1.#12	-0.100000E+00	-0.100000E+00									
2.#12	-0.100000E+00	-0.100000E+00									
4.#22	-0.100000E+00	-0.100000E+00									
6.#09	-0.100000E+00	-0.100000E+00									
10.#52	-0.100000E+00	-0.100000E+00									
20.#72	-0.100000E+00	-0.100000E+00									
40.#00	-0.100000E+00	-0.100000E+00									
80.#00	-0.100000E+00	-0.100000E+00									
160.#00	-0.100000E+00	-0.100000E+00									
320.#00	-0.100000E+00	-0.100000E+00									
640.#00	-0.100000E+00	-0.100000E+00									
1280.#00	-0.100000E+00	-0.100000E+00									
2560.#00	-0.100000E+00	-0.100000E+00									
5120.#00	-0.100000E+00	-0.100000E+00									
10240.#00	-0.100000E+00	-0.100000E+00									
20480.#00	-0.100000E+00	-0.100000E+00									
40960.#00	-0.100000E+00	-0.100000E+00									
81920.#00	-0.100000E+00	-0.100000E+00									
163840.#00	-0.100000E+00	-0.100000E+00									
327680.#00	-0.100000E+00	-0.100000E+00									
655360.#00	-0.100000E+00	-0.100000E+00									
1310720.#00	-0.100000E+00	-0.100000E+00									
2621440.#00	-0.100000E+00	-0.100000E+00									
5242880.#00	-0.100000E+00	-0.100000E+00									
10485760.#00	-0.100000E+00	-0.100000E+00									
20971520.#00	-0.100000E+00	-0.100000E+00									
41943040.#00	-0.100000E+00	-0.100000E+00									
83886080.#00	-0.100000E+00	-0.100000E+00									
167772160.#00	-0.100000E+00	-0.100000E+00									
335544320.#00	-0.100000E+00	-0.100000E+00									
671088640.#00	-0.100000E+00	-0.100000E+00									
1342177280.#00	-0.100000E+00	-0.100000E+00									
2684354560.#00	-0.100000E+00	-0.100000E+00									
5368709120.#00	-0.100000E+00	-0.100000E+00									
10737418240.#00	-0.100000E+00	-0.100000E+00									
21474836480.#00	-0.100000E+00	-0.100000E+00									
42949672960.#00	-0.100000E+00	-0.100000E+00									
85899345920.#00	-0.100000E+00	-0.100000E+00									
171798691840.#00	-0.100000E+00	-0.100000E+00									
343597383680.#00	-0.100000E+00	-0.100000E+00									
687194767360.#00	-0.100000E+00	-0.100000E+00									
1374389534720.#00	-0.100000E+00	-0.100000E+00									
2748779069440.#00	-0.100000E+00	-0.100000E+00									
5497558138880.#00	-0.100000E+00	-0.100000E+00									
10995116277760.#00	-0.100000E+00	-0.100000E+00									
21990232555520.#00	-0.100000E+00	-0.100000E+00									
43980465111040.#00	-0.100000E+00	-0.100000E+00									
87960930222080.#00	-0.100000E+00	-0.100000E+00									
175921860444160.#00	-0.100000E+00	-0.100000E+00									
351843720888320.#00	-0.100000E+00	-0.100000E+00									
703687441776640.#00	-0.100000E+00	-0.100000E+00									
1407374883553280.#00	-0.100000E+00	-0.100000E+00									
2814749767106560.#00	-0.100000E+00	-0.100000E+00									
5629499534213120.#00	-0.100000E+00	-0.100000E+00									
11258999068426240.#00	-0.100000E+00	-0.100000E+00									
22517998136852480.#00	-0.100000E+00	-0.100000E+00									
45035996273704960.#00	-0.100000E+00	-0.100000E+00									
90071992547409920.#00	-0.100000E+00	-0.100000E+00									
180143985094819840.#00	-0.100000E+00	-0.100000E+00									
360287970189639680.#00	-0.100000E+00	-0.100000E+00									
720575940379279360.#00	-0.100000E+00	-0.100000E+00									
1441151880758558720.#00	-0.100000E+00	-0.100000E+00									
2882303761517117440.#00	-0.100000E+00	-0.100000E+00									
5764607523034234880.#00	-0.100000E+00	-0.100000E+00									
1152921504606846720.#00	-0.100000E+00	-0.100000E+00									
2305843009213693440.#00	-0.100000E+00	-0.100000E+00									
4611686018427386880.#00	-0.100000E+00	-0.100000E+00									

Table 6-4. Computer Output for Electric and Dielectric Data of Basalt Sample K<sub>1</sub> Following 23-Hour Water Soak

ENTER N6,ADD 879.83916									
PUT #11 UP FOR ELECTRODE CORRECTION									
K1 9/18/71									
ADD# 8.83916									
PHASE AND AMPLITUDE CORRECTED									
FRQ	KP	X5	RAOD	XADO	PH1	2	ZAOD		
1.885	279.4892	48.9736	18.9417	1.9178	9.9423	283.6687	11.1885		
4.825	296.7758	-59.7574	11.6217	-2.3491	-11.3854	382.7315	11.8558		
8.832	241.9583	-125.6838	9.4751	-4.9186	-27.4363	272.6168	18.6737		
16.875	165.9746	-147.5878	6.4996	-5.7764	-41.6316	222.8493	8.6954		
28.208	143.8486	-146.5651	5.6818	-5.7383	-45.6998	284.8829	8.8281		
48.888	91.3979	-147.9236	3.5791	-4.2263	-49.7432	141.4252	5.5582		
88.775	54.5153	-84.8781	2.1348	-3.3235	-57.2888	188.8784	5.5881		
188.785	23.4282	-56.6761	1.3858	-2.2194	-59.5486	65.7474	2.5747		
288.138	9.8535	-49.4393	0.9171	-1.8969	-64.2811	53.8848	2.1878		
488.844	5.1242	-15.6243	0.5859	-1.1283	-71.1253	58.4512	1.1925		
818.811	3.4972	-8.1451	0.3889	-0.6118	-71.8318	16.4447	0.6448		
1888.174	3.2733	-6.6239	0.1282	-0.3198	-66.7681	8.8641	0.3471		
1528.913	2.9259	-4.3883	0.1146	-0.2594	-63.7888	7.3886	0.2895		
2848.528	2.6882	-3.3458	0.1821	-0.1318	-56.3189	5.7743	0.2865		
					-52.8587	4.2417	0.1661		
N6,XP CIRCLE FIT RESULTS- CIRCLE CENTER = 155.2299 4.2558									
RADIUS = 146.6115									
FIT = 6.8611									
K# = 381.7795 KINF# = 8.8881									
MODEL PARAMETERS - K1 = 26567.3359/FRQ									
KP = 243.8994									
KIU = 0.11818E 18 OHM-CM									
CP = 0.161691E-14									
TAU = 4.741148E-08 E# = 1576.85829 EINF# = 45.33224									
FRQ	EP	EPP							
1.885	0.152878E-04	0.487153E-02							
4.825	0.148465E-04	0.964586E-02							
8.832	0.148614E-04	0.186842E-03							
16.875	0.127234E-04	0.332177E-03							
28.208	0.121669E-04	0.422234E-03							
48.888	0.950481E-05	0.662824E-03							
88.775	0.74515E-05	0.731489E-03							
188.785	0.438822E-05	0.537263E-03							
288.138	0.269543E-05	0.438447E-03							
488.844	0.167388E-05	0.138888E-03							
818.811	0.189699E-05	0.668881E-02							
1888.174	0.978816E-06	0.544227E-02							
1528.913	0.887329E-06	0.361682E-02							
2848.528	0.721562E-06	0.272658E-02							
DEL. 0.16 FOR N18/PHN									
N6,X5 CIRCLE FIT RESULTS- CIRCLE CENTER = 569.8811 256.6362									
RADIUS = 624.9592									
FIT = 8.4488									
K# = 1138.8354 KINF# = -0.8339									
MODEL PARAMETERS - K1 = 17693.5623/FRQ									
KP = 1139.6699									
F	F-1/2	K1	XP	CP					
1.8846	0.9977	3738.3389	-1648.1946	-0.9659E-04					
2.8446	0.7828	2384.5439	-1886.1287	-0.7238E-04					
4.8319	0.4988	1518.5762	-783.8887	-0.5688E-04					
8.8359	0.3515	996.8929	-444.8887	-0.4422E-04					
18.8740	0.2151	608.4542	-381.8447	-0.4137E-04					
28.2675	0.2221	496.3653	-242.8685	-0.3244E-04					
48.4830	0.1372	348.6243	-151.9793	-0.2587E-04					
88.7755	0.1113	219.8772	-91.1188	-0.2155E-04					
188.7849	0.0996	139.9681	-75.6945	-0.2888E-04					
288.1384	0.0783	128.4846	-41.8712	-0.1888E-04					
488.8442	0.0496	61.4549	-23.3549	-0.1679E-04					
818.8188	0.0351	26.3587	-13.6238	-0.1442E-04					
1888.1743	0.0314	19.8292	-11.7688	-0.1348E-04					
1528.9126	0.0256	11.9225	-9.7223	-0.1179E-04					
2848.5488	0.0221	8.3359	-8.6864	-0.9828E-05					
G = 0.58150E-04 H = 0.77886E-08									
***** STUP *****									

**Table 6-5. Computer Output for Electric and Dielectric Data of Basalt Sample K<sub>2</sub> Following 23-Hour Water Soak**

ENTER NO, AND PUT SW1 UP FOR ELECTRODE CORRECTION  
#77.96184

[illegible]

MS, XS CIRCLE FIT RESULTS:- CIRCLE CENTER = 419.2#23 116.45992  
RADIUS = 748.6751  
FIT = 4.8992

```

K1 = 438.5414      K1HF = -1.5169
MODEL PARAMETERS -  K1 = 8810.5145/FRQ
                   KP = 439.4383

```

KIU = p. 27143E 1p UNH-CH

CP# 8.404845E-84

TAU= 14.04754115EC      Ep=49588.543      E11Fe 58.3958M

PMU	EP	EPF
1.005	0.44706E	0.5
2.000	0.38584E	0.5
4.007	0.33733E	0.5
6.002	0.27494E	0.5
10.000	0.23075E	0.5
20.178	0.16121E	0.5
40.258	0.10450E	0.5
80.586	0.55809E	0.4
160.503	0.30851E	0.5
320.174	0.50720E	0.5
640.570	0.38809E	0.4
1280.333	0.41705E	0.4
2560.736	0.18720E	0.4
5120.448	0.14113E	0.4
10240.472	0.11405E	0.4

UET. 6,10 FOR N186/FHNN

```
MS,KB CIRCLE FIT RESULTS- CIRCLE CENTER = 075.1211 293.2156
                           RADIUS = 733.8569
                           FIT = 0.9575
```

$K_H = 1347.4547$        $K_{HF} = 2.3873$   
 MODEL PARAMETERS -       $K_1 = 14489.4062 / FRQ$   
                                   $Q_P = 1345.4673$

F	F-1/4	M	XP	CP
1.0054	0.7973	3351.1836	-1326.0083	-0.1194E-03
4.0244	0.7155	1037.7493	-004.7429	0.9325E-04
4.0274	0.3831	1104.3674	-534.5367	0.7393E-04
0.0218	0.3581	1098.8958	-338.3501	0.6066E-04
3.00402	0.3155	593.4642	-274.0288	0.5666E-04
4.0174	0.2246	557.4402	-173.5365	0.4954E-04
4.0174	0.1574	434.0011	-105.9410	0.3733E-04
0.0039	0.1115	1.02955	-00.6456	0.3265E-04
1.0054	0.0997	1.94097	-0.15915	0.3073E-04
2.0174	0.7705	187.7549	-2.5352	0.24085E-04
4.0274	0.4948	25.2745	-15.2123	0.2510E-04
0.0155	0.351	51.1663	-7.9341	0.2479E-04
1.007.4202	0.315	50.2445	-6.3773	0.24748E-04
1.014.4874	0.2457	57.4759	-4.3865	0.2399E-04
2.033.4748	0.241	48.4949	-3.8678	0.2359E-04

08 0.43313L 04 148 0.55354L 00  
MM0.43313L 04 148 0.55354L 00

Table 6-6. Computer Output for Electric and Dielectric Data of Basalt Sample K<sub>4</sub> Following 23-Hour Water Soak

ENTER NO. ADD PWT 55W1 UP FOR ELECTRODE CORRECTION #78.12317									
K4 9/19/71									
ADD# #.12317 PHASE AND AMPLITUDE CORRECTED									
FRQ	RAOD	XAOD	PHI	Z	ZAOD				
1.000	193.0083	-103.2272	23.7753	-12.7145	-28.1389	218.8967	26.9615		
2.013	132.3350	-104.3148	16.2990	-12.4444	-38.2581	168.5859	28.7549		
4.040	89.2916	-84.1705	10.9961	-10.3673	-45.3121	122.7828	15.1142		
8.080	55.7016	-66.4763	6.8608	-8.1879	-58.0435	86.7281	10.6823		
16.000	40.8967	-59.0826	5.7783	-7.2772	-51.5639	75.4324	6.1777		
20.027	39.4582	-49.0012	5.7269	-4.9269	-52.8889	59.1563	9.2918		
40.032	17.5454	-29.0573	2.1611	-3.5799	-58.8888	33.9436	4.1898		
80.045	9.0423	-16.7859	1.1137	-2.3139	-64.3016	20.8488	2.5679		
160.061	7.8072	-10.0505	0.9016	-1.9779	-64.0770	17.8558	2.1993		
200.077	3.8151	-9.4997	0.4453	-1.1781	-69.1787	10.1643	1.2519		
400.099	1.0829	-5.3388	0.2495	-0.6576	-78.7695	5.6545	0.6965		
800.174	1.1000	-2.7341	0.1500	-0.3368	-85.1453	3.0133	0.3712		
1600.455	0.6894	-2.2486	0.1368	-0.2770	-86.7495	2.5873	0.3888		
2000.037	0.0130	-1.5519	0.1095	-0.1912	-88.1847	1.7887	0.2203		
		-1.1101	0.1128	-0.1377	-90.6913	1.4451	0.1789		
NS,XB CIRCLE FIT RESULTS- CIRCLE CENTER = 164.4427 76.8911									
RADIUS = 181.1940									
PWT = 0.9105									
M# = 320.5128 MINF# = 0.3725									
MODEL PARAMETERS - N1 = 4007.1875/FREQ									
NP = 320.1400									
MNU = 0.40403E 10 UH1-CH									
CP# = 0.074179E-04									
TAU# = 24.4314515EC EN# = 0.164.734 EINF# = 68.22583									
FRQ	EP	EMP							
1.000	0.403100E 05	0.189967E 05							
2.013	0.424671E 05	0.150747E 05							
4.040	0.354877E 05	0.103311E 05							
8.080	0.278498E 05	0.100437E 05							
16.000	0.252053E 05	0.184773E 05							
20.027	0.179906E 05	0.153118E 05							
40.032	0.122306E 05	0.112444E 05							
80.045	0.798688E 04	0.761403E 04							
160.061	0.694497E 04	0.660217E 04							
200.077	0.438257E 04	0.424391E 04							
400.099	0.274039E 04	0.265432E 04							
800.174	0.171307E 04	0.163938E 04							
1600.455	0.147020E 04	0.140212E 04							
2000.037	0.117315E 04	0.110139E 04							
	0.923078E 03	0.852702E 03							
UET. 0.14 FOR N10/FREQ									
NS,XB CIRCLE FIT RESULTS- CIRCLE CENTER = 364.4236 139.3846									
RADIUS = 388.8036									
FIT = 0.6445									
M# = 727.4375 MINF# = 1.4098									
MODEL PARAMETERS - N1 = 9414.4453/FREQ									
NP = 726.0277									
P	F-1/2	R1	XP	CP					
1.000	0.9959	2277.5112	-0.37.4116	-0.1045E-03					
2.013	0.7049	1431.3850	-0.40.0271	-0.1448E-03					
4.040	0.4075	840.4438	-0.46.3225	-0.1138E-03					
8.080	0.1921	510.1658	-0.212.5725	-0.9288E-04					
16.000	0.3162	437.6799	-0.02.0204	-0.8742E-04					
20.027	0.2244	401.0143	-0.110.7184	-0.7107E-04					
40.032	0.1575	177.7355	-0.09.9308	-0.5897E-04					
80.045	0.1114	116.7027	-0.09.9754	-0.5864E-04					
160.061	0.0798	104.7803	-0.32.3545	-0.4333E-04					
200.077	0.0703	99.0307	-0.17.7451	-0.3870E-04					
400.099	0.0497	45.5987	-0.04.001	-0.4105E-04					
800.174	0.0351	30.4916	-0.03.030	-0.3870E-04					
1600.455	0.0314	23.7440	-0.04.0725	-0.3873E-04					
2000.037	0.0205	22.4412	-0.02.0225	-0.3868E-04					
	0.0221	16.5356	-0.01.0668	-0.3971E-04					
G# 0.20178E #4 N# 0.03535E #4									
XXXXXXXXXXXX STUP XXXXXXXXXXXXXXX									

Table 6-7. Computer Output for Electric and Dielectric Data of Basalt Sample K<sub>1</sub> Following 72-Hour Water Soak

ENTER NO,ADD PUT 15W1 UP FOR ELECTRODE CORRECTION  
002.03916

K1 9/17/71 77 MM ADD# 0.03916 PHASE AND AMPLITUDE CORRECTED

FRQ	RS	XS	RAOD	XADD	PHI	Z	ZADD
1.011	1012.1704	-033.7279	39.6366	-32.6488	-39.4813	1311.3310	31.3310
2.013	640.3005	-000.0103	23.0742	-26.8998	-47.0109	930.9912	36.7709
4.042	305.7009	-305.1570	14.3234	-19.7020	-34.0970	623.6743	24.4231
8.080	151.1057	-342.1343	7.4037	-13.3988	-60.0195	391.0069	19.9471
16.154	152.4525	-295.4302	5.9096	-11.5690	-62.6327	332.6762	19.0276
20.145	99.5024	-174.2307	3.3441	-6.0229	-62.5553	196.5342	7.6804
40.225	54.9444	-113.0870	2.0733	-4.4398	-65.0699	125.5949	4.0183
80.445	31.0339	-71.1370	1.2308	-2.7857	-66.0306	77.0535	3.0407
160.604	16.7475	-39.3700	0.6358	-2.3231	-74.2337	61.6918	2.4158
201.013	9.4012	-32.9723	0.3077	-1.2912	-73.2910	34.4268	1.3402
403.220	5.2777	-17.0320	0.2067	-0.6991	-73.5399	18.6198	0.7209
807.039	3.4044	-9.1037	0.1333	-0.3366	-69.3027	9.7215	0.3807
1607.320	3.3004	-7.2723	0.1316	-0.2844	-65.2036	8.0111	0.3197
1515.151	3.2034	-4.9406	0.1206	-0.1938	-36.4360	3.9300	0.2326
4033.472	2.7261	-3.2877	0.1008	-0.1287	-30.3302	4.2709	0.1672

RS, XS CIRCLE FIT RESULTS- CIRCLE CENTER = 1057.4980 311.3094  
RADIUS = 1350.4213  
FIT = 0.1448

KP = 2510.4492 RINF = -1.4331

MODEL PARAMETERS - R1 = 10199.4102/FRQ  
KP = 2517.0023

KIU = 0.98344E 10 OHM-CM

CP = 0.150470E-04

TAU = 42.5453311SEC EP=004442.062 EINF = 40.76112

FRQ	EP	EPP
1.011	-0.020930E 03	-0.205449E 05
2.013	-0.522494E 05	-0.203099E 05
4.042	-0.409350E 05	-0.204044E 05
8.080	-0.200076E 05	-0.232501E 05
16.154	-0.200417E 05	-0.234750E 05
20.145	-0.170070E 05	-0.170417E 05
40.225	-0.114713E 05	-0.113103E 05
80.445	-0.711027E 04	-0.712400E 04
160.604	-0.000430E 04	-0.010931E 04
201.013	-0.707590E 04	-0.372101E 04
403.220	-0.219334E 04	-0.224100E 04
807.039	-0.120077E 04	-0.133900E 04
1607.320	-0.100770E 04	-0.113061E 04
1515.151	-0.700000E 03	-0.037800E 03
4033.472	-0.025300E 03	-0.072232E 03

DET. GIN FOR RING/FMMH

RS, AS CIRCLE FIT RESULTS- CIRCLE CENTER = 883.6303 417.9223  
RADIUS = 978.1311  
FIT = 0.4049

KP = 1700.0053 KINF = -0.7033

MODEL PARAMETERS - R1 = 15901.0437/FRQ  
KP = 1700.7075

F	F=1/2	R1	XP	CP
1.0105	0.3948	3922.7336	-1737.1453	-0.0964E-04
2.0134	0.7047	2330.0003	-1133.9956	-0.6971E-04
4.0417	0.4074	1430.0392	-719.5470	-0.3539E-04
8.0802	0.3510	914.9009	-433.3304	-0.4523E-04
16.1545	0.3154	790.0003	-300.4014	-0.4204E-04
20.1450	0.2428	449.3347	-223.3005	-0.3459E-04
40.2253	0.1577	304.1002	-143.4750	-0.2750E-04
80.4452	0.1114	197.9350	-87.0230	-0.2260E-04
160.6030	0.0997	107.6031	-69.6103	-0.2273E-04
201.0129	0.0704	107.0200	-40.0049	-0.1973E-04
403.2204	0.0430	50.1409	-22.5007	-0.1750E-04
807.0394	0.0351	25.0150	-13.0719	-0.1577E-04
1607.3202	0.0213	10.0504	-11.2510	-0.1404E-04
1515.1514	0.0230	11.0702	-9.2134	-0.1140E-04
4033.4720	0.0221	0.2137	-0.2597	-0.9477E-05

G = 0.47747L U4 I0 = 0.70137L 00  
XX

**Table 6-8. Computer Output for Electric and Dielectric Data of Basalt Sample K<sub>2</sub> Following 72-Hour Water Soak**

ENTER NS,ADD POT 55W1 UP FOR ELECTRODE CORRECTION  
#80, #0104

AZ 9/17/71 77 HR		AOD= 0.66184		PHASE AND AMPLITUDE CORRECTED					
PRQ	RS	XS	ROAD	XAOD	PHI	Z	2ADD		
1.004	549.5524	-499.2118	32.7166	-24.7491	-37.1891	663.5746	41.8231		
2.111	347.4284	-336.5769	21.4724	-28.8139	-44.1111	403.3786	29.5943		
4.043	459.1339	-450.9608	17.9332	-15.8313	-50.7373	338.3737	20.4427		
8.041	117.0079	-108.9921	7.2367	-11.1864	-37.8233	219.6373	13.3359		
16.137	95.7949	-145.1648	5.9143	-18.8941	-39.6187	183.1613	11.6977		
32.137	57.0489	-47.9423	3.3761	-6.6289	-39.3294	113.3551	7.0990		
64.458	33.9551	-45.3471	2.1423	-4.0534	-62.3917	73.8382	4.3662		
128.775	19.1594	-41.7323	1.1848	-2.3822	-65.3347	45.9387	2.6480		
256.563	12.6533	-35.2492	0.7823	-1.2823	-78.2797	37.0890	2.3143		
511.004	6.0413	-26.0026	0.4251	-1.2487	-71.1754	21.1978	1.5180		
1021.944	3.7151	-19.8891	0.2297	-0.6794	-71.3214	11.5973	0.7172		
2047.899	2.0417	-5.7354	0.1541	-0.3347	-66.3229	6.2333	0.3867		
4093.944	2.2116	-6.7443	0.1368	-0.2922	-64.9193	3.2163	0.3226		
8187.200	1.9329	-3.2193	0.1193	-0.1991	-39.8242	3.7332	0.3322		
16374.783	1.9773	-4.3532	0.1161	-0.1433	-31.8224	3.8193	0.1862		

RS,AS CIRCLE FIT RESULTS- CIRCLE CENTER = 603.8373 261.2600  
RADIUS = 637.7368  
FIT = 4.3839

HP= 12μ7.4μ7                      HIRF= μ.2344

MODEL PARAMETERS - H1 = 9877.5664/FRQ  
HP = 1247.2463

000000 = 8,74671E 1# 0H4-CII

CP# 44754E-44

TAU= 39.13530/SEC      EY=53.5112.10      E1NF= 39.22110

FMJ	EP	EPP
1. #22	#.24762E	#6
2. #11	#.194992E	#6
3. #43	#.152932E	#6
4. #10	#.13395E	#6
5. #1	#.11699E	#6
6. #137	#.60935E	#5
7. #45	#.49808E	#5
8. #775	#.208532E	#5
9. #90.50	#.204415E	#5
10. #.404	#.149993E	#5
11. #242	#.910247E	#4
12. #100.5	#.744993E	#4
13. #100.5	#.747519E	#4
14. #132.28	#.33357E	#4
15. #25.783	#.20604E	#4
16. #70537E	#.70537E	#3
17. #911249E	#.911249E	#3
18. #1406179E	#.1406179E	#3
19. #558671E	#.558671E	#3
20. #41853E	#.41853E	#3
21. #33276E	#.33276E	#3
22. #270997E	#.270997E	#3
23. #240419E	#.240419E	#3
24. #140652E	#.140652E	#3
25. #91813E	#.91813E	#3
26. #744993E	#.744993E	#3
27. #681149E	#.681149E	#3
28. #747532E	#.747532E	#3
29. #206032E	#.206032E	#3

DET. G. H. FUR HING/FERN

```
RS,XS CIRCLE FIT RESULTS- CIRCLE CENTER = 333.6002 176.3403
                             RADIUS = 570.4610
                             FIT = 0.5473
```

KF# 669.1244 KIP# -J.0001

MODEL PARAMETERS - R1 = 9046.9533/FKQ  
RP = 668.8325

F	W	R13	XP	CP
1.0019	0.9998	1950.7134	-980.2205	-0.1621E+03
2.0112	0.7951	1213.9211	-648.8895	-0.1220E+03
4.0474	0.4974	767.0616	-422.8733	-0.9319E+02
8.0612	0.3560	509.4535	-270.3139	-0.7336E+02
16.0503	0.3153	335.0242	-175.0509	-0.5803E+02
32.0399	0.2749	220.4606	-110.4072	-0.3393E+02
64.0270	0.1576	101.2910	-91.0665	-0.6131E+01
128.0753	0.1113	121.0577	-63.4156	-0.3621E+01
256.0525	0.0997	101.0609	-60.9402	-0.3374E+01
512.0882	0.0703	62.3372	-27.1119	-0.2491E+01
1024.1243	0.0498	32.4214	-13.7749	-0.2532E+01
2048.0974	0.0315	15.0440	-6.7673	-0.2636E+01
4096.0344	0.0315	14.2991	-6.3360	-0.1894E+01
8192.2076	0.0257	9.9938	-6.7673	-0.1533E+01
16384.7847	0.0222	3.9903	-0.6082	-0.1109E+01

G# 0.24041E #4 R# 0.74404E #J  
##### STOP #####



Table 6-9. Computer Output for Electric and Dielectric Data of Basalt Sample K<sub>4</sub> Following 72-Hour Water Soak

ENTER NS,AUD PUT SSWI UP FOR ELECTRODE CORRECTION  
#01.12317

K4 9/17/71 77 HK ADD# 0.12517 PHASE AND AMPLITUDE CORRECTED

FRQ	RS	XS	RAOD	XAOD	PHI	Z	ZAOD
1.007	217.1331	-146.2850	26.7445	-18.0177	-55.9785	261.8156	32.2476
2.022	149.7510	-126.3896	18.4424	-13.3020	-40.2157	196.0721	24.1502
4.050	93.4650	-101.1523	11.7304	-12.4563	-46.6546	130.0750	17.1296
8.091	57.2352	-75.4501	7.0497	-9.2907	-32.0152	94.6867	11.6626
16.178	47.4025	-66.9405	5.0460	-8.2451	-34.6665	82.0392	10.1872
32.356	29.3177	-45.4969	3.6111	-3.5575	-36.0254	32.4540	6.4609
64.713	17.5133	-30.0500	2.1327	-5.7022	-60.0395	34.6888	4.2726
129.426	9.5442	-19.0440	1.1504	-2.4197	-64.5760	21.7522	2.6792
258.852	5.0378	-9.7200	0.6005	-2.1120	-66.9596	10.6530	2.2951
517.704	2.6667	-5.5600	0.4503	-1.1975	-69.5842	10.5862	1.2795
1035.408	1.4200	-2.8737	0.1749	-0.3539	-68.9509	5.7329	0.7066
2070.816	1.2536	-2.5074	0.1319	-0.2941	-65.7087	5.2054	0.3940
4141.632	0.9279	-1.6402	0.1143	-0.2028	-62.6785	2.6073	0.3510
8283.264	0.9378	-1.2237	0.1100	-0.1507	-64.9469	1.8096	0.2327
					-51.9541	1.3540	0.1914

NS,XS CIRCLE FIT RESULTS- CIRCLE CENTER = 223.4990 106.2901  
RADIUS = 247.1219  
FIT = 0.0101

MP = 440.0124 MINF = 0.1057  
MODEL PARAMETERS - R1 = 4002.6133/FRQ  
RP = 440.0207

RHU = 0.33854E 10 OHM-CM

CP = 0.39777E-04

TAU = 29.50055MSEC E0 = 0.146090.37 EINF = 60.70006

FRQ	EP	EPP
1.007	0.115734E 06	0.293029E 03
2.022	0.900101E 03	0.390094E 03
4.050	0.009715E 03	0.434510E 03
8.091	0.019537E 03	0.447643E 03
16.178	0.561820E 03	0.430290E 03
32.356	0.393404E 03	0.344501E 03
64.713	0.263694E 03	0.247926E 03
129.426	0.171007E 03	0.165205E 03
258.852	0.140771E 03	0.143971E 03
517.704	0.937327E 04	0.917197E 04
1035.408	0.304079E 04	0.375032E 04
2070.816	0.361073E 04	0.553062E 04
4141.632	0.309510E 04	0.501992E 04
8283.264	0.233362E 04	0.226007E 04
16566.528	0.190900E 04	0.184464E 04

DET. G,N FOR R1G/FRMH

NS,XS CIRCLE FIT RESULTS- CIRCLE CENTER = 194.2527 95.4422  
RADIUS = 215.2560  
FIT = 0.6200

MP = 300.1494 MINF = 0.3100  
MODEL PARAMETERS - R1 = 5094.1033/FRQ  
RP = 507.0334

F	F-1/2	R1	RP	CP
1.000	0.9996	1234.5152	-570.7021	-0.2731E-03
2.000	0.7071	810.0309	-503.7461	-0.2041E-03
4.000	0.4472	400.0203	-249.0445	-0.1570E-03
8.000	0.3162	310.3510	-130.0434	-0.1245E-03
16.000	0.2582	271.2002	-130.1979	-0.1161E-03
32.000	0.2226	160.9179	-04.7639	-0.9506E-04
64.000	0.1961	111.5041	-52.3094	-0.7346E-04
128.000	0.1771	72.9370	-51.0037	-0.6339E-04
256.000	0.1600	63.9032	-26.0274	-0.6066E-04
512.000	0.1447	39.2520	-13.1900	-0.5217E-04
1024.000	0.1315	22.0331	-0.6510	-0.4500E-04
2048.000	0.1199	11.3239	-4.0026	-0.4043E-04
4096.000	0.1100	0.4790	-4.0034	-0.3040E-04
8192.000	0.1010	5.0026	-3.0078	-0.5400E-04
16384.000	0.0925	3.3376	-2.4000	-0.5145E-04

G = 0.15167E 04 N0 0.74106E 00  
XXXXXXXXXX STOP XXXXXXXXXXXX

K1 are given in Table 6-10. The significant conclusion indicated by these results is that the highest sensitivity for water detection in rocks can only be achieved by data extrapolation to the static or zero frequency dielectric constant.

Table 6-10. Effect of Water Pretreatment on Selected Electric and Dielectric Parameters of Basalt

Parameter $\downarrow$ / Soak Time (Hours) $\rightarrow$	0 (Baseline)	23	77
$R_o$ , megohm	1,031.0	328.0	447.0
$\tau$ , millisecond	16.6	24.4	29.6
$\epsilon_o \epsilon_r = \kappa_o$	1,770.0	60200.0	146000.0
$\epsilon_\infty \epsilon_r = \kappa_\infty$	14.8	68.2	60.7

The highest selectivity for water detection is obtained by choosing the real component of the dielectric constant at the limit of zero frequency from among the impedance and the dielectric parameters.

The variations of the impedivity vectors for three basalt samples with frequency are shown in Figure 6-1. After the three rocks were soaked for 23 hours in distilled water, their impedivity variation with frequency are shown by the curves in Figure 6-2. Figure 6-3 gives the same relationships for the rocks following a 77-hour soak period.

Here again, the impedivity vectors are the most separated at low frequencies, and approach each other as the frequency increases.

The variation of rock impedivity at 1 Hz with the duration of water pretreatment is shown in Table 6-11 and Figure 6-4 for the three basalt rocks.

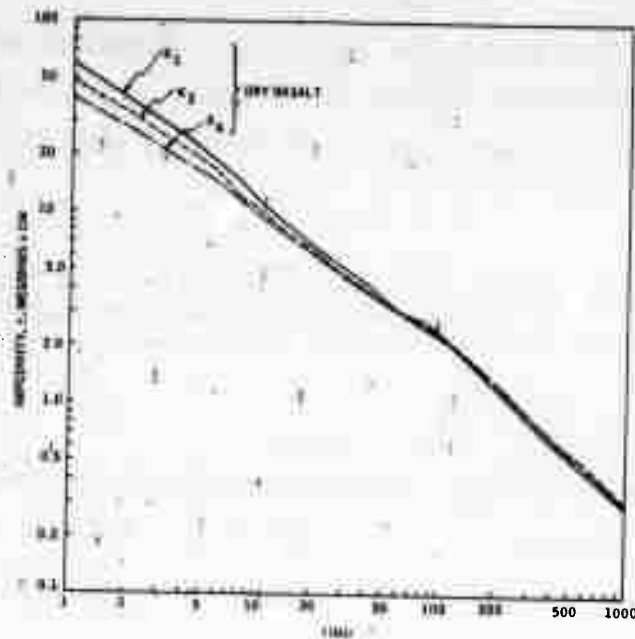


Figure 6-1. Variation of Impedivity with Frequency for an Untreated Basalt Sample

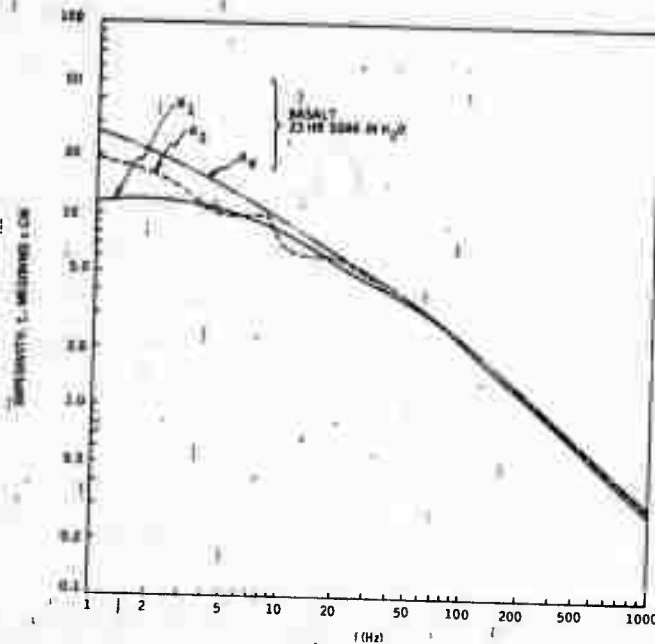


Figure 6-2. Variation of Impedivity with Frequency for Basalt Samples Following a 23-hour Water Soak

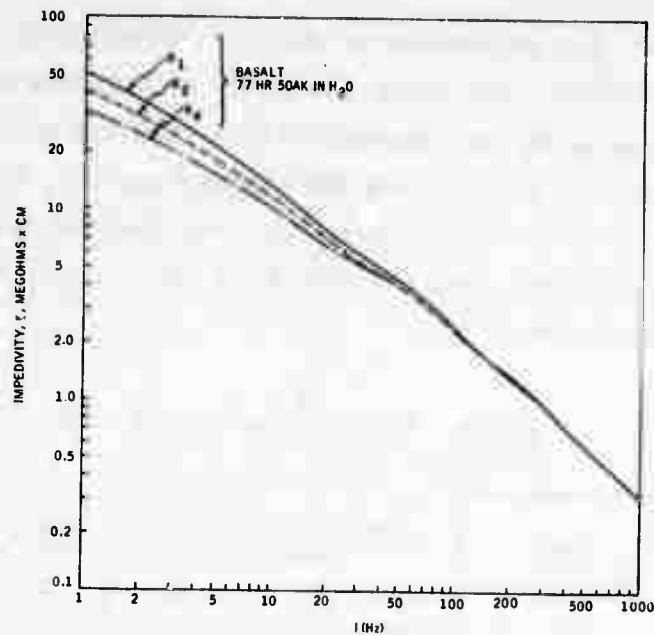


Figure 6-3. Variation of Impedivity with Frequency for Basalt Samples Following a 77-hour Water Soak

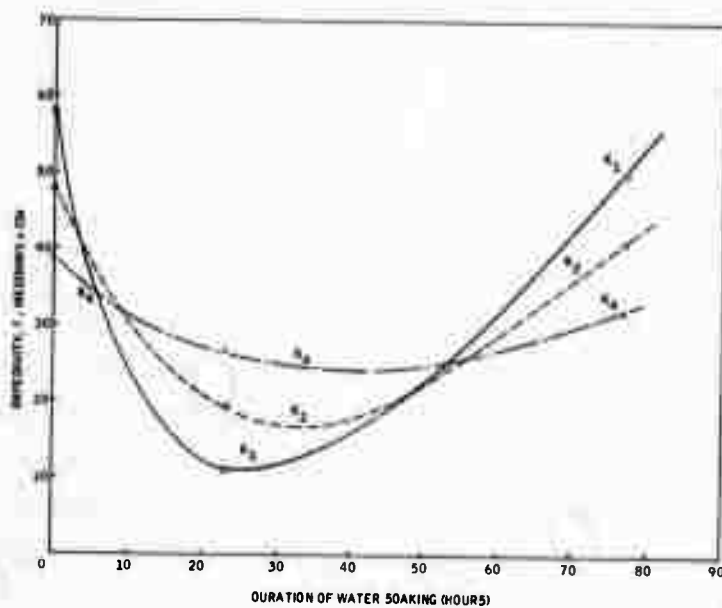


Figure 6-4. Variation of Rock Impedivity with the Duration Time of Water Treatment for Three Samples of Basalt

Generally speaking, the impedance versus time-of-soaking decreases initially, goes through a minimum, and increases again with longer soak times. This behavior is explainable by the assumption that the first portions of water that diffuse through the rock pores leach the adjacent sodium and potassium ions, and thus decrease the rock impedance. Further introduction of water into the pores will begin to leach out the dissolved alkali ions, thus resulting in an increase in rock impedance.

Table 6-11. Effect of Water Soaking on Impedivity of Basalt at 1 Hz

Time of Soaking (hours)	Impedivity at 1 Hz, megohm x cm		
	K <sub>1</sub>	K <sub>2</sub>	K <sub>4</sub>
0	58	48	39
23	11	19	27
77	50	41	32

#### PRETREATMENT OF BASALT IN SODIUM HYDROXIDE

To further investigate the effects of environmental conditions on rock impedivity, other series of tests were conducted on basalt that had been pretreated in solutions of sodium hydroxide. The three samples K<sub>1</sub>, K<sub>2</sub>, and K<sub>4</sub> of basalt were soaked for 23 hours in 1, 5, and 10 percent solutions of sodium hydroxide in water. The impedance data of these experiments were grouped with those obtained while soaking the same rock samples in distilled water (zero percent NaOH) for 23 hours. Computer output data of these experiments are given in Tables 6-12 to 6-20. Variations of the magnitude of impedivity vector with frequency as a result of the various soaking solutions are shown in Figures 6-5, 6-6, and 6-7. Here again, the impedance arcs for various NaOH concentrations seem to overlap and become indistinguishable at frequencies greater than 100 Hz.

Table 6-12. Computer Output for Electric and Dielectric Data of Basalt Sample K<sub>1</sub> Pretreated in 1% NaOH for 23 Hours

ENTER NS,ADD PUT SSWI UP FOR ELECTRODE CORRECTION  
#03.#3916

K1 9/27/71 IPC ADD= #.05918 PHASE AND AMPLITUDE CORRECTED

FRQ	RS	XS	RAOD	XAOD	PHI	Z	ZAOD
1.#00	-46.845#	225.45#4	-1.8544	0.0200	181.7451	258.2654	9.8172
2.#05	68.50#6	174.8752	2.0020	0.0400	88.6114	187.0143	7.5548
4.#20	155.9631	89.3441	5.5245	5.4087	53.5122	162.8989	0.571#
8.#08	149.142#	4.9989	5.408#	0.1054	2.8590	148.2589	5.4914
1#.#20	131.1#49	-15.8520	5.1541	-0.5425	-6.852#	151.8547	5.1826
2#.#61	98.4211	-42.44#5	5.8542	-1.002#	-25.5282	187.1817	4.1972
4#.#25	65.889#	-51.16#1	2.5489	-2.881#	-39.2425	86.8591	5.291#
8#.#57	51.5885	-41.8259	1.257#	-1.7555	-54.8587	54.8562	2.1474
1#.#5#1	26.7956	-39.64#	1.8492	-1.5325	-55.9484	47.8439	1.8758
2#.#72	15.87#9	-25.7145	0.5119	-1.087#	-85.8599	28.8439	1.1298
4#.#576	6.4445	-15.8297	0.2574	-0.5406	-86.7894	18.5358	0.64#4
8#.#572	5.8188	-8.1292	0.1492	-0.5101	-84.8751	8.9758	0.5524
1#.#5.4#4	5.5162	-8.4839	0.1577	-0.2559	-51.5558	7.3788	0.2888
1512.2#8	2.95#4	-4.4186	0.1157	-0.1727	-58.1847	5.5889	0.2879
2#25.7#5	2.6284	-5.5321	0.1829	-0.1585	-51.7572	4.244#	0.1662

RS,XS CIRCLE FIT RESULTS- CIRCLE CENTER = 41.5851 89.8127  
RADIUS = 128.8220  
FIT = 17.4#81

R# = 121.8755 RINF = -39.1491

MODEL PARAMETERS - R1 = 2#7#5.8516/FRQ  
RP = 161.8244

R#U = #.47726E #9 OHM-CM

CP = #.145554E-#5

TAU = #.54887#SEC E# = -25.71297 EINF = 0.25958

FRQ	EP	OPP
1.#00	-#.244897E #2	-#.119245E #1
2.#05	-#.259#77E #2	-#.159938E #1
4.#20	-#.23216#E #2	-#.211921E #1
8.#08	-#.222789E #2	-#.2755#E #1
1#.#20	-#.219#61E #2	-#.298975E #1
2#.#61	-#.2#4959E #2	-#.378#34E #1
4#.#25	-#.18665#E #2	-#.463112E #1
8#.#57	-#.163456E #2	-#.544896E #1
1#.#5#1	-#.154955E #2	-#.588659E #1
2#.#72	-#.125518E #2	-#.627421E #1
4#.#576	-#.#952172E #1	-#.655538E #1
8#.#5.372	-#.#85745E #1	-#.641258E #1
1#.#5.4#4	-#.#83255E #1	-#.629258E #1
1512.2#8	-#.#524915E #1	-#.#598716E #1
2#25.7#5	-#.#2#547#E #1	-#.#5711#E #1

DET. G,N FOR K1=G/FR#N

RS,XS CIRCLE FIT RESULTS- CIRCLE CENTER = 259.2518 125.1585  
RADIUS = 289.2#81  
FIT = #.955#

R# = 519.955# RINF = -1.4918

MODEL PARAMETERS - R1 = 177#1.2891/FRQ  
RP = 521.446#

F	F-1/2	R1	XP	CP
#.4999	1.0#01	3934.5721	-1718.56#8	-#.9262E-#4
2.#051	#.7#62	2395.5915	-1121.8417	-#.7#81E-#4
4.#196	#.49#8	1468.57#8	-717.5760	-#.5518E-#4
8.#077	#.3554	915.6278	-444.691#	-#.447#E-#4
1#.#281	#.3158	778.4894	-388.1547	-#.4175E-#4
2#.#613	#.2227	465.7562	-244.0275	-#.5224E-#4
4#.#255	#.1577	322.8987	-152.5859	-#.2595E-#4
8#.#268	#.1116	221.8252	-88.4447	-#.2242E-#4
1#.#3#89	#.#998	185.5672	-72.2488	-#.21#9E-#4
2#.#724	#.#7#3	159.9158	-42.9241	-#.#144E-#4
4#.#576	#.#4#8	56.9755	-24.5258	-#.#161E-#4
8#.#5.715	#.#352	25.1147	-14.6844	-#.#154E-#4
1#.#5.4#4	#.#315	18.9547	-12.8555	-#.#1251E-#4
1512.2#76	#.#257	12.826#	-18.8965	-#.#9659E-#5
2#25.7#27	#.#222	8.8#46	-18.1782	-#.#7719E-#5

G = #.48169E #4 N = #.77814E #8  
XXXXXXXXXXXX STUP XXXXXXXXXXXX

Table 6-13. Computer Output for Electric and Dielectric Data of Basalt Sample K<sub>2</sub> Pretreated in 1% NaOH for 23 Hours

```

ENTER NS,AMU PUT 66M1 UP FOR ELECTRODE CORRECTION
983.86184

K2 8/27/71 IPC ADD= 8.86184 PHASE AND AMPLITUDE CORRECTED

PRQ R6 XS RAOO RAOO PHI Z ZAOO
8.899 113.4325 3.6831 7.8139 8.2279 1.8668 113.9185 7.8139
2.818 128.8828 -18.3338 7.4733 -8.6329 -4.9988 121.3418 7.8139
4.833 173.7433 -28.3816 7.1579 -1.8178 -14.2448 119.4149 7.8139
8.899 99.8086 -43.1841 3.7615 -3.7942 -23.8741 183.3467 6.4833
18.888 89.8086 -48.8838 3.1888 -8.8738 -28.8831 86.8871 3.7888
28.121 69.1812 -48.8838 3.7222 -2.7721 -36.8796 79.8488 4.8811
48.238 38.8488 -48.8838 3.7222 -2.7721 -36.8796 79.8488 4.8811
88.313 18.3282 -31.8398 1.1888 -1.1888 -38.7211 39.3611 8.2897
188.482 18.3334 -27.2186 8.4831 -1.6337 -38.7211 39.3611 8.2897
281.613 7.8731 -17.8788 8.4831 -1.6337 -38.7211 39.3611 8.2897
482.376 4.8788 -8.8888 8.2821 -8.8888 -47.8888 38.8888 8.8888
887.888 2.8811 -9.2834 8.1847 -8.8888 -47.8888 38.8888 8.8888
1888.174 2.8822 -4.2822 8.1847 -8.8888 -47.8888 38.8888 8.8888
1318.827 1.8884 -2.8888 8.1189 -8.1811 -37.1846 8.4888 8.2188
2833.472 1.8391 -2.1426 8.1133 -8.1325 -48.4873 2.8215 8.1748

R6,X6 CIRCLE FIT RESULTS- CIRCLE CENTER = 91.8881 18.8896
RADIUS = 98.4888
FIT = 3.7894

R6= 121.3734 RINF= 2.4828
MODEL PARAMETERS - R1 = 13977.4648/PRQ
RP = 118.9786
RMU = 8.738378 BY UHM-CH
CP= 8.388178E-04
TAU= 4.328888888 88=3482.72848 RINF= 69.14898

PRQ BP EPP
8.899 8.3384188 84 8.1418428 83
2.818 8.3243228 84 8.2386738 83
4.833 8.3884888 84 8.4638818 83
8.899 8.2764888 84 8.7869138 83
18.888 8.2842838 84 8.8133838 83
28.121 8.2188388 84 8.1383748 84
48.238 8.1886188 84 8.1423888 84
88.313 8.1183888 84 8.1148288 84
188.482 8.1882838 84 8.1818438 84
281.613 8.8883118 83 8.6314888 83
482.376 8.4138888 83 8.3624838 83
887.888 8.2831738 83 8.2883848 83
1888.174 8.2228388 83 8.1683888 83
1318.827 8.4228888 83 8.1188828 83
2833.272 8.1872888 83 8.8881138 82

GET. G.M FOR R1G/P=RM
R6,X6 CIRCLE FIT RESULTS- CIRCLE CENTER = 438.3424 216.9981
RADIUS = 487.3888
FIT = 8.4277
R6= 871.6748 RINF= -8.9881
MODEL PARAMETERS - R1 = 12372.5781/PRQ
RP = 872.6931

P F-1/2 R1 XF CP
8.8987 1.8888 3613.3827 -1267.8838 -8.12878-83
2.8182 7.8833 1647.8183 -823.1321 -8.98818-84
4.8333 8.4888 1837.1868 -328.6428 -8.74888-84
8.8934 8.3328 633.7811 -328.4938 -8.98138-84
18.8888 8.3133 337.8788 -281.3318 -8.36188-84
28.1287 8.2223 338.8793 -178.8888 -8.44428-84
48.2376 8.1394 238.7323 -188.8888 -8.38318-84
88.3133 8.1114 133.8778 -84.3879 -8.38788-84
188.4818 8.8888 133.8778 -84.3879 -8.38788-84
281.6128 8.6784 78.4887 -54.4288 -8.28138-84
482.3764 8.8488 48.3438 -17.8817 -8.23888-84
887.8884 8.8331 17.8887 -18.3871 -8.18888-84
1888.1743 8.8314 13.7183 -8.2134 -8.17118-84
1318.8288 8.8256 8.7383 -7.7388 -8.13318-84
2833.2788 8.8221 8.3488 -7.3913 -8.18388-84

GM 8.333338 84 NM 8.772188 88
***** STOP *****

```

Table 6-14. Computer Output for Electric and Dielectric Data of Basalt Sample K<sub>4</sub> Pretreated in 1% NaOH for 23 Hours

ENTER NS,ADD PUT SSW1 UP FOR ELECTRODE CORRECTION  
#84.12517

K4 9/27/71 IPC		ADD# 8.12517		PHASE AND AMPLITUDE CORRECTED			
FRQ	RS	XS	RAOD	XADD	PH1	Z	ZADD
1.004	110.0592	-38.0375	14.6132	-7.1485	-26.0657	132.0922	16.2698
2.019	94.3437	-37.3047	11.6205	-7.0382	-51.2770	110.3838	15.3960
4.038	70.7654	-31.9217	8.7162	-6.3952	-36.2700	87.7701	10.8106
8.077	46.0505	-43.7294	5.9552	-5.5861	-41.9492	65.4209	8.0579
16.154	42.4959	-40.6498	3.2540	-5.0068	-45.7527	38.0039	7.2431
20.000	29.5502	-30.2315	5.6151	-3.7261	-45.0096	42.1495	3.1915
40.161	18.1461	-25.7146	2.2551	-2.9209	-52.3811	29.8608	5.6779
80.313	9.4075	-16.7069	1.1587	-2.0676	-60.7500	19.2452	2.0555
160.626	8.1115	-14.5846	0.9991	-1.7964	-60.9255	16.6844	1.1970
201.613	3.0677	-8.9159	0.4764	-1.0982	-66.5559	9.7187	0.6761
403.237	2.0508	-5.0963	0.2311	-0.6277	-68.2015	5.4800	0.5705
806.555	1.2989	-2.7117	0.1600	-0.5540	-64.4099	5.0068	0.3045
1612.891	1.1819	-2.1599	0.1456	-0.2673	-61.4285	2.4709	1.0084
1512.200	0.9370	-1.3539	0.1189	-0.1809	-58.0252	1.0084	0.2227
2029.520	0.9962	-1.0097	0.1227	-0.1542	-47.5697	1.4764	0.1818

NS,XS CIRCLE FIT RESULTS- CIRCLE CENTER = 96.7230 55.4681  
RADIUS = 110.4367  
FIT = 1.4339

R0 = 195.3554 KINF = 0.0926

MODEL PARAMETERS - R1 = 0.005.9922/FRQ  
RP = 193.2600

RNU = 0.23013E 10 OHM-CM

CP = 0.614124E-04

TAU = 15.56457MSEC EP = 0.5154331.59 EINF = 64.35760

FRQ	EP	EPP
1.004	0.114620E 06	0.181965E 05
2.019	0.104793E 06	0.257065E 05
4.038	0.918067E 05	0.554077E 05
8.077	0.763991E 05	0.387091E 05
16.154	0.710187E 03	0.394330E 05
20.000	0.343193E 03	0.370009E 03
40.161	0.592349E 05	0.317039E 05
80.313	0.209930E 05	0.258233E 03
160.626	0.257904E 03	0.214611E 05
201.613	0.156746E 05	0.140938E 03
403.237	0.101632E 05	0.974330E 04
806.555	0.640920E 04	0.628081E 04
1612.891	0.360963E 04	0.344500E 04
1512.200	0.431984E 04	0.419661E 04
2029.520	0.356446E 04	0.346068E 04

DET. 0.11 FOR R1=0/FMMN

NS,XS CIRCLE FIT RESULTS- CIRCLE CENTER = 242.0772 121.0511  
RADIUS = 271.0034  
FIT = 0.3391

R0 = 485.6497 KINF = -1.4953

MODEL PARAMETERS - R1 = 0.154.8477/FRQ  
RP = 487.1430

F	F-1/2	R1	XP	CP
1.0036	0.9982	1917.0001	-911.2679	-0.1740E-05
2.0072	0.7030	1162.5101	-585.8918	-0.1330E-03
4.0144	0.4981	710.7501	-566.5549	-0.1078E-05
8.0288	0.3532	436.0704	-227.0554	-0.0744E-04
16.0576	0.3136	389.7518	-193.5504	-0.0200E-04
20.0000	0.2231	241.9306	-119.6719	-0.0621E-04
40.0000	0.1378	100.1624	-72.2030	-0.5489E-04
80.0000	0.1114	101.3481	-42.4442	-0.4657E-04
160.0000	0.0998	86.4976	-33.3226	-0.4455E-04
201.6129	0.0704	47.6977	-20.3789	-0.5856E-04
403.2374	0.0498	25.3962	-12.2504	-0.5233E-04
806.5523	0.0351	10.3631	-7.9871	-0.2462E-04
1612.8914	0.0314	8.3449	-7.2569	-0.2171E-04
1512.2076	0.0237	3.6483	-6.9753	-0.1509E-04
2029.5200	0.0221	4.4309	-6.7278	-0.1166E-04

G = 0.24221E 04 N = 0.79574E 04  
XXXXXXXXXXXX STOP XXXXXXXXXXXX



Table 6-15. Computer Output for Electric and Dielectric Data of Basalt Sample K<sub>1</sub> Pretreated in 5% NaOH for 23 Hours

ENTER NS,ADD PUT SSW1 UP FOR ELECTRODE CORRECTION  
#00.05916

K1 9/20/71 SPC AOD= 0.03916 PHASE AND AMPLITUDE CORRECTED

FRQ	RS	XS	RAOD	XAOD	PH1	Z	ZADD
1.0004	-157.195W	102.5416	-0.1537	4.0077	146.9445	187.3732	7.3454
2.0009	-113.000W	125.4922	-0.4285	4.9143	132.0533	168.9293	6.6153
4.0021	-41.4929	120.4851	-1.0209	4.7182	109.0108	127.4297	4.0901
8.0030	22.2226	88.1223	0.0702	3.4589	75.8519	90.8812	3.5589
16.0042	56.793W	73.1545	1.4448	2.8659	63.2983	81.8681	5.2060
20.0049	58.5265	20.9186	2.2919	1.1325	26.2964	65.2812	2.5364
40.0098	35.711W	-4.2177	2.1816	-0.1652	-4.3297	55.8704	2.1879
80.0196	30.7504	-20.5966	1.5178	-0.0066	-27.9887	43.8911	1.7188
160.0392	31.5991	-22.5054	1.2202	-0.0812	-35.6393	38.6231	1.3123
200.0490	16.5455	-19.4906	0.6478	-0.7633	-49.6791	25.5659	1.0011
400.0980	7.9445	-13.1213	0.5113	-0.5138	-58.7979	15.3410	0.6000
800.1960	4.2702	-7.6000	0.1675	-0.2976	-60.6283	8.7214	0.2833
1600.3920	3.6688	-6.2931	0.1457	-0.2464	-59.7629	7.2845	0.2063
3200.7840	5.5592	-4.0508	0.1515	-0.1589	-50.3916	3.2606	0.1640
6401.5680	2.8229	-5.1213	0.1105	-0.1222	-47.8771	4.2004	0.1640

RS, XS CIRCLE FIT RESULTS- CIRCLE CENTER = 875.9071 1090.9680  
RADIUS = 1378.3042  
FIT = 2.4599

RH= 1716.2319 RINF= 51.5825

MODEL PARAMETERS - R1 = 5550.2773/FRQ  
RP = 1084.6497

RHO = 0.67200E 10 OHM-CM

CP= 0.469270E-05

TAU= 12.93616MSEC

EP=1101.00794

EINF= 21.74922

FRQ	EP	EPP
1.0004	0.929929E 05	0.140000E 05
2.0009	0.854565E 05	0.169344E 05
4.0021	0.765252E 05	0.180274E 05
8.0030	0.665850E 05	0.196125E 05
16.0042	0.552595E 05	0.197575E 05
20.0049	0.527705E 05	0.195550E 05
40.0098	0.420525E 05	0.184925E 05
80.0196	0.541651E 05	0.167350E 05
160.0392	0.516118E 05	0.160910E 05
200.0490	0.246400E 05	0.158590E 05
400.0980	0.191605E 05	0.115827E 05
800.1960	0.149090E 05	0.943866E 04
1600.3920	0.157641E 05	0.879491E 04
3200.7840	0.119295E 05	0.769576E 04
6401.5680	0.107955E 05	0.696751E 04

DET. G, H FOR R1=G/FHNN

RS, XS CIRCLE FIT RESULTS- CIRCLE CENTER = 89.7714 35.8754  
RADIUS = 95.9456  
FIT = 1.1576

RH= 178.7581 RINF= 0.7846

MODEL PARAMETERS - R1 = 16416.9433/FRQ  
RP = 177.9736

F	F-1/2	K1	XP	CP
1.0004	0.9980	2359.8872	-1195.3615	-0.1326E-05
2.0009	0.7050	2139.8452	-860.5085	-0.9208E-04
4.0021	0.4987	1505.1824	-586.4468	-0.6740E-04
8.0030	0.3529	975.3585	-579.8451	-0.3218E-04
16.0042	0.3156	824.8989	-327.5205	-0.4550E-04
20.0049	0.2227	473.8910	-212.9669	-0.5705E-04
40.0098	0.1577	508.5551	-135.6855	-0.2960E-04
80.0196	0.1116	295.5284	-81.2527	-0.2441E-04
160.0392	0.0990	176.3287	-67.5950	-0.2345E-04
200.0490	0.0794	109.5883	-50.3949	-0.2050E-04
400.0980	0.0490	62.6180	-21.5471	-0.1859E-04
800.1960	0.0352	30.5905	-12.0024	-0.1647E-04
1600.3920	0.0251	25.4178	-9.9496	-0.1500E-04
3200.7840	0.0256	15.5512	-7.4479	-0.1410E-04
6401.5680	0.0221	9.0077	-5.9746	-0.1313E-04

G= 0.40225E 04 No 0.73464E 04  
XXXXXXXXXX STOP XXXXXXXXXXXX

Table 6-16. Computer Output for Electric and Dielectric Data of Basalt Sample K<sub>2</sub> Pretreated in 5% NaOH for 23 Hours

ENTER NS,AUD PUT SSW1 UP FOR ELECTRODE CORRECTION  
M87.06184

K2 9/28/71 5PC ADD= 0.06184 PHASE AND AMPLITUDE CORRECTED

FRQ	RS	XS	RADD	XADD	PHI	Z	ZAOD
1.0003	-58.0750	57.5107	-3.6285	3.5565	135.5841	82.1599	5.0800
2.0017	-20.9002	03.1007	-1.6639	3.9026	113.0991	68.6050	4.2425
4.0029	9.2421	54.0287	0.5715	3.3782	80.4035	55.4050	3.4262
8.0045	35.9742	31.0350	2.2246	1.9687	41.5107	40.0301	2.9707
16.0082	40.2602	23.9011	2.4902	1.4018	30.7565	45.8579	2.8977
20.0129	43.2346	2.6133	2.6736	0.1616	3.4593	4.3136	2.6785
40.0257	35.9017	-11.0715	2.2202	-0.7341	-18.2907	37.0135	2.3384
80.0514	23.7954	-17.1604	1.4715	-1.0617	-35.0131	29.3423	1.8145
160.1028	19.0201	-16.9979	1.2133	-1.0512	-40.9071	25.9592	1.6053
200.1342	10.0314	-13.3597	0.6203	-0.8262	-53.1021	16.7066	1.0331
400.2684	5.0100	-8.6320	0.3099	-0.5330	-59.8695	9.9810	0.6172
800.5368	2.7789	-4.9539	0.1710	-0.3064	-60.7147	5.6001	0.3513
1600.1073	2.4226	-4.0054	0.1498	-0.2526	-59.3365	4.7497	0.2937
1512.288	2.1869	-2.6422	0.1352	-0.1634	-50.3896	3.4298	0.2121
2018.349	1.8420	-2.0604	0.1139	-0.1274	-40.2071	2.7637	0.1709

RS, XS CIRCLE FIT RESULTS- CIRCLE CENTER = 292.4046 301.6920  
RADIUS = 407.3560  
FIT = 4.7200

RM = 566.1212 RINF = 18.6080

MODEL PARAMETERS - R1 = 5095.1404/FRQ  
RP = 547.4332

RHO = 0.35009E 10 OHM-CM

CP = 0.831733E-05

TAU = 0.77022MSEC E0 = 0.0254005 EINF = 21.87005

FRQ	EP	EPP
1.0003	0.565052E 03	0.705028E 02
2.0017	0.531279E 03	0.607085E 02
4.0029	0.487012E 03	0.502378E 02
8.0045	0.435413E 03	0.411512E 02
16.0082	0.417345E 03	0.311014E 02
20.0129	0.350007E 03	0.123474E 02
40.0257	0.294257E 03	0.121426E 02
80.0514	0.236360E 03	0.112613E 02
160.1028	0.210051E 03	0.100508E 02
200.1342	0.171212E 03	0.930731E 01
400.2684	0.132473E 03	0.777092E 01
800.5368	0.103339E 03	0.622100E 01
1600.1073	0.054363E 02	0.575296E 01
1512.288	0.029145E 02	0.496109E 01
2018.349	0.752028E 02	0.444619E 02

DET. G, H FOR R1=G/FRQH

RS, XS CIRCLE FIT RESULTS- CIRCLE CENTER = 148.3072 62.1715  
RADIUS = 159.8024  
FIT = 1.3705

RM = 295.0000 RINF = 1.0078  
MODEL PARAMETERS - R1 = 11225.9102/FRQ  
RP = 294.5907

F	F-1/2	R1	XP	CP
1.0027	0.9900	2029.2903	-98.7141	-0.1618E-03
2.0073	0.7041	1077.2017	-0.71192	-0.1176E-03
4.0293	0.4902	1005.0247	-439.7712	-0.8982E-04
8.0451	0.3526	642.1090	-279.4043	-0.7079E-04
16.0820	0.3162	539.0024	-240.3228	-0.6021E-04
20.1208	0.2229	313.0195	-152.0530	-0.5200E-04
40.2453	0.1577	206.0049	-94.1023	-0.4201E-04
80.4908	0.1116	139.6407	-55.0460	-0.3551E-04
160.9816	0.0996	120.7905	-46.4130	-0.3405E-04
201.3423	0.0704	76.4019	-26.8541	-0.2944E-04
402.6846	0.0490	44.5304	-15.0485	-0.2631E-04
805.3692	0.0352	22.9930	-8.2708	-0.2389E-04
1610.7384	0.0315	17.7110	-6.7862	-0.2328E-04
1512.2876	0.0257	10.9527	-4.0015	-0.2150E-04
2018.3400	0.0222	7.1653	-3.7649	-0.2095E-04

G = 0.29328E 04 N = 0.73400E 00  
\*\*\*\*\* STOP \*\*\*\*\*

Table 6-17. Computer Output for Electric and Dielectric Data of Basalt Sample K<sub>4</sub> Pretreated in 5% NaOH for 23 Hours

ENTER NS,ADD PUT SSM1 UP FOR ELECTRODE CORRECTION  
 00.12317

K4 9/20/71 3PC		ADD= 0.12317		PHASE AND AMPLITUDE CORRECTED			
FRQ	R3	XS	RADD	XADD	PH1	Z	ZADD
1.007	-11.1069	23.8777	-1.3779	3.1874	113.3871	28.1923	3.4724
2.012	0.4092	24.8411	0.7894	3.0397	73.3383	23.6346	3.1399
4.023	20.3482	17.6013	2.3309	2.1679	40.3839	27.0361	3.3323
8.036	27.4643	3.8038	3.3828	0.7149	11.9332	28.0709	3.4373
16.044	27.3324	2.4336	3.3936	0.3000	3.0321	27.6398	3.4069
20.137	24.3600	-3.3920	3.0004	-0.6661	-12.4819	24.9496	3.0730
40.290	18.3064	-9.9308	2.2348	-1.2232	-28.4810	20.8263	2.3632
80.386	11.2623	-10.3699	1.3872	-1.2773	-42.6409	13.3003	1.8836
160.604	9.2219	-9.6970	1.1339	1.1944	-46.4420	13.3819	1.6482
201.804	4.0404	-7.1321	0.3962	-0.8809	-33.9149	8.6361	1.0637
402.376	2.3009	-4.4766	0.3000	-0.3314	-60.8136	3.1278	0.6316
809.333	1.4196	-2.3434	0.1749	-0.3133	-60.8334	2.9143	0.3390
1611.030	1.2394	-2.0973	0.1331	-0.2303	-39.0199	2.4463	0.3013
1313.131	1.1229	-1.3360	0.1303	-0.1670	30.3769	1.7606	0.2168
2033.272	0.9400	-1.0701	0.1168	-0.1318	-48.4673	1.4296	0.1761

RS, XS CIRCLE FIT RESULTS- CIRCLE CENTER = 10.6066 9.9038  
 RADIUS = 17.8203  
 FIT = 19.4934

K0 = 23.4204 RINF = -4.2071

MODEL PARAMETERS - R1 = 7409.3781/FRQ  
 KP = 29.6273

KHO = 0.31310E 09 OHM-CM

CP = 0.113070E-04

TAU = 0.41012MSEC E0 = -89.42803 EINF = 14.80070

FRQ	EP	EPP
1.007	-0.073324E 02	-0.204368E 01
2.012	-0.062493E 02	-0.310231E 01
4.023	-0.043742E 02	-0.467005E 01
8.036	-0.020664E 02	-0.604519E 01
16.044	-0.010223E 02	-0.786209E 01
20.137	-0.760130E 02	-0.113713E 02
40.290	-0.700391E 02	-0.130343E 02
80.386	-0.627614E 02	-0.208283E 02
160.604	-0.396619E 02	-0.224093E 02
201.804	-0.407320E 02	-0.264094E 02
402.376	-0.366619E 02	-0.270393E 02
809.333	-0.243302E 02	-0.260473E 02
1611.030	-0.209072E 02	-0.248943E 02
1313.131	-0.147940E 02	-0.223260E 02
2033.272	-0.107934E 02	-0.202369E 02

DET. G,N FOR R1=G/FRQ

R3, X3 CIRCLE FIT RESULTS- CIRCLE CENTER = 138.6480 70.6484  
 RADIUS = 173.7294  
 FIT = 0.3396

K0 = 317.3637 RINF = -0.0077

MODEL PARAMETERS - R1 = 7400.2031/FRQ  
 KP = 317.4313

F	F-1/2	R1	XP	CP
1.0073	0.9964	1396.2349	-713.0491	-0.2207E-03
2.0122	0.7030	1131.0634	-478.0938	-0.1632E-03
4.0240	0.4983	607.4030	-306.6374	-0.1290E-03
8.0360	0.3328	410.7403	-192.0294	-0.1031E-03
16.0442	0.3133	339.3662	-164.6032	-0.9622E-04
20.1369	0.2220	217.9590	-102.3693	-0.7721E-04
40.2901	0.1373	142.2237	-62.3217	-0.6339E-04
80.3839	0.1113	92.1638	-36.9969	-0.3332E-04
160.6036	0.0997	79.2181	-30.7379	-0.3144E-04
201.8042	0.0703	46.8037	-17.6424	-0.4469E-04
402.3764	0.0498	24.9922	-10.0018	-0.3921E-04
809.3323	0.0331	11.3314	-3.8776	-0.3346E-04
1611.0293	0.0314	8.7587	-4.9384	-0.3180E-04
1313.1314	0.0236	3.8049	-3.0378	-0.2723E-04
2033.2720	0.0221	3.6838	-3.3079	-0.2324E-04

G = 0.21394E 04 N = 0.77079E 00  
 \*\*\*\*\* STOP \*\*\*\*\*

Table 6-18. Computer Output for Electric and Dielectric Data of Basalt Sample K<sub>1</sub> Pretreated in 10% NaOH for 23 Hours

ENTER NS,AOD PUT 55W1 UP FOR ELECTRODE CORRECTION  
#89. #5916

K1 9/29/71 18PC

AOD= #.5916

PHASE AND AMPLITUDE CORRECTED

FRQ	RS	XS	RAOD	XAOD	PH1	Z	ZAOD
1.000	59.4852	6.9586	2.5294	0.2722	6.6651	59.8899	2.3453
2.010	41.5985	18.1095	1.6298	0.7892	23.5272	45.3893	1.7767
4.018	46.4519	21.7561	1.8185	0.8520	25.1877	51.2762	2.0880
8.026	50.5688	16.7120	2.2152	0.6544	16.4598	58.0038	2.5090
16.050	58.2242	13.5717	2.2861	0.3315	13.1220	59.7850	2.9418
20.155	60.9485	0.0402	2.3867	0.0013	0.0378	60.9485	3.3867
40.258	55.6060	-15.9153	2.1775	-0.6252	-15.9712	57.8383	2.5849
80.257	48.5458	-25.3645	1.5877	-0.9953	-32.0527	47.8243	1.8728
160.402	55.5752	-25.8068	1.5069	-1.0106	-37.7168	42.1872	1.6521
202.156	0.0000	-21.6983	0.6667	-0.8496	-51.8757	87.3736	1.0790
405.877	0.1538	-14.1124	0.5195	-0.5526	-59.9862	16.2986	0.6383
806.452	4.6554	-7.0564	0.1815	-0.5877	-59.4671	9.1219	0.3870
1605.484	5.8574	-6.5246	0.1583	-0.2555	-59.5426	7.5694	0.2964
1518.027	3.2261	2.6455	0.1265	-0.1836	59.3558	4.1722	0.1634
2029.520	2.9661	-5.1608	0.1162	-0.1258	-46.8235	4.5545	0.1697

RS,XS CIRCLE FIT RESULTS- CIRCLE CENTER = 51.8407 -0.4295  
RADIUS = 27.5527  
FIT = 0.0840

R# = 59.5980 RINF = 4.2994

MODEL PARAMETERS - R1 = 216537.6875/FRQ  
RP = 55.0986

RHO = 0.2526/E #9 UHM-CM

CP = 0.7776/E-#5

TAU = 0.4285/MSEC E# = 287.57928 EINF = 20.81576

FRQ	EP	EPP
1.000	0.28682E #5	0.76171E #0
2.010	0.28606E #5	0.15196E #1
4.018	0.28459E #5	0.50163E #1
8.026	0.28172E #5	0.59798E #1
16.050	0.28029E #5	0.74741E #1
20.155	0.27347E #5	0.14825E #2
40.258	0.26972E #5	0.29096E #2
80.257	0.25930E #5	0.55467E #2
160.402	0.25005E #5	0.67411E #2
202.156	0.19319E #5	0.11808E #5
405.877	0.14867E #5	0.15087E #5
806.452	0.10557E #5	0.10658E #5
1605.484	0.95293E #2	0.86470E #2
1518.027	0.75845E #2	0.61895E #2
2029.520	0.62675E #2	0.47716E #2

DET. G,N FOR R1=G/FMHN

RS,XS CIRCLE FIT RESULTS- CIRCLE CENTER = 75.9658 42.4923  
RADIUS = 80.0766  
FIT = 1.6498

R# = 155.1117 RINF = -1.1841

MODEL PARAMETERS - R1 = 13460.5059/FRQ  
RP = 154.2958

F	F-1/2	R1	XP	CP
1.0005	0.9999	2711.5076	-1151.9424	-0.1581E-#5
2.0097	0.7054	1061.2422	-458.9255	-0.9440E-#4
4.0177	0.4989	1054.4907	-573.8958	-0.6093E-#4
8.0237	0.5550	667.6863	-374.6154	-0.5294E-#4
16.0505	0.5155	585.9577	-522.9716	-0.4899E-#4
20.1552	0.2228	558.5120	-216.9011	-0.5745E-#4
40.2576	0.1576	247.5275	-154.5000	-0.2959E-#4
80.2568	0.1116	189.1596	-82.7553	-0.2596E-#4
160.4016	0.0994	145.6857	-68.9052	-0.2501E-#4
202.1564	0.0785	99.7404	-39.8980	-0.1973E-#4
405.8772	0.0497	49.0474	-23.1757	-0.1700E-#4
806.4517	0.0552	22.8451	-14.0006	-0.1402E-#4
1605.4844	0.0515	17.9178	-12.1758	-0.1500E-#4
1518.0269	0.0256	11.5225	-10.5571	-0.1014E-#4
2029.5200	0.0221	8.2850	-9.6710	-0.8109E-#5

G = 0.52225E #4 N = 0.75407E #0  
\*\*\*\*\* STOP \*\*\*\*\*

Table 6-19. Computer Output for Electric and Dielectric Data of Basalt Sample K<sub>2</sub> Pretreated in 10% NaOH for 23 Hours

ENTER NS,AOD PUT SSWI UP FOR ELECTRODE CORRECTION  
 #9#.#6184

K2 9/29/71 1#PC

ADD= #.#6184

PHASE AND AMPLITUDE CORRECTED

FRQ	RS	XS	RAOD	XAOD	PHI	Z	ZADD
1.#9#	6.212#	15.4181	#.5842	#.8298	65.16#	14.7866	#.9144
2.#24	13.2251	17.4562	#.8178	1.#783	52.8242	21.8844	1.5533
4.#54	21.2575	19.1558	1.3146	1.1846	42.8262	28.6152	1.7696
8.#53	31.8477	14.29#	1.9548	#.8837	24.55#	34.3969	2.1271
9.99#	53.9513	1#.#775#	2.#985	#.6662	17.6156	35.6#4	2.2#13
2#.#145	36.5922	#.#66	2.2629	#.#6#4	#.#1#3	36.5922	2.2629
4#.#29#	52.6115	-9.8252	2.#167	-#.#6#76	-16.7677	34.#594	2.1#62
8#.#86	25.2928	-14.9661	1.44#4	-#.#9255	-52.724#	27.6865	1.7121
1#.#4#2	19.5869	-15.1233	1.2115	-#.#9552	-37.6749	16.5648	1.5393
2#2.156	1#.#285	-12.6937	#.6387	-#.#785#	-5#.#8695	9.9#73	#.612#
4#5.226	5.256#	-8.3981	#.329#	-#.#5193	-57.9655	5.6697	#.35#6
8#7.#99	5.#1#6	-4.#845	#.1862	-#.#2971	-57.8589	4.7161	#.2916
1#11.#5#	2.5#95	-3.9951	#.1552	-#.#1726	-53.32#2	5.48#6	#.2152
151#.#27	2.#795	-2.7915	#.1286	-#.#1194	-44.1447	2.7727	#.1715
2#57.#37	1.9898	-1.951#	#.125#				

RS, XS CIRCLE FIT RESULTS- CIRCLE CENTER = 19.1747 1.7855  
 RADIUS = 17.3574  
 FIT = 1.64#8

R# = 56.44# RINF = 1.9#95  
 MODEL PARAMETERS - R1 = 55#88.8125/FRQ  
 RP = 34.53#7

RHO = #.22555E #9 UHM-CM

CP = #.314665E-#4

TAU = 1.#92551#SEC E# = 1#45.56743 EINF = 54.77335

FRQ	EP	EPP
1.#9#	#.1#56#8E #4	#.955844E #1
2.#24	#.1#2757E #4	#.18#5#E #2
4.#54	#.1#12#8E #4	#.541495E #2
8.#53	#.985715E #5	#.6453#6E #2
9.99#	#.97#23E #5	#.786938E #2
2#.#145	#.911#84E #3	#.146728E #3
4#.#29#	#.816773E #5	#.257235E #5
8#.#86	#.684589E #5	#.39#6#4E #5
1#.#4#2	#.6556#5E #5	#.425246E #5
2#2.156	#.474686E #5	#.42859#E #5
4#5.226	#.35#54#E #5	#.5#9787E #5
8#7.#99	#.22#62#E #5	#.18575#E #3
1#11.#5#	#.195625E #5	#.152#54E #5
151#.#27	#.154113E #3	#.1#65#7E #3
2#57.#37	#.152#91E #3	#.817719E #2

DET. G, H FOR R1=G/FH#N

RS, XS CIRCLE FIT RESULTS- CIRCLE CENTER = 62.9858 19.9821  
 RADIUS = 64.4255  
 FIT = 4.8657

R# = 124.251# RINF = 1.7547  
 MODEL PARAMETERS - R1 = 1#62#.#582#/FRQ  
 RP = 122.4922

F	F-1/2	K1	XP	CP
1.#9#	#.9999	668.8#57	-67#.#45#	-#.#2574E-#5
2.#24	#.7#28	2265.1558	-49#.#1249	-#.#1589E-#5
4.#54	#.49#5	1482.4895	-53#.#258#	-#.#1169E-#5
8.#53	#.5528	757.4973	-22#.#5851	-#.#899#E-#4
9.99#	#.5164	654.99#6	-192.#256	-#.#8297E-#4
2#.#145	#.2228	358.7#12	-125.484#	-#.#6398E-#4
4#.#29#	#.1575	2#2.8852	-77.3645	-#.#51#6E-#4
8#.#86	#.1115	13#.#2266	-46.863#	-#.#4225E-#4
1#.#4#2	#.#998	11#.#1134	-59.6155	-#.#4#82E-#4
2#2.156	#.#7#3	7#.#751	-23.#775	-#.#3412E-#4
4#5.226	#.#498	45.6954	-15.#775	-#.#3#18E-#4
8#7.#99	#.#351	26.8472	-7.#727	-#.#2785E-#4
1#11.#5#	#.#114	22.7199	-5.7318	-#.#2746E-#4
151#.#27	#.#256	14.984#	-3.9569	-#.#265#E-#4
2#57.#37	#.#221	1#.#717	-2.#797	-#.#2713E-#4

G = #.25459E #4 N = #.66952E ##  
 \*\*\*\*\* STOP \*\*\*\*\*

Table 6-20. Computer Output for Electric and Dielectric Data of Basalt Sample K<sub>4</sub> Pretreated in 10% NaOH for 23 Hours

```

ENTER NS,AUD PUT SSW1 UP FOR ELECTRODE CORRECTION
#91.12317

K4 9/29/71 1MPC ADD= #.12317 PHASE AND AMPLITUDE CORRECTED

FRQ RS XS RAOD XADD PH1 Z ZADD
1.#1 -9.9475 1#622# -1.2232 1.3#03 133.1316 14.3327 1.7923
2.#16 #.3441 11.2683 #.0423 1.3#79 88.2373 11.2733 1.3886
4.#32 7.1366 11.9394 #.0813 1.4756 39.#634 13.92# 1.7143
8.#39 13.7#39 8.7#49 1.6879 1.#722 32.4263 16.2349 1.9997
1#.#42 13.8#34 6.3483 1.9468 #.7#19 21.8843 17.#327 2.8979
2#129 17.3382 -#.#439 2.16#2 -#.#33 -#.#131 17.3383 2.16#2
4#238 13.2932 -4.7#33 1.8839 -#.#892 -17.3673 16.#237 1.9759
8#313 1#6617 -7.1398 1.3132 -#.#794 -33.8114 12.8313 1.38#3
1#.#33 9.1638 -7.#432 1.1207 -#.#673 -37.3483 11.3378 1.4236
2#1.613 4.99#4 -3.9232 #.6147 -#.#296 -49.8888 7.7432 #.934#
4#2.376 2.6843 -3.9796 #.33#6 -#.#982 -36.#34 4.8#3 3.912
8#7.499 1.3431 -2.3423 #.19#1 -#.#283 -36.6267 2.8#49 #.3433
1#11.#3# 1.2926 -1.9494 #.1392 -#.#24#1 -32.1184 1.7247 #.2881
132#.#13 1.#391 -1.3612 #.13#4 -#.#1677 -41.899# 1.4#61 #.1732
2#22.#39 1.#466 -#.#939# #.1289 -#.#1137 -41.899# 1.4#61 #.1732

RS,XS CIRCLE FIT RESULTS- CIRCLE CENTER = 21.9436 39.#331
RADIUS = 42.#324
FIT = 14.4431

R# = 37.4883 RINF = 6.4#27

MOUEL PARAMETERS - R1 = 2733.7339/FRQ
RP = 31.#838

RHU = #.46173E #9 UHM-CM
CP = #.2#3112E-#4
TAU = 1.7#743MSEC E# = 244.64394 EINF = 41.78333

FRQ EP EPP
1.#1 #.2#9413E #3 #.144887E #2
2.#16 #.2#2122E #3 #.137#84E #2
4.#32 #.193743E #3 #.1682#4E #2
8.#39 #.1#41#E #3 #.177835E #2
1#.#42 #.1#8#77E #3 #.1#8388E #2
2#129 #.1#9#67E #3 #.1877#3E #2
4#238 #.138#86E #3 #.192376E #2
8#313 #.143829E #3 #.194364E #2
1#.#33 #.141871E #3 #.194411E #2
2#1.613 #.12934E #3 #.192694E #2
4#2.376 #.117717E #3 #.18829#E #2
8#7.499 #.1#6393E #3 #.181388E #2
1#11.#3# #.1#3224E #3 #.178697E #2
132#.#13 #.9738#E #2 #.173286E #2
2#22.#39 #.933395E #2 #.169162E #2

DET. G,N FOR R1=G/FMMN

RS,XS CIRCLE FIT RESULTS- CIRCLE CENTER = 76.9643 3#.#73
RADIUS = 82.2643
FIT = #.8112

R# = 133.4#27 RINF = #.5263

MOUEL PARAMETERS - R1 = 6763.3833/FRQ
RP = 132.#764

F F-1/2 R1 XP CP
1.#1# #.9993 1279.766# -37#.#14# -#.#27#3E-#3
2.#16# #.7#43 983.9623 -38#.#86# -#.#2#34E-#3
4.#316 #.49# 679.4182 -236.1473 -#.#1341E-#3
8.#386 #.3327 411.3#93 -163.1936 -#.#1213E-#3
1#.#422 #.313# 347.7717 -14#.#359# -#.#1128E-#3
2#128# #.2229 199.3332 -87.6288 -#.#9#23E-#4
4#237# #.137# 129.12#1 -33.9399 -#.#7329E-#4
8#5133 #.111# 83.8437 -32.3#43 -#.#6119E-#4
1#.#3#23 #.8997 72.778# -26.9#71 -#.#3886E-#4
2#1.6129 #.#7#4 44.327# -13.3813 -#.#3#66E-#4
4#2.3764 #.#9# 23.4143 -8.7#77 -#.#4499E-#4
8#7.8994 #.#331 12.9489 -4.8#48 -#.#4#33E-#4
1#11.#293 #.#314 9.9692 -4.#292 -#.#397E-#4
132#.#126 #.#236 3.9#26 -2.9726 -#.#332E-#4
2#22.#391 #.#222 4.4384 -2.2127 -#.#3557E-#4

G = #.1831#E #4 N = #.74494E #9
##### STOP #####

```

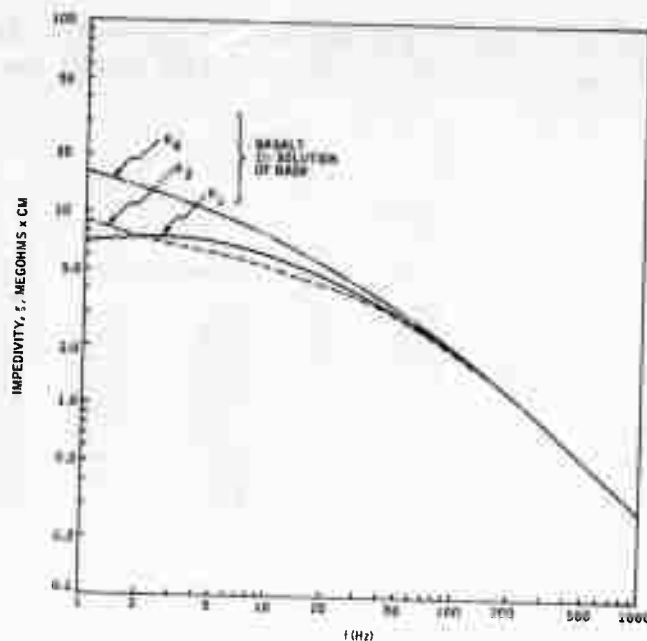


Figure 6-5. Variation of Impedivity with Frequency for the Basalt Samples after 23-hour Pretreatment in 1% NaOH

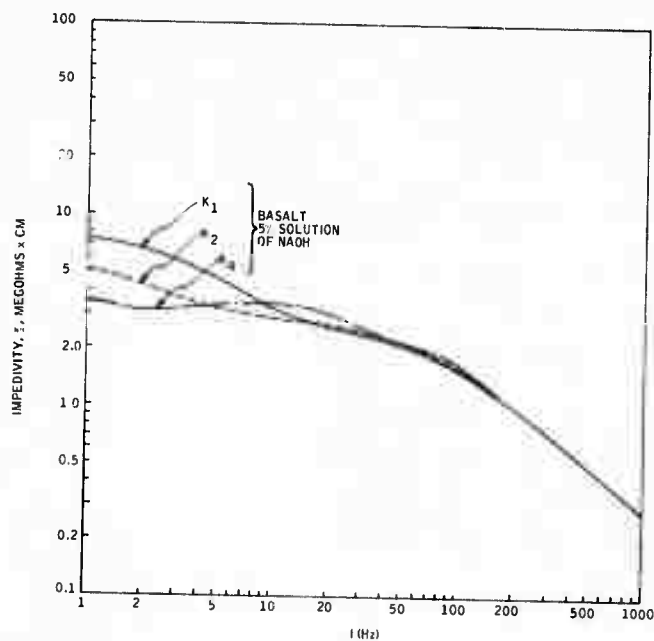


Figure 6-6. Variation of Impedivity with Frequency for Basalt Samples Following a 23-hour Pretreatment in 5% NaOH

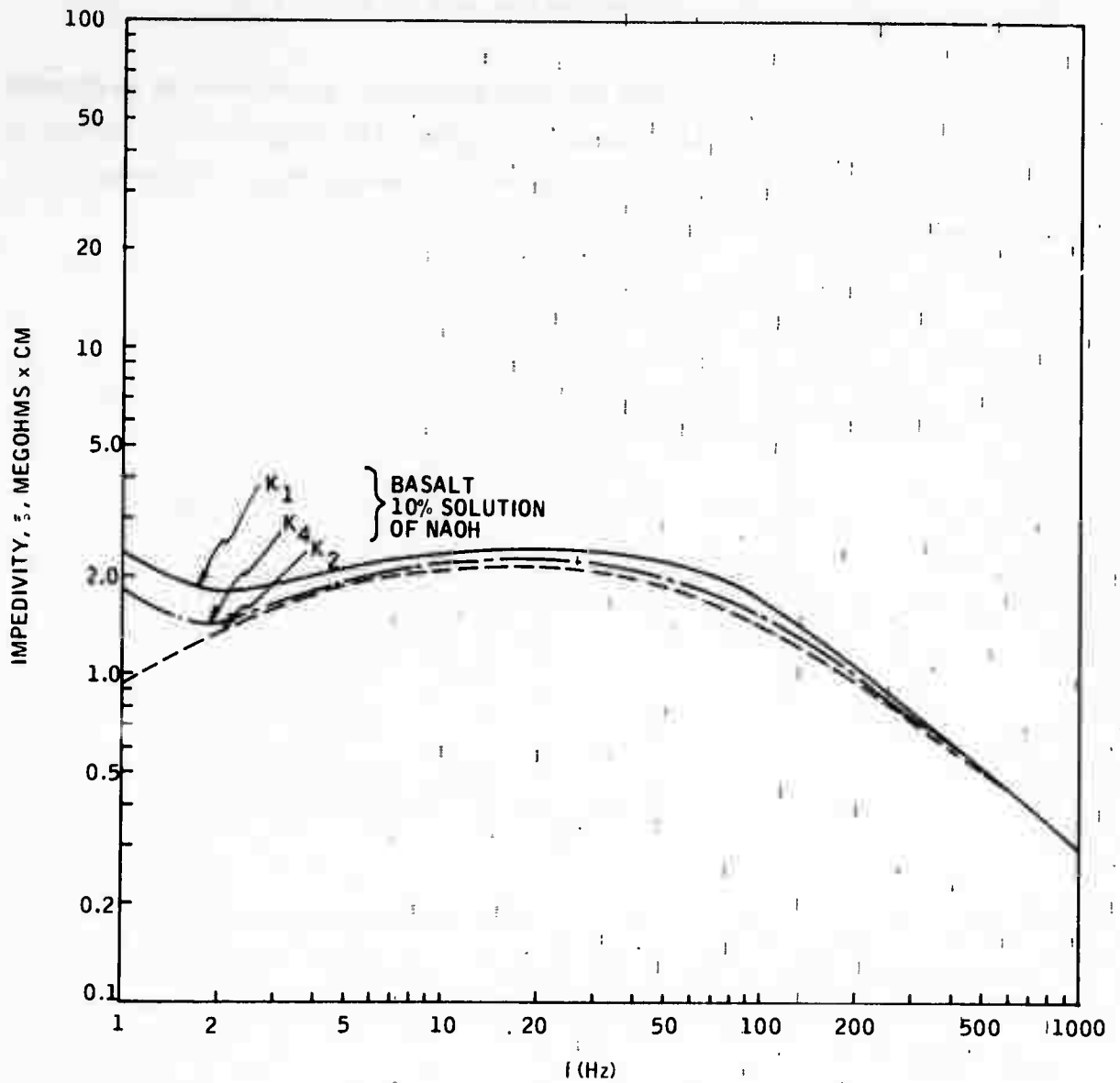


Figure 6-7. Variation of Impedivity with Frequency for Basalt Samples Following a 23-hour Pre-treatment in 10% NaOH



The effect of sodium hydroxide concentration on the impeditivity at 1 Hz for the three basaltic rocks is shown by the data in Table 6-21.

The plot of impeditivity against the concentration,  $c$ , of sodium hydroxide in the pretreating solution is shown in Figure 6-8. Apparently, impeditivity decreases exponentially with the electrolyte concentration following an equation of the form

$$\xi = \xi_0 e^{-\lambda c}$$

Table 6-21. Effect of Pretreatment in NaOH for 23 Hours

Conc. of NaOH	Impeditivity at 1 Hz, Megohm cm		
	$K_1$	$K_2$	$K_4$
0	11.0	19.0	27.0
1	7.0	9.0	16.5
5	7.4	5.0	3.5
10	2.4	0.9	1.8

The plots of  $\log \xi$  against  $c$  for the three basalt cylindrical rocks are shown in Figure 6-9. The slopes of the lines in this figure allow a determination of the constant  $\lambda$  for each cylindrical rock. Table 6-22 gives these straight-line parameters.

It is interesting to note from these limited number of data points that the coefficient  $\lambda$  decreases linearly with increasing rock length, providing that the rocks are of the same cross sectional area. The variation of  $\lambda$  with  $d$  is shown in Figure 6-10 and indicates a significant dependence of the rock impeditivity decay constant due to electrolyte impregnation with the length of the rock samples.

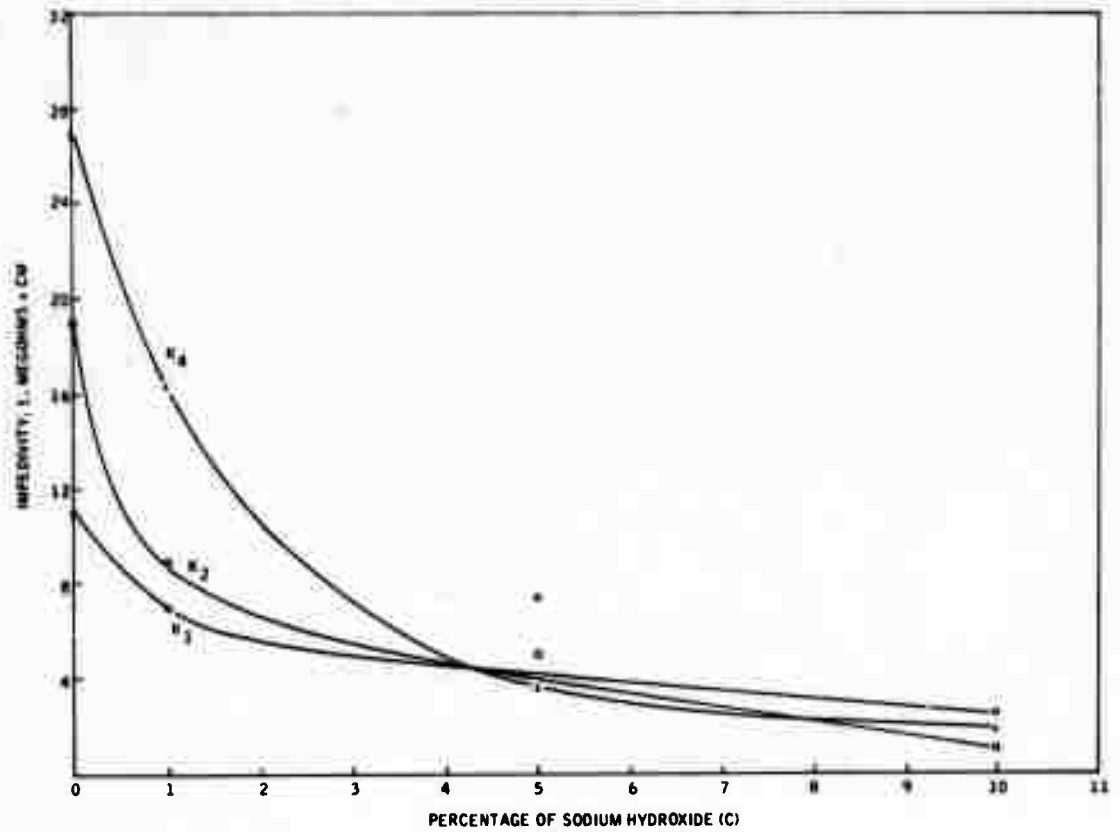


Figure 6-8. Variation of Impedivity with Sodium Hydroxide Concentration in the Pretreating Solution

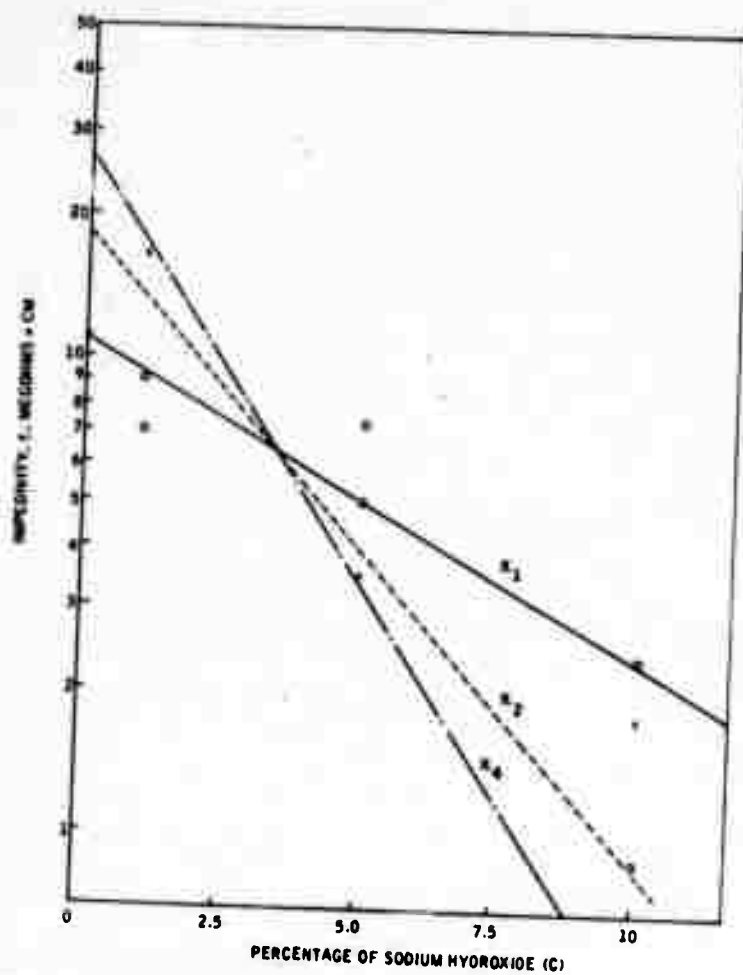


Figure 6-9. Semilogarithmic Plot of Basalt Impedivity with Concentration of Sodium Hydroxide in the Pretreating Solution

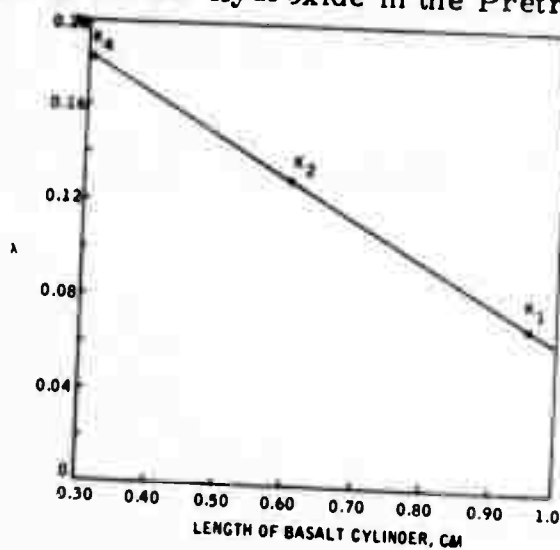


Figure 6-10. Variation of Parameter  $\lambda$  with Rock Thickness

Table 6-22. Exponential Decrease of Impedivity with Electrolyte Concentration

Length of Rock Cylinder, d, cm	$\xi_o$ (megohm)(cm)	$\lambda$ (ml. gm <sup>-1</sup> )
0.956	11	0.07
0.605	19	0.13
0.304	27	0.18

#### EFFECT OF WATER SOAKING ON QUARTZ ELECTRIC PARAMETERS

Three quartz (II) disc samples were cut from one cylinder with lengths 0.31, 0.61, and 0.92 cm and are designated M1, M2, and M3, respectively. These samples had a cross sectional area over length (A/d) ratio of 0.122, 0.061, and 0.041 meter, respectively. The samples were pretreated in distilled water, once for 24 hours and another time for 75 hours. After each pretreatment, the rock was dried in an 80°C oven for two hours before the electrodes were applied and measurements were taken. Computer output data pertaining to the untreated and water-treated quartz are shown in Tables 6-23 to 6-31.

The variation of the untreated quartz impedivity with frequency is shown in Figure 6-11. Following a 24-hour soak, the same quartz samples gave the impedivity frequency relationships shown in Figure 6-12. When the soaking time was prolonged to 75 hours, the quartz impedivity changed with frequency according to the curves of Figure 6-13.

Table 6-23. Computer Output for Electric and Dielectric Data of Untreated Quartz Sample M<sub>1</sub>

ENTER RS,AUD PUT SW1 UP FOR ELECTRODE CORRECTION  
 #1.12219

M1 1/19/72		AUD= #.12219		PHASE AND AMPLITUDE CORRECTED			
FRQ	RS	XS	RAUD	XAUD	PHI	Z	ZADD
9.990	140.7771	-1#21.3215	10.1791	-124.7953	-81.7180	1032.1008	126.1124
20.050	153.0709	-559.1614	10.7770	-68.3239	-74.6386	579.8932	70.8571
40.000	63.9872	-320.9099	7.8186	-39.9451	-78.9311	333.1132	40.7031
80.000	22.3478	-177.5770	2.7307	-21.6981	-82.8332	178.9777	21.8693
99.900	7.4529	-141.1557	0.9107	-17.2478	-86.9841	141.3524	17.7718
200.535	5.6384	-70.8661	0.6090	-8.6591	-85.4572	71.0901	8.6865
400.641	4.1794	-34.7135	0.5107	-4.2416	-83.1410	34.9642	4.2723
805.009	3.9071	-16.9568	0.4774	-2.0720	-77.0004	17.4011	2.1262
1001.022	4.0005	-13.4710	0.4962	-1.6460	-73.2312	14.0697	1.7192

RS,AS CIRCLE FIT RESULTS- CIRCLE CENTER = 3426.6367 84.7719  
 RADIUS = 3413.4722  
 FIT = 0.9484

R# = 0039.0557 RINF = 14.2173

MODEL PARAMETERS - R1 = 205070.000/FRQ  
 RP = 024.0379

RMD = 0.03500E 11 OHM-CM

CP = 0.907824E-05

TAU = 07.430201SEC E# = 4300.42285 EINP = 9.11866

FRQ	EP	EPP
9.990	0.000020E #3	0.987557E #3
20.050	0.000019E #3	0.521772E #3
40.000	0.000017E #3	0.207748E #3
80.000	0.000015E #3	0.136149E #3
99.900	0.000014E #3	0.109483E #3
200.535	0.000013E #2	0.552051E #2
400.641	0.000012E #2	0.279481E #2
805.009	0.000011E #2	0.140663E #2
1001.022	0.000010E #2	0.113425E #2

DET. 0.0 FOR R1=0/FRQ

RS,AS CIRCLE FIT RESULTS- CIRCLE CENTER = 3426.6367 84.7719  
 RADIUS = 3413.4722  
 FIT = 0.9484

R# = 0039.0557 RINF = 14.2173

MODEL PARAMETERS - R1 = 205070.000/FRQ  
 RP = 024.0379

F	F-1/2	R1	XP	CP
9.9900	0.3163-51493.8510	-1039.0498	-0.1532E-04	
LOG	XXXXXXXXXXXX			

Table 6-24. Computer Output for Electric and Dielectric Data of Untreated Quartz Sample M<sub>2</sub>

ENTER RS,AUD PUT SSN1 UP FOR ELECTRODE CORRECTION  
M11,M0154

M2 1/19/72

AUD =  $\mu$ .M6134

PHASE AND AMPLITUDE CORRECTED

FRQ	RS	XS	KAUD	XAUD	PHI	Z	ZA00
9.976	154.555J	-1557.0934	9.4791	-83.28J9	-83.5126	1366.46J9	83.8186
20.096	230.159J	-740.5276	14.1167	-45.7797	-72.8676	781.0J5J	47.9068
40.161	47.0J6J	-452.839J	5.3569	-27.7771	-79.1299	461.1217	28.2852
100.000	52.5557	-194.3854	1.9846	-11.9236	-80.5562	197.0596	12.0876
202.705	0.4J22	-J5.7117	0.3J82	-5.071J	-86.1259	95.9516	5.8844
402.576	4.9239	-47.047J	0.5J24	-2.8859	-84.0243	47.5054	2.9017
805.572	5.0175	-22.7543	0.3J78	-1.5945	-77.5605	25.2814	1.4281
1001.822	5.0558	-18.018J	0.5J89	-1.1052	-74.39J5	18.7085	1.1476

RS,XS CIRCLE FIT RESULTS- CIRCLE CENTER = 6167.8789 286.3789  
RADIUS = 0155.50J9  
FIT =  $\mu$ .8996

KP = 12514.5918 KINF = 21.166J

MODEL PARAMETERS - R1 = 12312J.562/FRQ  
KP = 12295.4258

R10 =  $\mu$ .75558E 11 ON1=CH

CP =  $\mu$ .095050E-05

TAU = 05.03655HSEC

EW = 7453.05516

EINF = 12.810J9

FRQ	EP	EMP
9.976	$\mu$ .123041E J4	$\mu$ .137741E J4
20.096	$\mu$ .043997E J5	$\mu$ .725779E J5
40.161	$\mu$ .371454E J5	$\mu$ .574J21E J5
100.000	$\mu$ .105047E J3	$\mu$ .155J81E J5
202.703	$\mu$ .905080E J2	$\mu$ .782269E J2
402.576	$\mu$ .528552E J2	$\mu$ .40220J E J2
805.572	$\mu$ .5353J4E J2	$\mu$ .205722E J2
1001.822	$\mu$ .295071E J2	$\mu$ .166103E J2

DET. G,1 FOR R1=G/FRQ

RS,XS CIRCLE FIT RESULTS- CIRCLE CENTER = 6167.8789 286.3789  
RADIUS = 0155.38J9  
FIT =  $\mu$ .8996

KP = 12314.5918 KINF = 21.166J

MODEL PARAMETERS - R1 = 12312J.562/FRQ  
KP = 12295.4258

F	F-1/2	R1	XP	CP
9.9761	$\mu$ .31661J4775.559	-137J.7942	-0.1164E-J4	
LOG	XXXXXXXXXX			

Table 6-25. Computer Output for Electric and Dielectric Data of Untreated Quartz Sample M<sub>2</sub>

ENTER 1/5, AUD PUT 55:1 UP FOR ELECTRODE CORRECTION  
 #12.04002

M3 1/19/72

AUD= 0.04062

PHASE AND AMPLITUDE CORRECTED

FRQ	RS	AS	KAOD	XAOD	PHI	Z	ZAOD
10.052	110.3150	-1573.3510	4.4810	-03.0095	-35.9956	1577.2140	64.0665
20.101	272.3010	-005.5210	11.0041	-35.1575	-72.5365	987.3689	36.8573
40.090	09.1025	-540.7039	4.0208	-21.9634	-79.6115	549.7292	22.3298
100.000	29.1770	-233.1074	1.1052	-9.4721	-82.8740	235.0058	9.5459
200.013	4.5050	-112.0970	0.1062	-4.5059	-87.6808	112.9901	4.5097
400.570	4.3509	-54.9410	0.1771	-2.2317	-85.4702	55.1142	2.2387
805.009	5.1910	-20.3502	0.2100	-1.0703	-78.8613	26.8567	1.0909
1001.022	5.3707	-20.7349	0.2104	-0.8422	-75.4686	21.4206	0.8701

RS, AS CIRCLE FIT RESULTS- CIRCLE CENTER = 8785.5508 299.9439  
 RADIUS = 8764.8477  
 FIT = 0.8574

R0 = 17545.2017 KINF = 25.8379

MODEL PARAMETERS - R1 = 120910.218/FRQ  
 RP = 17519.4219

RHO = 0.71209E 11 OHM-CM

CP = 0.574335E-05

TAU = 100.07910/10LC E0 = 0.10039.257 EINF = 15.96235

FRQ	EP	ERP
10.052	0.153022E 04	0.170024E 04
20.101	0.044004E 03	0.005452E 03
40.090	0.055037E 03	0.055403E 03
100.000	0.199003E 03	0.100902E 03
200.013	0.100419E 03	0.0402073E 02
400.570	0.030792E 02	0.0479120E 02
805.009	0.040242E 02	0.243294E 02
1001.022	0.355727E 02	0.190438E 02

DET. 0.0 FOR R10/FRQ

RS, XS CIRCLE FIT RESULTS- CIRCLE CENTER = 8785.5508 299.9439  
 RADIUS = 8764.8477  
 FIT = 0.8574

R0 = 17545.2017 KINF = 25.8379

MODEL PARAMETERS - R1 = 120910.218/FRQ  
 RP = 17519.4219

F	F-1/2	R1	XP	CP
10.0523	0.3154-43540.0000	-1577.8872	-0.1003E-04	

LOG

Table 6-26. Computer Output for Electric and Dielectric Data of Untreated Quartz Sample M<sub>1</sub> Following a 24-Hour Water Soak

ENTER 145, AUD PUT 3541 UP FOR ELECTRODE CORRECTION  
 000.12219

M1 24HR		AUD 0.12219		PHASE AND AMPLITUDE CORRECTED			
FREQ	AS	AS	RAUD	XAOD	PHI	Z	ZAOD
1.000	1.0000	-0.1394	0.2036	-0.0170	-4.7631	1.6725	0.2043
2.000	1.0323	-0.0672	0.1995	-0.0166	-3.6614	1.6307	0.1997
4.000	1.0649	-0.1144	0.1937	-0.0139	-4.1303	1.5891	0.1946
6.000	1.0951	-0.1362	0.1912	-0.0166	-4.9730	1.5710	0.1920
8.000	1.1230	-0.1712	0.1870	-0.0209	-6.3020	1.5390	0.1681
10.000	1.1484	-0.1643	0.1860	-0.0190	-6.0616	1.5370	0.1676
12.000	1.1710	-0.1643	0.1840	-0.0269	-8.7344	1.4474	0.1769
14.000	1.1910	-0.1643	0.1840	-0.0311	-10.7700	1.3639	0.1669
16.000	1.2081	-0.1643	0.1840	-0.0389	-13.8030	1.3172	0.1609
18.000	1.2241	-0.1643	0.1840	-0.0441	-20.0007	1.1859	0.1449
20.000	1.2381	-0.1643	0.1840	-0.0336	-22.3050	1.0173	0.1203
22.000	1.2501	-0.1643	0.1840	-0.0336	-22.3050	0.7616	0.0935
24.000	1.2601	-0.1643	0.1840	-0.0246	-17.9144	0.6581	0.0804
26.000	1.2681	-0.1643	0.1840	-0.0246	-17.9144	0.6367	0.0802

AS, AS CIRCLE FIT RESULTS- CIRCLE CENTER = 1.0000 0.7206  
 RADIUS = 1.0412  
 FIT = 2.2641

KP = 1.7543 RHP = 0.4490

MODEL PARAMETERS - R1 = 393.0010/FREQ  
 KP = 1.5034

GM = 0.2141E-04 OHM-CM

EP = 0.443035E-03

TIME = 0.11100000 EP = 1.0000E-03 EHP = 269.9696

FREQ	EP	CP
1.000	0.443035E-03	0.574577E-02
2.000	0.443035E-03	0.797303E-02
4.000	0.443035E-03	0.100000E-01
6.000	0.443035E-03	0.100000E-01
8.000	0.443035E-03	0.100000E-01
10.000	0.443035E-03	0.100000E-01
12.000	0.443035E-03	0.100000E-01
14.000	0.443035E-03	0.100000E-01
16.000	0.443035E-03	0.100000E-01
18.000	0.443035E-03	0.100000E-01
20.000	0.443035E-03	0.100000E-01
22.000	0.443035E-03	0.100000E-01
24.000	0.443035E-03	0.100000E-01
26.000	0.443035E-03	0.100000E-01

UET, 0.00 FOR R120/FREQ

AS, AS CIRCLE FIT RESULTS- CIRCLE CENTER = 1.0000 0.7206  
 RADIUS = 1.0412  
 FIT = 2.2641

KP = 1.7543 RHP = 0.4490

MODEL PARAMETERS - R1 = 393.0010/FREQ  
 KP = 1.5034

F	P-174	R1	KP	CP
1.000	0.443035E-03	0.574577E-02	-14.5492	-0.1000E-01
2.000	0.443035E-03	0.797303E-02	-22.0000	-0.1000E-01
4.000	0.443035E-03	0.100000E-01	-25.7000	-0.1000E-01
6.000	0.443035E-03	0.100000E-01	-14.0470	-0.1000E-01
8.000	0.443035E-03	0.100000E-01	-4.7614	-0.1000E-01
10.000	0.443035E-03	0.100000E-01	-10.2475	-0.1000E-01
12.000	0.443035E-03	0.100000E-01	-0.5574	-0.1000E-01
14.000	0.443035E-03	0.100000E-01	-4.9941	-0.1000E-01
16.000	0.443035E-03	0.100000E-01	-3.0441	-0.1000E-01
18.000	0.443035E-03	0.100000E-01	-2.0144	-0.1000E-01
20.000	0.443035E-03	0.100000E-01	-1.7453	-0.1000E-01
22.000	0.443035E-03	0.100000E-01	-1.0139	-0.1000E-01
24.000	0.443035E-03	0.100000E-01	-0.7777	-0.1000E-01
26.000	0.443035E-03	0.100000E-01	-0.9014	-0.1000E-01

GM = 0.2141E-04 OHM-CM  
 EHP = 269.9696



Table 6-27. Computer Output for Electric and Dielectric Data of Untreated Quartz Sample M<sub>2</sub> Following a 24-Hour Water Soak

LISTEN 100,ADD  
003.00139 POT 3001 UP FOR ELECTRODE CORRECTION

104 20014		ADD= 0.00139		PHASE AND AMPLITUDE CORRECTED			
FMU	AS	AS	RAUD	KAOD	PHI	Z	2AOD
1.0000	2.9374	-0.2149	0.1002	-0.0131	-4.1664	2.9432	0.1807
4.0144	2.0346	-0.2155	0.1739	-0.0132	-4.3478	2.0428	0.1794
9.0041	2.7509	-0.2536	0.1075	-0.0136	-3.3407	2.7423	0.1682
0.0041	2.0179	-0.2413	0.1003	-0.0172	-6.1363	2.6321	0.1613
10.0016	2.0106	-0.2750	0.1003	-0.0167	-3.9729	2.6310	0.1614
40.0004	2.0000	-0.3534	0.1003	-0.0218	-8.0733	2.3307	0.1332
90.0000	2.0000	-0.4000	0.1000	-0.0273	-10.0291	2.3094	0.1466
100.0000	2.0317	-0.4253	0.1246	-0.0303	-17.1076	2.1230	0.1304
200.0013	1.0000	-0.7030	0.1053	-0.0431	-2.0097	1.8250	0.1128
400.0040	1.2701	-0.0350	0.0704	-0.0402	-17.1361	1.4565	0.0801
600.0000	0.9271	-0.0070	0.0308	-0.0311	-20.7007	1.0570	0.0640
1000.0000	0.0000	-0.0377	0.0533	-0.0208	-26.7365	0.9731	0.0396
1500.0000	0.0000	-0.0399	0.0427	-0.0200	-23.9998	0.7734	0.0473

NO. 00 CIRCLE FIT RESULTS= CIRCLE CENTER = 1.0430 1.0705  
RADIUS = 1.7403  
FIT = 2.7457

RP = 4.000/ KINF = 0.2000

MODEL PARAMETERS - K1 = 927.1457/FMU  
KP = 2.0932

KIM = 0.1000000000000000

CP = 0.0000000000000000

TAU = 0.0000000000000000 EPP = 0.52441 EINF = 398.43040

FMU	CP	EPP
1.0000	0.0000000000000000	0.1100000000000000
4.0144	0.0000000000000000	0.1000000000000000
9.0041	0.0000000000000000	0.0900000000000000
0.0041	0.0000000000000000	0.0800000000000000
10.0016	0.0000000000000000	0.0700000000000000
40.0004	0.0000000000000000	0.0600000000000000
90.0000	0.0000000000000000	0.0500000000000000
100.0000	0.0000000000000000	0.0400000000000000
200.0013	0.0000000000000000	0.0300000000000000
400.0040	0.0000000000000000	0.0200000000000000
600.0000	0.0000000000000000	0.0100000000000000
1000.0000	0.0000000000000000	0.0000000000000000
1500.0000	0.0000000000000000	0.0000000000000000

ULT. 0.00 FOR K1=0/FMU

NO. 00 CIRCLE FIT RESULTS= CIRCLE CENTER = 1.0430 1.0705  
RADIUS = 1.7403  
FIT = 2.7457

RP = 4.000/ KINF = 0.2000

MODEL PARAMETERS - K1 = 927.1457/FMU  
KP = 2.0932

FMU	CP	EPP	K1	KP	CP
1.0000	0.0000	0.1100	927.1457	2.0932	0.0000
4.0144	0.0000	0.1000	927.1457	2.0932	0.0000
9.0041	0.0000	0.0900	927.1457	2.0932	0.0000
0.0041	0.0000	0.0800	927.1457	2.0932	0.0000
10.0016	0.0000	0.0700	927.1457	2.0932	0.0000
40.0004	0.0000	0.0600	927.1457	2.0932	0.0000
90.0000	0.0000	0.0500	927.1457	2.0932	0.0000
100.0000	0.0000	0.0400	927.1457	2.0932	0.0000
200.0013	0.0000	0.0300	927.1457	2.0932	0.0000
400.0040	0.0000	0.0200	927.1457	2.0932	0.0000
600.0000	0.0000	0.0100	927.1457	2.0932	0.0000
1000.0000	0.0000	0.0000	927.1457	2.0932	0.0000
1500.0000	0.0000	0.0000	927.1457	2.0932	0.0000

CP = 0.0000000000000000 K1 = 927.1457/FMU  
KIM = 0.1000000000000000

Table 6-28. Computer Output for Electric and Dielectric Data of Untreated Quartz Sample M<sub>3</sub> Following a 24-Hour Water Soak

ENTER NO. AND PUT BACK UP FOR ELECTRODE CONNECTION

MS 24 PM		ADU = 0.00002		PHASE AND AMPLITUDE CORRECTED			
PMU	X0	X0	XADU	XADU	PM1	2	ZADU
1.000	103.4000	-14.0357	4.2734	-0.0002	-8.0434	106.2943	4.3171
1.999	601.0350	-21.4434	4.1000	-0.0002	-11.0002	103.2304	4.1933
7.001	20.2000	-31.2000	3.0000	-1.2004	-10.2000	100.0000	4.0000
0.001	01.0000	-40.0000	3.0000	-1.0000	-20.7193	98.7607	3.0000
0.000	04.0000	-40.3700	3.0173	-1.9733	-35.1067	80.7349	3.0000
0.000	07.0000	-40.0000	1.0000	-1.0000	-55.8319	60.1091	2.7500
0.000	25.0000	-45.0000	1.0000	-1.3102	-55.7034	43.2438	1.8370
0.000	0.0000	-21.5000	0.0000	-1.0000	-65.2652	20.0000	1.1410
0.000	3.0000	-10.5000	0.2101	-0.0001	-67.2000	23.3602	0.9370
0.000	3.3333	-7.1000	0.1504	-0.2921	-64.9743	13.0002	0.5332
0.000	4.0000	-3.0000	0.0932	-0.1621	-60.0812	7.1000	0.1070
1.000	0.0000	-3.3333	0.0001	-0.1356	-37.8776	4.0000	0.1601
1314.000	1.0000	-4.0000	0.0001	-0.0934	-50.0000	2.9976	0.1201

```

ND,AD CIRCLE FIT RESULTS-  CIRCLE CENTER = 53.7631  3.8338
                             RADII = 33.4749
                             FIT = 2.2217

```

KP = 100.961 / KHTB = 8.665  
MURTEL PANAMITLHO - KI = 100.961 / 11KQ  
KP = 100.473

ALL INFORMATION CONTAINED HEREIN IS UNCLASSIFIED

CP# 8.34188/L-84

TAU= 3.548910E6      L=384.94773      E11F= 142.44314

[illegible]

DET. 6, 14 FOR K156/TMMN

--- NO. OF CIRCLE FIT RESULTS ---		CIRCLE CENTER	X	Y
		RADIUS	55.7631	5.8338
		PIT	55.2749	
			2.2217	

```

MP = 18.951/          MTF = 2.6283
MULTI PARAMETER -    M1 = 10330.8174/THQ
                     MP = 18.8732

```

[illegible]

6# 0.13476E #5 N# 0.11142E #1  
##### STOP #####

Table 6-29. Computer Output for Electric and Dielectric Data of Quartz Sample M<sub>1</sub> Following a 75-Hour Water Soak

ENTEK NS,ADD PUT 50W1 UP FOR ELECTRODE CORRECTION									
000,12219									
M1 75 HR									
AOD= 0.12219									
PHASE AND AMPLITUDE CORRECTED									
FRQ	NS	XS	RADD	ZADD	PHI	Z	ZAOD		
0.999	5.3284	-0.4195	0.6311	-0.0312	-4.5015	5.3049	0.65		
2.015	5.1193	-0.4167	0.6253	-0.0509	-4.6541	5.1364	0.65		
4.028	4.9659	-0.4915	0.6067	-0.0609	-9.5519	4.0099	0.65		
8.015	4.7399	-0.6198	0.5792	-0.0756	-7.4405	4.7000	0.65		
20.004	4.4421	-0.8637	0.5428	-0.1035	-11.0033	4.4000	0.65		
40.006	4.4084	-1.0814	0.4947	-0.1321	-14.9568	4.4000	0.65		
80.128	3.4939	-1.5398	0.4272	-0.1637	-20.9787	3.4000	0.65		
99.900	5.5067	-1.5197	0.4040	-0.1615	-21.7598	5.5000	0.65		
201.072	2.5489	-1.3806	0.3114	-0.1687	-20.4448	2.0000	0.65		
401.929	1.8145	-1.2229	0.2217	-0.1494	-55.9006	4.0000	0.65		
803.372	1.2258	-0.8608	0.1493	-0.1032	-55.1240	8.0000	0.65		
1603.630	0.8959	-0.7933	0.1337	-0.0969	-53.9545	1.6000	0.65		
2025.783	0.7038	-0.4133	0.0862	-0.0387	-30.4045	2.0000	0.65		
NS,XS CIRCLE FIT RESULTS- CIRCLE CENTER = 2.8856 1.7549									
RADIUS = 3.1103									
FIT = 2.0303									
M# = 5.4537 KINF= 0.5174									
MODEL PARAMETERS - R1 = 1103.9126/FRQ									
RP = 5.1364									
KHU = 0.00059E #8 UHM-CH									
CP= 0.125530E-05									
TAU= 0.78105MSEC E0=2273.00325 E1NF= 152.45570									
FRQ	EP	EPP							
0.999	0.221099E #4	0.632355E #2							
2.013	0.217663E #4	0.555848E #2							
4.028	0.212603E #4	0.141027E #3							
8.015	0.203162E #4	0.204546E #3							
20.004	0.190092E #4	0.318295E #3							
40.006	0.175819E #4	0.418665E #3							
80.128	0.153145E #4	0.500870E #3							
99.900	0.143769E #4	0.552110E #3							
201.072	0.120000E #4	0.363688E #3							
401.929	0.962137E #3	0.553078E #3							
803.372	0.741060E #3	0.434635E #3							
1603.630	0.670301E #3	0.423201E #3							
2025.783	0.311765E #3	0.321207E #3							
DET. G,N FOR K1G/FRN									
NS,XS CIRCLE FIT RESULTS- CIRCLE CENTER = 2.8856 1.7549									
RADIUS = 3.1103									
FIT = 2.0303									
M# = 5.4337 KINF= 0.5174									
MODEL PARAMETERS - R1 = 1103.9126/FRQ									
RP = 5.1364									
F	F-1/2	R1	XP	CP					
0.9983	1.0007	67.3181	-60.2051	-0.2644E-02					
2.0132	0.7044	42.0714	-35.7525	-0.1417E-02					
4.0196	0.4988	33.9869	-44.4586	-0.0906E-05					
8.0128	0.3553	26.0536	-52.2178	-0.6165E-05					
20.0042	0.2252	20.4321	-20.3652	-0.3850E-05					
40.0062	0.1379	15.6325	-15.0543	-0.2045E-05					
80.1282	0.1117	11.9353	-8.8897	-0.2237E-05					
99.9001	0.1001	10.3524	-8.8908	-0.1969E-05					
201.0724	0.0703	7.1063	-4.0874	-0.1507E-05					
401.9293	0.0498	4.6026	-5.0359	-0.1290E-05					
803.3713	0.0332	2.3207	-1.8134	-0.1091E-05					
1603.6497	0.0315	2.2384	-1.3554	-0.1021E-05					
2025.7827	0.0222	0.9829	-0.7787	-0.1009E-05					
G# 0.70428E #2 N# 0.49970E #0									
***** STOP *****									

Table 6-30. Computer Output for Electric and Dielectric Data of Quartz Sample M<sub>2</sub> Following a 75-Hour Water Soak

ENTER RS,AOD PUT SSW1 UP FOR ELECTRODE CORRECTION  
#07, #6154

M2 75 HR		AOD= #.6154		PHASE AND AMPLITUDE CORRECTED			
FRQ	RS	XS	RAOD	XAOD	PH1	Z	ZAOD
1.010	2.7131	-0.1000	0.1664	-0.0115	-5.9645	2.7196	0.1668
2.006	2.6621	-0.2101	0.1655	-0.0133	-4.6035	2.6710	0.1630
4.004	2.6199	-0.2093	0.1607	-0.0120	-4.5669	2.6202	0.1612
8.009	2.5629	-0.2332	0.1572	-0.0145	-5.1905	2.5735	0.1579
16.018	2.5700	-0.2031	0.1576	-0.0124	-4.1901	2.5700	0.1581
20.155	2.4924	-0.2570	0.1529	-0.0150	-6.0511	2.5057	0.1475
40.193	2.3076	-0.2068	0.1465	-0.0175	-9.2450	2.2540	0.1350
80.386	2.1053	-0.5557	0.1340	-0.0210	-11.2750	1.9834	0.1217
99.900	2.2115	-0.4407	0.1356	-0.0220	-16.2509	1.6706	0.1030
200.267	1.9041	-0.5553	0.1160	-0.0340	-19.6094	1.3322	0.0817
400.522	1.5004	-0.5655	0.0969	-0.0546	-22.2297	1.2474	0.0765
800.000	1.2250	-0.5202	0.0750	-0.0524	-10.0124	0.9312	0.0571
1600.650	1.1547	-0.4719	0.0700	-0.0209			
2029.520	0.0855	-0.2079	0.0543	-0.0176			

RS, XS CIRCLE FIT RESULTS- CIRCLE CENTER = 1.6467 #.9936  
RADIUS = 1.5552  
FIT = 2.6115

Rd = 2.0171 RINF = 0.4764

MODEL PARAMETERS - R1 = 601.5010/FRQ  
RP = 2.3407

RHO = 0.17200E #0 OHM-CM

CP = 0.15060E-05

TAU = 0.42557MSEC E0 = 1645.55640 RINF = 270.20550

FRQ	EP	EPP
1.010	0.16060E #4	0.579263E #2
2.006	0.150015E #4	0.541229E #2
4.004	0.156214E #4	0.766119E #2
8.009	0.152476E #4	0.106042E #3
16.018	0.150962E #4	0.110415E #3
20.155	0.145034E #4	0.160193E #3
40.193	0.137051E #4	0.200030E #3
80.386	0.124405E #4	0.256013E #3
99.900	0.122020E #4	0.270709E #3
200.267	0.109300E #4	0.505256E #3
400.522	0.945010E #3	0.316200E #3
800.000	0.801149E #3	0.209059E #3
1600.650	0.757611E #3	0.209630E #3
2029.520	0.652455E #3	0.246356E #3

DET. G,N FOR R1=G/PHN

RS, XS CIRCLE FIT RESULTS- CIRCLE CENTER = 1.6467 #.9936  
RADIUS = 1.5552  
FIT = 2.6115

Rd = 2.0171 RINF = 0.4764

MODEL PARAMETERS - R1 = 601.5010/FRQ  
RP = 2.5407

F	F-1/2	R1	XP	CP
1.010	0.9950	11.2306	-26.7974	-0.5000E-02
2.006	0.7001	10.2003	-22.1241	-0.5506E-02
4.004	0.4997	9.3327	-22.1660	-0.1793E-02
8.009	0.3354	8.4400	-18.9055	-0.1051E-02
16.018	0.5159	8.4500	-21.7794	-0.7295E-03
20.155	0.2220	7.5149	-16.0229	-0.4929E-03
40.193	0.1577	6.5004	-15.0200	-0.5041E-03
80.386	0.1115	4.0569	-8.5656	-0.2311E-03
99.900	0.1001	5.3429	-7.2700	-0.2101E-03
200.267	0.0706	3.9400	-4.2261	-0.1001E-03
400.522	0.0490	2.7504	-2.7209	-0.1451E-03
800.000	0.0352	1.0000	-1.5034	-0.1249E-03
1600.650	0.0315	1.5001	-1.4460	-0.1096E-03
2029.520	0.0221	0.7014	-0.0695	-0.9021E-04

G = 0.15917E #2 N = 0.31379E #0  
XXXXXXXXXXXX STOP XXXXXXXXXXXXXXX

Table 6-31. Computer Output for Electric and Dielectric Data of Quartz Sample M<sub>3</sub> Following a 75-Hour Water Soak

ENTER NS,AOD P-T SSW1 UP FOR ELECTRAUDE CORRECTION  
 #09.04#62

M3 75 HR		AOD = #.04#62		PHASE AND AMPLITUDE CORRECTED			
FREQ	RS	XS	RADD	XAOD	PHI	2	2AOD
1.010	109.0204	-17.7542	4.4284	-0.7212	-9.2502	110.4566	4.4867
2.015	102.0055	-25.7605	4.1467	-0.9651	-15.1053	104.0140	4.2575
6.006	77.0051	-36.0534	3.1604	-1.4637	-24.0510	85.7440	3.4029
8.015	74.5559	-38.4600	5.0277	-1.5622	-27.2054	85.8756	3.4069
10.010	67.9902	-40.3577	2.7621	-1.6903	-30.6010	79.0727	5.2119
20.006	45.0007	-40.0505	1.0657	-1.6272	-41.1275	60.0075	2.4741
40.120	27.6611	-53.2904	1.0992	-1.5525	-50.0960	42.0017	1.7427
80.120	14.4024	-25.4754	0.5085	-0.5555	-50.5510	27.5015	1.1204
99.002	12.1009	-20.5269	0.4910	-0.8350	-50.4679	23.0323	0.9601
201.072	6.0541	-12.6170	0.2704	-0.5125	-61.4032	14.5592	0.5051
402.576	4.1916	-7.5679	0.1705	-0.2905	-60.3675	8.4769	0.3440
805.572	2.8073	-4.1555	0.1173	-0.1679	-55.0696	5.0421	0.2040
1005.050	2.5016	-5.5036	0.1049	-0.1570	-52.7026	4.2640	0.1752
2029.520	2.6192	-1.6006	0.0820	-0.0674	-50.4370	2.6145	0.1062

RS,XS CIRCLE FIT RESULTS- CIRCLE CENTER = 59.1507 21.5426  
 RADIUS = 62.2774  
 FIT = 1.5099

R# = 117.6440 KINF = #.6526

MODEL PARAMETERS - R1 = 7954.4250/FREQ  
 RP = 117.0122

KNU = #.47767E #9 OHM-CM

CP = #.306524E-04

TAUR = 4.61454MSEC E0 = 0.21170.226 EINF = 115.03640

FREQ	EP	EPP
1.010	#.109245E #3	#.125135E #4
2.015	#.191155E #3	#.206094E #4
6.006	#.168492E #3	#.421077E #4
8.015	#.160000E #3	#.491230E #4
10.010	#.153224E #3	#.547709E #4
20.006	#.127159E #3	#.607200E #4
40.120	#.082605E #4	#.750457E #4
80.120	#.705955E #4	#.622400E #4
99.002	#.627615E #4	#.570640E #4
201.072	#.414557E #4	#.395633E #4
402.576	#.264055E #4	#.253345E #4
805.572	#.166300E #4	#.155599E #4
1005.050	#.143006E #4	#.132290E #4
2029.520	#.695603E #3	#.707051E #3

UET. G,H FOR R1#0/P#H#4

RS,XS CIRCLE FIT RESULTS- CIRCLE CENTER = 59.1507 21.5426  
 RADIUS = 62.2774  
 FIT = 1.5099

R# = 117.6440 KINF = #.6526

MODEL PARAMETERS - R1 = 7954.4250/FREQ  
 RP = 117.0122

F	F-1/2	R1	XP	CP
1.0057	#.9952	2062.5200	-679.4500	-0.2320E-03
2.0151	#.7045	1104.6700	-456.9467	-0.1729E-03
6.0065	#.4000	467.6204	-201.3152	-0.1305E-03
8.0120	#.5555	465.6025	-100.4699	-0.1101E-03
10.0100	#.5101	412.6055	-152.0055	-0.1041E-03
20.0004	#.2231	257.1005	-91.1004	-0.0690E-04
40.1204	#.1579	105.1920	-54.2714	-0.7300E-04
80.1202	#.1117	90.5751	-51.6451	-0.6277E-04
99.0010	#.1002	81.6500	-20.9452	-0.5931E-04
201.0724	#.0705	45.6016	-15.6055	-0.5046E-04
402.5764	#.0490	22.5917	-9.0072	-0.4551E-04
805.5715	#.0352	10.7294	-5.3634	-0.3693E-04
1005.0497	#.0315	8.4204	-4.5150	-0.5514E-04
2029.5200	#.0221	5.4751	-2.8104	-0.2705E-04

G# #.24960E #4 N# #.00274E #0  
 \*\*\*\*\* STOP \*\*\*\*\*

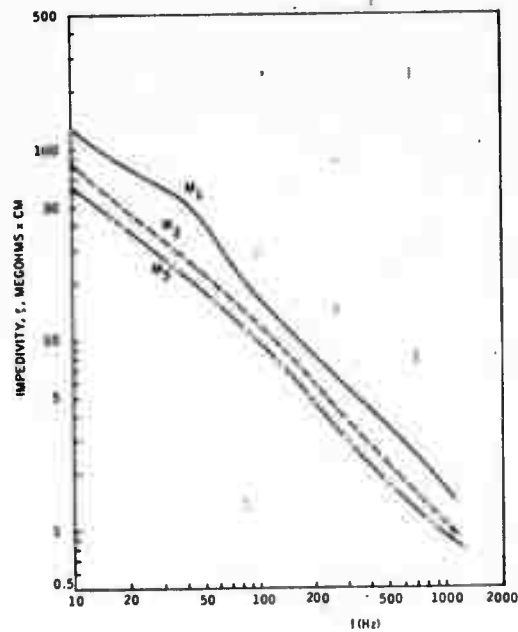


Figure 6-11. Variation of Impedivity with Frequency for the Untreated Quartz Samples

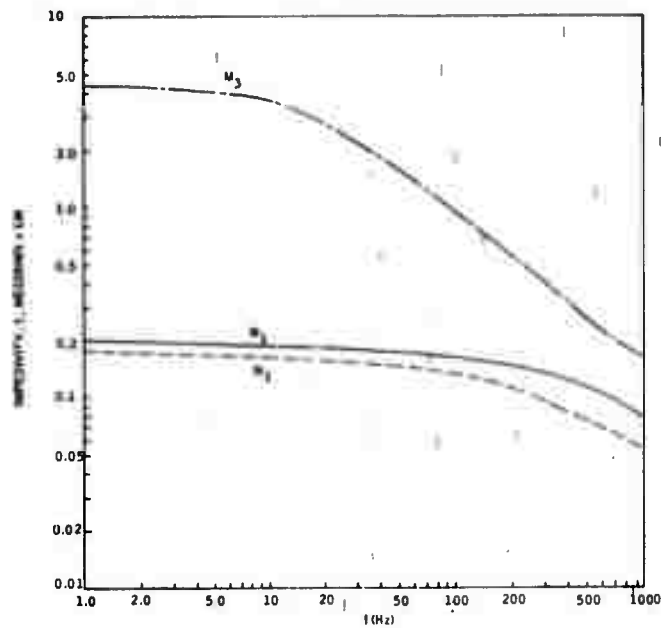


Figure 6-12. Variation of Impedivity with Frequency for the Quartz Following 24-hour Soak

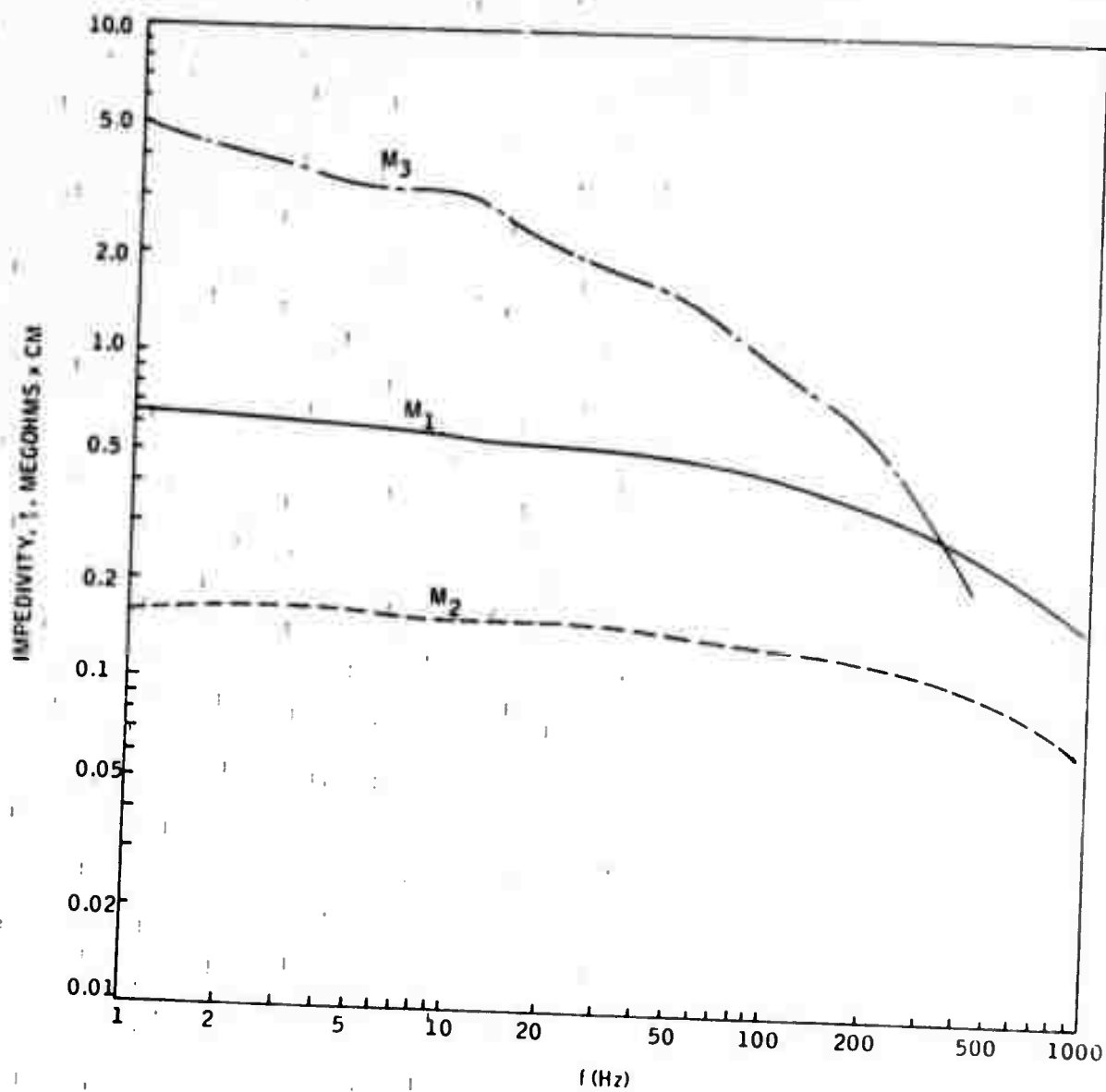


Figure 6-13. Variation of Impedivity with Frequency for the Quartz (II) Following 75-Hour Soak

The electric and dielectric parameters that exhibit the most significant change with water treatment are chosen and given in Table 6-32. It is noted that the resistivity at zero frequency (dc resistivity),  $\rho_o$ , decreases by about three orders of magnitude by mere soaking in water. This explains the frequent difficulties experienced in working with quartz where the output was often very unstable and exhibited considerable d-c drift, apparently due to slight changes in environmental humidity. The decrease in quartz resistivity with duration of soaking time is illustrated by the curves in Figure 6-14. The d-c resistivity of dry quartz was  $8.36 \times 10^{10}$ ,  $7.55 \times 10^{10}$ , and  $7.13 \times 10^{10}$  ohm·cm for the three samples, with an average of  $7.68 \times 10^{10}$  ohm·cm. The water-treated samples exhibited larger variability in resistivity. In addition, prolongation of water treatment beyond 24 hours produced little variation in  $\rho_o$ , except for the thinnest sample M1 where a slight increase in  $\rho_o$  occurred at larger soaking times. This is suggestive of the leaching out of the conductive ions by prolonged soaking, a phenomena which should occur more readily with thinner rock samples.

Figure 6-15 shows the variation of the dielectric constant at the limit of zero frequency,  $K_o$ , with soaking time. For quartz the decrease in dielectric constant with soaking time is much smaller than the decrease in resistivity. The decrease was nearly linear except for the thinner sample M1, where  $K_o$  appeared to increase with increased soaking time after reaching a minimum at about 40 hours.

The foregoing experiments were planned to illustrate the effects of rock water content and alkali (mobile) ion content on the rock electric and dielectric properties. The experiments suggest a choice of certain electric or dielectric parameters that respond the most by change in water or alkali content. Further experiment should be done with shorter pretreatment times to show whether the chosen parameters can indeed be used to measure the quantity of water retained in the rock. The experiments described in this section are, therefore, illustrative in nature and by no means quantitative. Developments



Table 6-32. Effect of Water Pretreatment on Some Impedance and Dielectric Parameters of Quartz (II)

Parameters	MF1, $d = 0.31$ cm			MF2, $d = 0.41$ cm			MF3, $d = 0.92$ cm		
	Blank (no pretreatment)	24 hr	75 hr	Blank (no pretreatment)	24 hr	75 hr	Blank (no pretreatment)	24 hr	75 hr
$f_0$ (kHz)	$8.36 \times 10^4$	$2.16 \times 10^2$	$6.46 \times 10^7$	$7.95 \times 10^{10}$	$1.93 \times 10^7$	$1.75 \times 10^7$	$7.12 \times 10^{10}$	$4.42 \times 10^8$	$4.78 \times 10^8$
$C_p$ (picofarads)	3.88	246	126	4.94	188	126	3.74	52.2	38.6
$\epsilon$ (dimensionless)	82.4	(6.5)	6.78	85.8	6.65	0.43	105.7	5.6	4.8
$R_p$	4386	1500	2276	745.3	4018	1646	18533	5885	21170
$n_p$	3.12	370	1.33	12.61	398	278	15.96	142	114

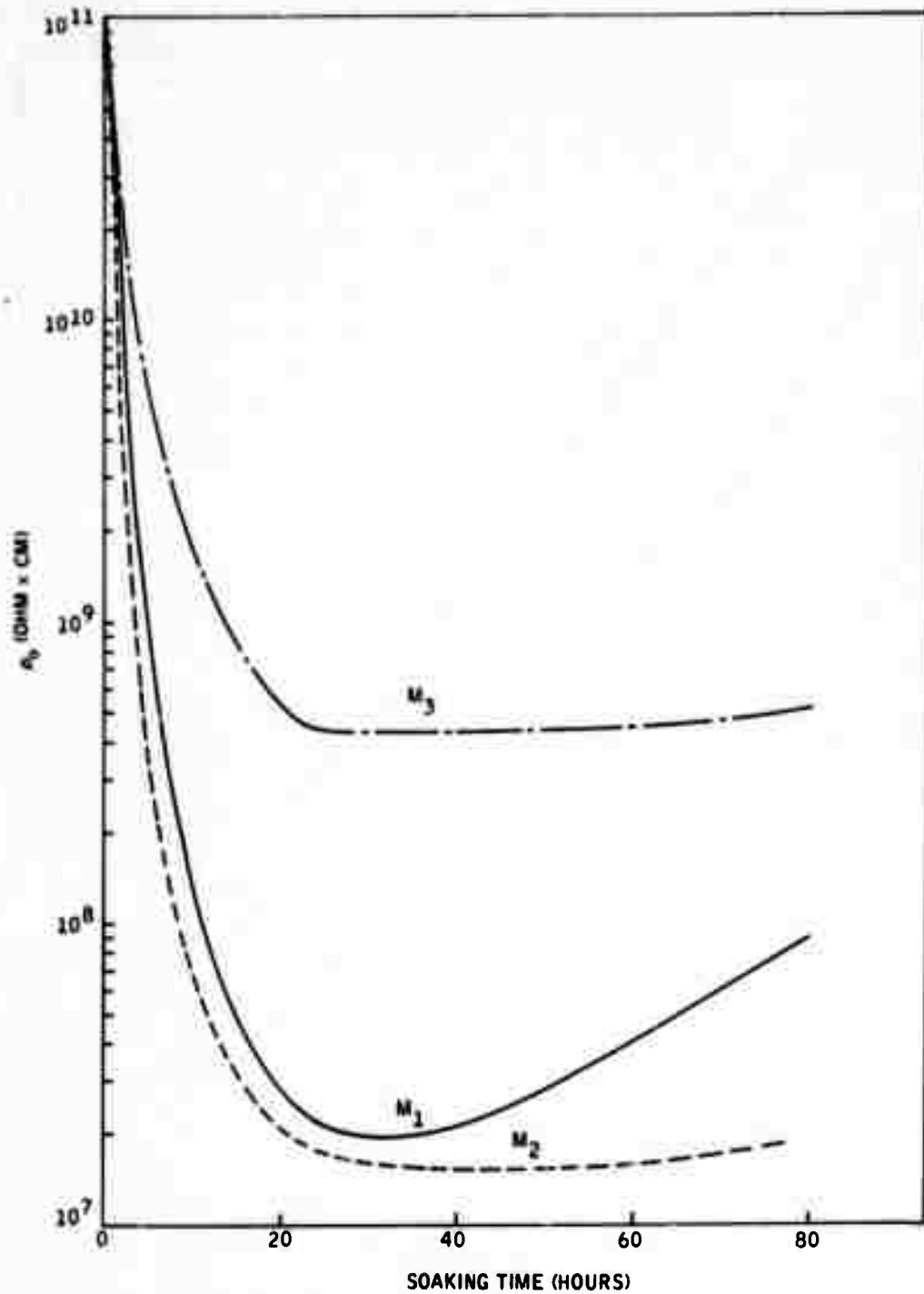


Figure 6-14. Variation of Quartz Resistivity with the Duration of Soaking Time in Water

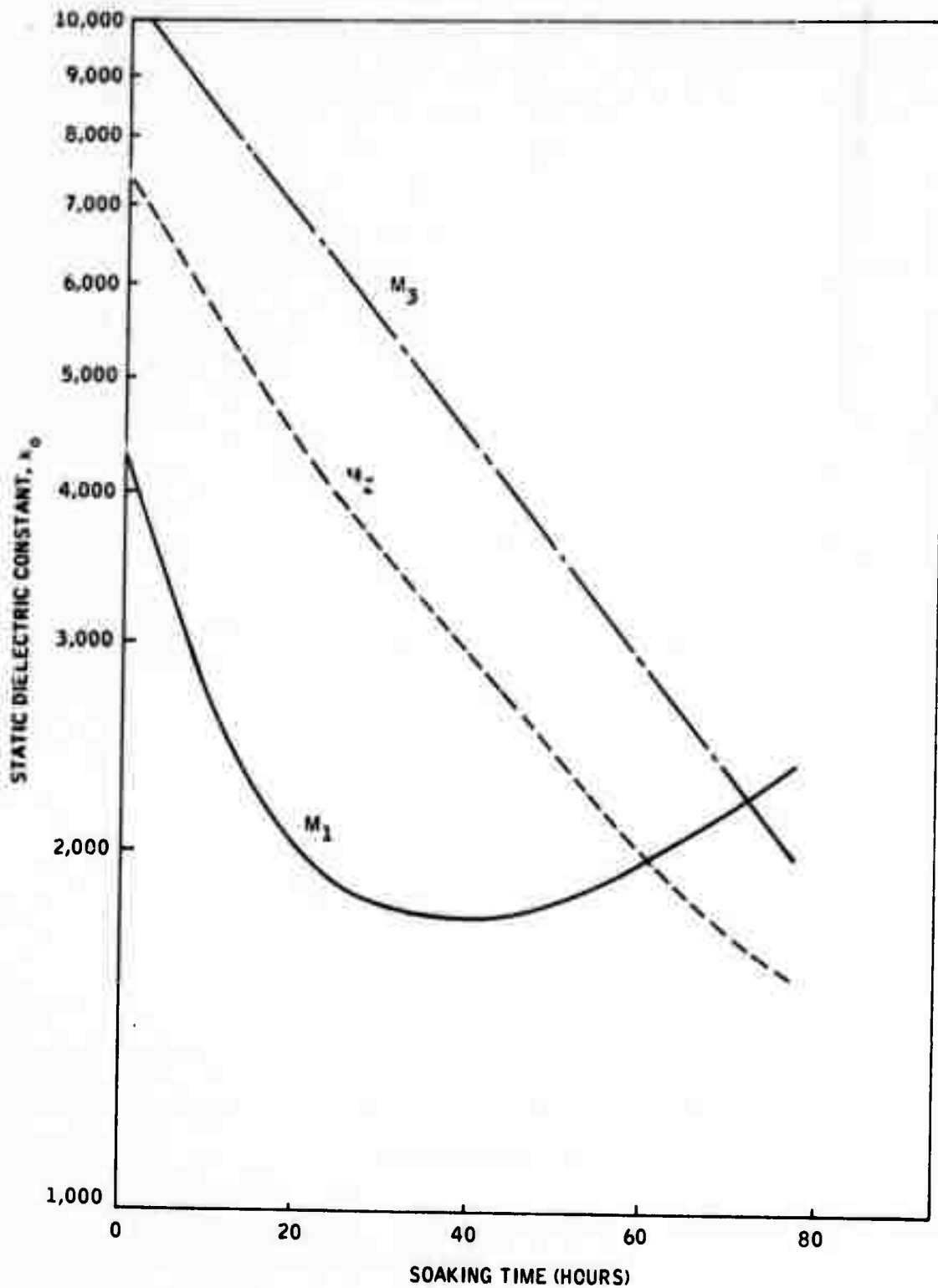


Figure 6-15. Variation of Quartz Dielectric Constant ( $K_0$ ) with Its Soaking Time in Water

of procedures to measure the water content in rocks, while not the intent of this research, can nevertheless be improved by choice of the optimum electric or dielectric parameter; i.e., the one that exhibits the highest sensitivity to the presence of water or sodium ions. This research shows beyond doubt that the zero-frequency parameters (dc or those extrapolated from measurements at low frequencies) are the most sensitive ones, while the high-frequency parameters show little or no variation by presence of water or mobile sodium ions.

## SECTION VII

### MODELS TO SIMULATE THE ELECTRIC AND DIELECTRIC ROCK BEHAVIOR

This section is concerned with the mathematical description of physical models selected to describe the experimentally obtained electric and dielectric data on rocks.

Conventional models, such as the one by Debye (Ref. 18) and K. W. Wagner et al (Ref. 19), have been able to explain many fundamental characteristics of molecular behavior. They do, however, fail to explain the dielectric characteristics of complex systems such as rocks. For the interpretation of data obtained during this study, a mathematical model will be introduced that is able to explain many of the rock impedance characteristics. A method of converting the impedance data into the complex permittivity data is also treated in detail.

In principle, it is always possible to simulate the impedance and dielectric behavior of many real systems, rocks included, by circuits composed of frequency-independent parameter components. An impedance whose frequency dependence is given by

$$Z = r_2 + \sum_i \frac{R_{p(i)}}{1 + j (\omega \tau_i)^{1-\alpha}} \quad (7-1)$$

establishes a circular arc in the complex impedance plane (Argand diagram). In this equation,  $r_2$  is the impedance at infinite frequency (equal to the resistance then, since any capacitive reactance will vanish and the presence of inductive reactance is not anticipated),  $R_{p(i)}$  is the  $i^{\text{th}}$  component representing a difference between the zero and infinite frequency resistances,  $\tau_i$  is a

constant with the dimensions of time (relaxation time for the  $i^{\text{th}}$  component or subprocess), and  $\alpha$  is a constant between 0 and 1, but less than 1.

The impedance circular arc subtends an angle,  $2\varphi$  at the center, such that  $\varphi = \frac{\pi}{2}(1-\alpha)$ . For a rock system, the angle  $\varphi$  is called the rock phase angle.

From Equations (7-1) and (4-1), and with the assumption of an  $\alpha$  of zero, we can separate the real and imaginary parts of the impedance to:

$$R_s = r_2 + \sum_i \frac{R_{pi}}{1 + (\omega\tau_i)^2}, \quad X_s = \sum_i \frac{\omega\tau_i R_{pi}}{1 + (\omega\tau_i)^2} \quad (7-2)$$

The relationship between  $X_s$  and  $R_s$  can be shown to describe a semicircle.

These equations can also be represented by a plot of  $X$  versus  $\log \omega$  or  $\log f$ . This representation is of particular value in determining the magnitude and frequency of the maximum value of  $X$  (turnover frequency). Equation (7-2) predicts that the maximum value of  $X$  is  $R_p/2$ , while the relaxation-time is found from the frequency of the maximum,  $\omega_{\text{max}}$ , thus

$$\tau = \frac{1}{\omega_{\text{max}}} = \frac{1}{2\pi f_{\text{max}}} \quad (7-3)$$

Impedance data for rocks have been found to describe a circular-arc plot when displayed in an Argand diagram with the series reactance as ordinate and the series resistance as abscissa. The display is never a full semicircle, but is a part of a circle whose center does not lie on the real axis (resistance), and is substantially below it. The phase angle is defined as half of the angle, subtended by the circular-arc at the center of the circle, i. e., between the two radii of the circle defining the two points of intersection of the arc with the resistive axis.

An ideal dielectric dispersion model (Debye Model) is easily simulated by a parallel RC unit, and can be shown to give a full semicircular plot upon transformation to an isoimpedic series RC unit.

Sinbel (Khalafalla) (Ref. 20) derived various analytical proofs of the semicircular arc in an attempt to describe the relationship of the equivalent series reactance to the corresponding resistance. The derivations were based on a parallel-to-series transformation of electrical models with a single time-constant. In the simplest case, it was shown that the transformation from a parallel RC unit (with frequency independent components) to an adjustable series RC unit (with the same total impedance) results in a full arc plot in the Argand diagram. The locus of the series reactance,  $X_s$ , when plotted against the series resistance,  $R_s$ , follows the analytical equation of a circle of radius,  $\frac{1}{2} R_p$ , where  $R_p$  is the parallel resistance assumed to be a constant quantity characteristic of the system, thus

$$X_s^2 + [R_s - \frac{1}{2} R_p]^2 = \frac{1}{4} R_p^2 \quad (7-4)$$

The center of the semicircular plot should then have the coordinates  $(0, \frac{1}{2} R_p)$  and hence is located on the real or resistive axis. This seems to represent a very idealized situation. In real systems the semicircular arc observed experimentally is usually translated vertically downwards so that its center has the coordinates  $(n$  and  $-m)$  and accordingly follows an equation of the form

$$[X_s + m]^2 + [R_s - n]^2 = a^2 \quad (7-5)$$

where  $m$ ,  $n$ , and  $a$  are constants related to  $X_p$  and  $C_p$ .

An electrical model with a single time constant will be developed to account for the experimentally observed electrical data of rocks. The model will also permit a determination of the dielectric data of rocks. In addition, the introduced model allows one to select the parameters that are strongly

influenced by rock conditions, such as the inclusion of water, mobile ions, entrapped gases, pores, and cracks; etc.

### ELECTRICAL ANALOG WITH ONE FREQUENCY DEPENDENT RESISTANCE

An electrical model, Figure 7-1, in which a frequency dependent resistance,  $r_1$ , is shunted across the condenser,  $C_p$ , is capable of describing a circular arc in the series domain with a vertically displaced center (Figure 7-2). A condition to be imposed on the resistor,  $r_1$ , is that its value changes inversely with the frequency such that  $r_1 = \frac{g}{f}$ , where  $g$  is a constant and  $f$  is the frequency. The total impedance of this model is given by

$$\begin{aligned}
 Z_p &= \frac{R_p \frac{j r_1 X_p}{r_1 + j X_p}}{\frac{j r_1 X_p}{R_p + r_1 + j X_p}} + r_2 \\
 &= \frac{r_1 R_p X_p^2 (r_1 + R_p)}{r_1^2 R_p^2 + X_p^2 (r_1 + R_p)^2} + j \frac{r_1^2 R_p^2 X_p}{r_1^2 R_p^2 + X_p^2 (r_1 + R_p)^2} + r_2 \quad (7-6) \\
 &= R_s + j X_s.
 \end{aligned}$$

From which one obtains

$$R_s = r_2 + \frac{r_1 R_1 X_p^2 (r_1 + R_p)}{r_1^2 R_p^2 + X_p^2 (r_1 + R_p)^2} \quad (7-7)$$



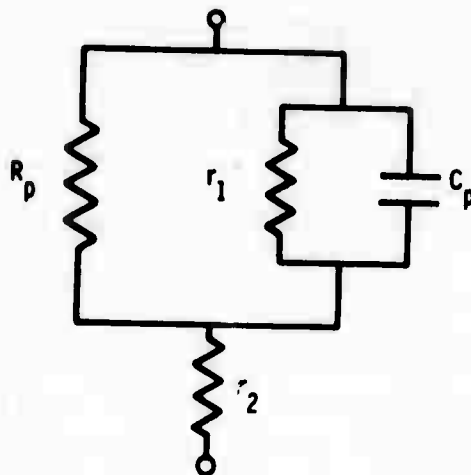


Figure 7-1. Electrical Model That Produces a Circular Arc Plot

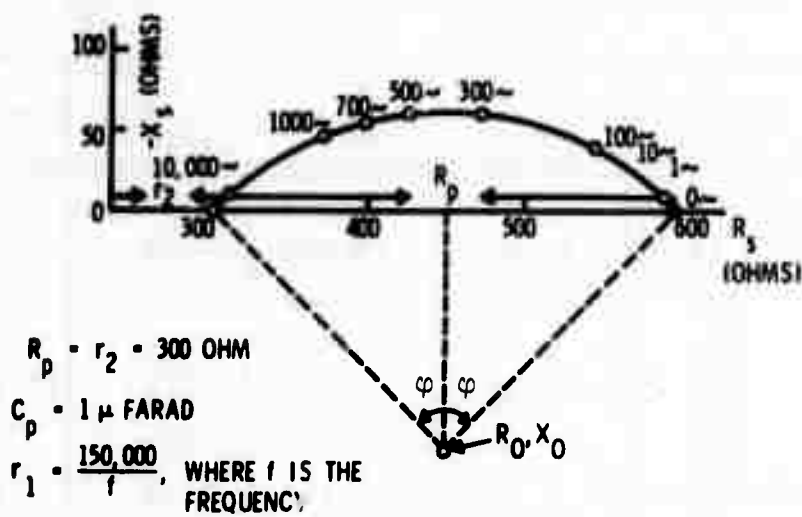


Figure 7-2. Circular Arc Plot Between Equivalent  $X_s$  and  $R_s$  of the Model

and

$$X_s = \frac{r_1^2 R_p^2 X_p}{r_1^2 R_p^2 + X_p^2 (r_1 + R_p)^2} \quad (7-8)$$

Taking the following representative values for the electrical parameters,

$$R_p = r_2 = 300 \text{ ohm}$$

$$C_p = 1 \text{ microfarad}$$

$g = 150,000 \text{ ohm per second}$ , such that  $r_1 = \frac{g}{f} = 300 \text{ ohm}$  at a frequency of 500 Hz, one is able to calculate values for  $R_s$  and  $X_s$  at various frequencies. These calculations are given in Table 7-1.

Table 7-1. Equivalent Series Resistance and Reactance for Electrical Model of Figure 7-1

f (Hz)	$r_1$ (ohm)	$X_p$ (ohm)	$R_s$ (ohm)	$X_s$ (ohm)
0	150,000	159,000	599	0.6
10	15,000	15,924	594	5.4
100	1,500	1,592	544	38.3
300	500	531	467	58.9
500	300	318	423	57.8
700	214	227	396	52.8
1,000	150	159	372	45.1
10,000	15	16	308	7.1

The plot of  $X_s$  against  $R_s$  as shown in Figure 7-2 is found to describe a circular-arc with a depressed center and whose boundary values satisfy the limiting values required by the electrical model of the circuit in Figure 7-1. Thus, at infinite frequency, both  $r_1$  and  $X_p$  become zero, and the total impedance of the network equals  $r_2$ ; i. e., 300 ohm. The first intersection point of the circular-arc with the  $R_s$  axis is also found to be 300 ohm. At zero frequency, the limiting impedance of the network becomes  $(R_p + r_2) = 600$  ohm.

It appears, therefore, that the electrical model of Figure 7-1 gives a realistic analog to a system displaying a circular-arc plot in the Argand diagram. The limits of the rock impedance at zero frequency would be given by  $(r_2 + R_p)$  and, at infinite frequency, by  $r_2$ . A direct estimation of  $r_2$  and  $R_p$  is thus possible by extrapolating the circular-arc to intersect the real axis. The unusual resistor in this model is  $r_1 = \frac{g}{f}$ , where  $g$  is a constant given by

$$g = \frac{1}{2\pi K C_p} \quad (7-9)$$

where  $K$  is a constant related to the phase-angle, and  $C_p$  is the frequency independent rock capacitance which can be taken as a constant.

The rock phase-angle,  $\phi$ , would only be dependent on the values of  $C_p$  and  $r_1$  and, since these two components are in parallel, then

$$\phi = \tan^{-1} \left( \frac{r_1}{X_p} \right) = \tan^{-1} \left( \frac{1}{K\omega C_p} \bigg/ \frac{1}{\omega C_p} \right) = \tan^{-1} \left( \frac{1}{K} \right) \quad (7-10)$$

and, hence,

$$K = \cotan \phi, \text{ or } \phi = \cotan^{-1} K. \quad (7-11)$$

The angle,  $\phi$  would also be identical with the experimentally measured phase-angle between the vertical through the semicircular-arc center and the line joining it to either of its intercepts with the real axis. Thus, experimentally determining the rock phase-angle,  $\phi$ , in each individual case would enable a determination of the constant  $K$  required to calculate  $r_1$ .

To calculate the turnover-frequency, one can make use of the fact that it is the characteristic frequency which maximizes  $X_s$ . Upon differentiating Equation (7-8) for  $X_s$  with respect to  $\omega$ , it is possible to derive (see Appendix B) that the turnover frequency is given by

$$f_{\max} = \frac{1}{2\pi R_p C_p \sqrt{1 + K^2}} \quad (7-12)$$

Despite its unusualness for being "electrically unrealizable," the suggested model of Figure 7-1 provides a mechanism for explaining the observed results; i. e., a circular arc with a depressed center in the Argand diagram relating  $X_s$  to  $R_s$ . Previous literature on electrode polarization had often revealed many such unusual electrical components, similar to  $r_1$ , in the model. Warburg (Ref. 7) stated that the electrochemical polarization resistance is inversely proportional to the square root of frequency; thus

$$R_m = R + \frac{g}{\sqrt{f}} \quad (7-13)$$

where  $R_m$  is the measured resistance,  $R$  is the true electrolytic resistance, and  $g$  is the polarization resistance at a frequency,  $f$ , of 1 Hz. Fricke (Ref. 21) had also proposed a capacitance for cell membranes that changes as a power function of frequency.

# CONVERSION OF IMPEDITIVITY DATA TO COMPLEX PERMITTIVITY IN A REAL SYSTEM

This subsection is concerned with a method of transforming the experimentally obtained electrical data (Argand diagram) into complex permittivity (Cole-Cole diagram). The technique used here invokes a single relaxation for both the circular arc plots in the Argand and Cole-Cole diagrams, and will be denoted as a "bracketing" technique. This method relates the boundary points for both the impedance and dielectric circular arcs with one characteristic relaxation time. Previous investigators (Refs. 19, 22, 23, and 24) used a distribution of relaxation times to account for dispersion in a real system. Unlike our electrical model, a mathematical distribution of time constants cannot provide a one-to-one correspondence between rock characteristics and their electrical parameters.

The relaxation time for a dielectric dispersion process following the Maxwell-Wagner mechanism is related to the volume resistivity by the following equation given in Vera Daniel's monograph (Ref. 25).

$$\tau = K \epsilon_r \rho \quad (7-14)$$

where  $\rho$  is the volume resistivity defined by

$$R = \rho \left( \frac{d}{A} \right), \quad \text{or } \rho = R \left( \frac{A}{d} \right) \quad (7-15)$$

At the two boundary points of infinite and zero frequency, respectively, the application of Equation (7-14) with the provision that the value of  $\epsilon$  decreases with increasing frequency, leads to

$$\tau = \epsilon_{\infty} \rho_0 = \epsilon_{\infty} R_0 \left( \frac{A}{d} \right) \quad (7-16)$$

Also,

$$\tau = \epsilon_0 \rho_\infty = \epsilon_0 R_\infty \left( \frac{A}{d} \right) \quad (7-17)$$

This is justified under the assumption of a single relaxation time.

The dielectric permittivity at infinite and zero frequency can therefore be calculated from

$$\epsilon_\infty = \left( \frac{\tau}{R_0} \right) \left( \frac{d}{A} \right) \quad (7-18)$$

and

$$\epsilon_0 = \left( \frac{\tau}{R_\infty} \right) \left( \frac{d}{A} \right) \quad (7-19)$$

Both  $R_0$  and  $R_\infty$  can be determined from the experimental impedance circular arc as the points of furthest and nearest intersection with the real axis. The relaxation time,  $\tau$ , can be determined from the experimental impedance data by the maximization of  $X_g$  with  $\log f$ . The maximum reactance appears at a frequency,  $f_{\max}$ , such that

$$\omega_{\max} \tau = 1, \text{ or } \tau = \frac{1}{\omega_{\max}} = \frac{1}{2\pi f_{\max}} \quad (7-3)$$

The relaxation time can also be estimated in terms of the model parameters. A detailed derivation (given in Appendix B) leads to

$$\tau = (R_0 - R_\infty) C_p \sqrt{1 + \cot^2 \varphi} \quad (7-20)$$

where  $\varphi$  is the rock phase angle derived from the impedance diagram as follows:

$$\varphi = \sin^{-1} \left[ \frac{R_0 - R_\infty}{2r} \right] \quad (7-21)$$

where  $r$  is the radius of the circle whose arc represents the Argand diagram.

The Cole-Cole parameter (Ref. 24),  $\alpha$ , is related to the phase angle,  $\varphi$ , as follows:

$$\varphi = \frac{\pi}{2} (1 - \alpha) \quad (7-22)$$

In the ideal case of a Debye dielectric,  $\varphi = \frac{\pi}{2}$  and  $\alpha = 0$ . In general,  $\alpha$  is a fraction, usually close to 0.5.

The capacitance,  $C_p$ , needed in Equation (7-20) for calculating the relaxation time can be obtained from the impedance data combining Equations (7-7) and (7-8) leads to the result:

$$C_p = \frac{-X_\omega}{\omega \left[ (R_\omega - R_\infty)^2 + X_\omega^2 \right]} \quad (7-23)$$

In practice, the plot of  $C_p$  as a function of frequency shows a sharp decrease between 0.01 and 100 Hz, which is followed by a plateau between 100 Hz to 2000 Hz. The average value of this plateau is considered to represent  $C_p$ .

The capacitance  $C_p$  can also be determined from Equation (7-20) by using the model-independent value of relaxation time,  $\tau$ , from Equation (7-3), and  $R_0$ ,  $R_\infty$ , and  $\omega$  from the experimental data. It was noted that  $\tau$  determined by the maximization of  $X_g$  (7-3) was in close agreement with that determined from the model equations (7-20).

Using the phenomenological equations of the complex dielectric permittivity given by Cole and Cole (Ref. 22) and in V. Daniel monograph (Ref. 25) as

$$\epsilon^* = \epsilon_\infty + \frac{\epsilon_0 - \epsilon_\infty}{1 + (J\omega\tau)^{1-\alpha}} = \epsilon' - J\epsilon'' \quad (7-24)$$

Equation (7-24) is separable into its real and imaginary parts using the identity:

$$j^\alpha = e^{\frac{j\pi}{2}\alpha} \quad (7-25)$$

to give

$$\epsilon' = \epsilon_\infty + \frac{\epsilon_0 - \epsilon_\infty}{2} \left[ 1 - \frac{\sinh(1-\alpha)s}{\cosh(1-\alpha)s + \cos\left(\frac{\alpha\pi}{2}\right)} \right] \quad (7-26)$$

and

$$\epsilon'' = \frac{\frac{1}{2}(\epsilon_0 - \epsilon_\infty) \cos\left(\frac{\alpha\pi}{2}\right)}{\cosh(1-\alpha)s + \sin\left(\frac{\alpha\pi}{2}\right)} \quad (7-27)$$

where  $s$  is given by

$$s = \log_e(\omega\tau) \quad (7-28)$$

The plot of  $\epsilon''(\omega)$  (or  $\kappa'' = \epsilon''/\epsilon_r$ ) as a function of  $\epsilon'(\omega)$  (or  $\kappa' = \epsilon'/\epsilon_r$ ) as calculated from Equations (7-26) and (7-27) gives the Cole-Cole diagram.

The necessary operational steps in accordance with the foregoing equations were, therefore, added to the computer algorithm to extract the dielectric permittivity data from the specific impedance parameters. Provision for correcting the measured impedance parameters for electrode effects was also included in the program. Note that the calculations of dielectric parameters according to this procedure can be made independently of any assumed model. All the needed quantities  $R_0$ ,  $R_\infty$ ,  $\rho$ , and  $\tau$  are obtained experimentally. The proposed model in this section can, however, be used to calculate  $\tau$  according to Equation (7-20).



# EVALUATION OF THE MODEL PARAMETER, $r_1$ , FOR BASALT

The model transformation equations from the parallel to the series domain were used to solve for  $r_1$  of Figure 7-1 (with no condition imposed on its frequency dependence). At each frequency,  $r_1$  was calculated from the measured values of  $X_s$  and  $R_s$  at that frequency.

Combining Equations (7-7) and (7-8), one obtains

$$\frac{R_s - r_2}{X_s} = \frac{X_p (r_1 + R_p)}{r_1 R_p} = \frac{X_p}{(r_1 // R_p)} \quad (7-29)$$

$$\begin{aligned} X_s X_p &= (R_s - r_2) (r_1 // R_p) \\ &= \frac{(R_s - r_2) (r_1 R_p)}{(r_1 + R_p)} \end{aligned} \quad (7-30)$$

$$\text{and } X_p = \frac{(R_s - r_2) (r_1 R_p)}{X_s (r_1 + R_p)}$$

Substituting the value of  $X_p$  from (7-30) into (7-8), one obtains

$$X_s = \frac{r_1 R_p X_s (R_s - r_2)}{(r_1 + R_p) [X_s^2 + (R_s - r_2)^2]} \quad (7-31)$$

Hence,

$$r_1 R_p (R_s - r_2) = (r_1 + R_p) X_s^2 + (R_s - r_2)^2 \quad (7-32)$$

Solving (7-32) for  $r_1$ , one obtains

$$r_1 = \frac{R_p [X_s^2 + (R_s - r_2)^2]}{R_p (R_s - r_2) - X_s^2 - (R_s - r_2)^2} \quad (7-33)$$

One can also calculate  $X_p$  at all frequencies by combining Equations (7-31) and (7-30), thus

$$X_p = \frac{X_s^2 + (R_s - r_2)^2}{X_s} = -\frac{1}{\omega C_p}$$

and hence

$$C_p = \frac{-X_s}{\omega [X_s^2 + (R_s - r_2)^2]} \quad (7-23)$$

Equations (7-23) and (7-33) were used to calculate  $r_1$  and  $C_p$  for all the rocks studied in the pretreatment experiments of Section VI. An equation of the form

$$r_1 = g/f^n \quad (7-34)$$

was assumed for each of the basalt samples. At each frequency,  $f$ , the resistance  $r_1$  was calculated from the  $X_s$  and  $R_s$  values measured at that frequency. A least-squares fit using Equation (7-34) was performed on these data points. Table 7-2 presents a summary of the values of  $g$  and  $n$  computed for each basalt sample in the dry state and after being subjected for various pretreatment conditions.

Table 7-2. Basalt Parameters of the Equation  $r_1 = g/f^n$ 

Sample → Basalt Rock State ↓	K <sub>1</sub>		K <sub>2</sub>		K <sub>4</sub>	
	g	n	g	n	g	n
Basalt (dry)	3626	0.474	2375	0.634	2048	0.704
Following 23 hour soak in water	5016	0.778	2331	0.554	2018	0.635
Following 77 hour soak in water	4775	0.782	2404	0.745	1517	0.741
Following treatment in 1% NaOH	4817	0.778	3333	0.772	2422	0.794
Following treatment in 5% NaOH	4022	0.735	2933	0.735	2159	0.779
Following treatment in 10% NaOH	3222	0.734	2344	0.670	1831	0.745
Average n	0.713		0.685		0.733	
Standard deviation in n	0.109		0.075		0.052	

Examination of the  $r_1$  values in Equation (7-34) for the obtained data shows a systematic variation in the value of  $g$  with both the basaltic rock sample and its pretreatment history. Except for dry basalt, the constant  $n$  appears to be independent of the rock size or the presence of water or mobile sodium ions. For basalt, an average  $n$  value of  $(0.71 \pm 0.08)$  may be concluded from the present data.

Variation of the parameter  $g$  for basalt with the percentage of sodium hydroxide,  $c$ , in the pretreating solution is illustrated by the curves in Figure 7-3. The pretreatment time was 23 hours, and pretreatment in distilled water for the same period was taken to represent zero percent sodium hydroxide. In

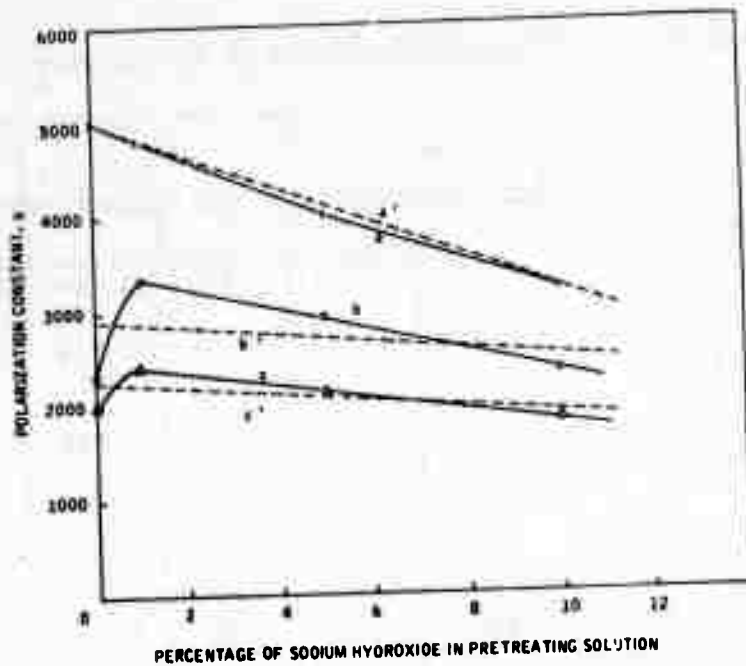


Figure 7-3. Variation of the Basalt Constant  $g$  with the Percentage of Sodium Hydroxide in the Pretreating Solution. Pretreatment Time = 23 Hours

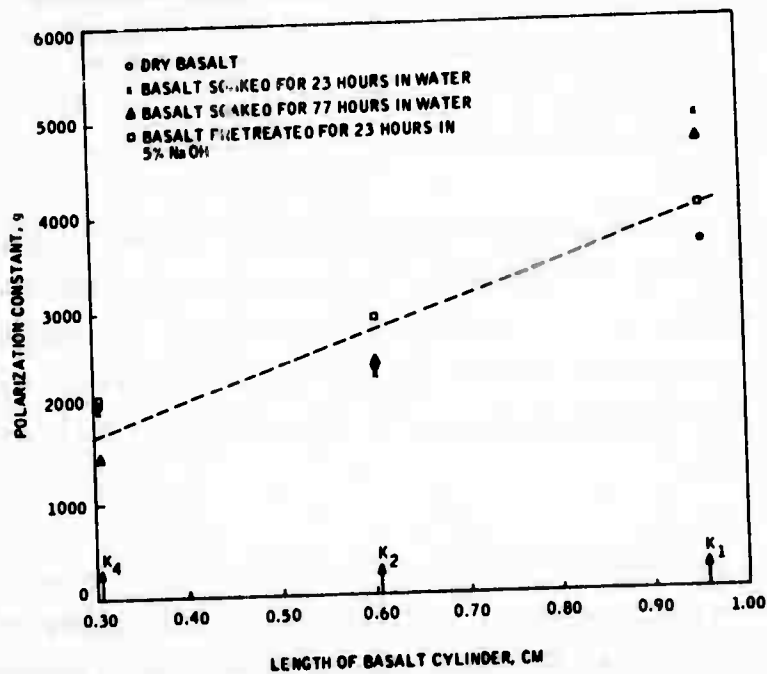


Figure 7-4. Effect of Length of Rock Cylinder on the Parameter  $g$

general,  $g$  decreases linearly with increasing sodium content, except for the thinner rock samples  $K_2$  and  $K_4$  where a slight increase in  $g$  is observed between 0 and 1 percent sodium hydroxide. Linear least-square fitting of the data gives the following relationships:

For basalt sample  $K_1$

$$g = 4989 - 180C \quad (7-35)$$

For basalt sample  $K_2$

$$g = 2885 - 37.5C \quad (7-36)$$

For basalt sample  $K_4$

$$g = 2249 - 35.4C \quad (7-37)$$

Systematic variations of the parameter  $g$  with the rock dimension are also evident from the data in Table 7-2. The variation of  $g$  with thickness of the basaltic rock cylinders is shown in Figure 7-4. The data indicate a systematic increase in  $g$  with increasing rock thickness.

#### CORRELATION OF IMPEDANCE POLARIZATION ARTIFACTS WITH THE MODEL

Electrode polarization effects have been found to constitute an integral part in impedance measurements. Polarization effects are simulated by the model resistor  $r_1 = g/f^n$ , which is parallel with the  $R_p C_p$  unit that represents the dielectric in Figure 7-1. The presence of  $r_1$  in the model accounts for the observed deviation from the ideal or Debye dielectric behavior, and hence for the observance of a circular arc with a depressed center, rather than the Debye full semicircle in the Argand diagram.

When various basalt samples were pretreated in solutions of sodium hydroxide of various concentrations for a period of 23 hours, the polarization parameter,  $g$ , was found to decrease nearly linearly with increasing concentration of the sodium ion. It also decreases systematically with decreasing rock thickness. The exponent,  $n$ , on the other hand appears to be independent of the rock condition, dimension, or pretreatment history.

The foregoing findings suggest that most of the polarization effects reside in the electrical double layer at the rock/electrode interfacial contact. The mobile sodium ions are expected to influence the structure, and hence the relaxation properties of this double layer. Remembering that  $r_1$  is in parallel with the dielectric model of Figure 7-1, it can be appreciated that polarization will be stronger at smaller values of  $r_1$  (or  $g$ ); i. e., in the presence of larger sodium ion contents.

#### CORRELATION OF $r_1$ WITH THE WARBURG POLARIZATION

The suggested model of Figure 7-1, with its unusual resistor  $r_1$ , provides a useful mechanism for explaining the observed results; i. e., the appearance of a circular arc with a depressed center in the Argand diagram relating the series reactance,  $X_s$ , to the series resistance,  $R_s$  (both measured at the same frequency). Electrochemical literature had often revealed many such unusual electrical components to account for electrode polarization effect. The Warburg electrochemical formula (Equation 7-13) suggests that the electrolytic polarization resistance is inversely proportional to the square root of frequency.

To explore the polarization significance of  $r_1$ , the data on dry basalt (Table 6-1) were examined in some detail. The variation of  $r_1$  for dry basalt with  $1/\sqrt{f}$  yielded a curvilinear plot, as shown in curve "a" of Figure 7-5. The points at frequencies larger than 100 Hz (the initial segments of curve "a" at  $1/\sqrt{f}$  less

than 0.1) appear to represent a straight line. This tangential line (curve "b" of Figure 7-5) has a slope of 2509 and is taken to represent the Warburg resistance for dry basalt.

$$r_w = \frac{g_1}{\sqrt{f}} = \frac{2509}{\sqrt{f}} \quad (7-38)$$

The Warburg line (curve "b") was extrapolated to very low frequencies and subtracted point by point from curve "a". The resulting "difference curve" was concave as shown in curve "c" of Figure 7-5. When the data on curve "c" were plotted as a function of  $1/f$ , straight line "d" in Figure 7-5 resulted. A new resistance,  $r_k = g_2/f$ , is therefore assumed to describe the polarization at very low frequencies. The slope of line "d" for the variation of this new resistance with  $1/f$  gives a value of 4032 megohm Hz for  $g_2$  of dry basalt.

The unusual resistor,  $r_1$ , appears to be analytically composed of two polarization terms, one of which is the Warburg resistance; thus,

$$\begin{aligned} r_1 &= r_w + r_k \\ &= \frac{g_1}{\sqrt{f}} + \frac{g_2}{f} = \frac{g}{f^n} \end{aligned} \quad (7-39)$$

For dry basalt

$$r_1 \text{ (megohms)} = \frac{2509}{\sqrt{f}} + \frac{4032}{f} = \frac{3626}{f^{0.71}} \quad (7-40)$$

Table 7-3 gives the parameters  $g_1$  and  $g_2$  for the rest of the basalt rock samples in the dry state as well as those following water soaking and pretreatment in sodium hydroxide. Except in a few instances, both  $g_1$  and  $g_2$  decrease

Table 7-3. Basalt Parameters of the Equation  $r_1 = \frac{g_1}{\sqrt{f}} + \frac{g_2}{f}$ 

Sample → Basalt Rock State ↓	K <sub>1</sub>		K <sub>2</sub>		K <sub>4</sub>	
	g <sub>1</sub>	g <sub>2</sub>	g <sub>1</sub>	g <sub>2</sub>	g <sub>1</sub>	g <sub>2</sub>
Basalt (dry)	2509	4032	881	1021	500	1000
Following 23 hour soak in water	2164	1625	1152	2187	1022	1302
Following 77 hour soak in water	1713	2256	1067	905	674	606
Following treatment in 1% NaOH	1796	2166	1389	1252	899	1035
Following treatment in 5% NaOH	2904	-382	1885	325	992	664
Following treatment in 10% NaOH	1414	1309	3607	-248	1102	233

with increasing sodium content in the pretreating solution as well as with decreasing rock thickness. Linear least-square fit of the data with the percentage,  $c$ , of sodium hydroxide gave the following relations:

- For rock sample K<sub>1</sub>

$$g_1 = 2241 - 43C$$

and

$$g_2 = 1536 - 89C$$



- For rock sample K<sub>2</sub>

$$g_1 = 1057 + 238C$$

and

$$g_2 = 1761 - 220C$$

- For rock sample K<sub>4</sub>

$$g_1 = 951 + 13C$$

and

$$g_2 = 1212 - 101C$$

The increase in the Warburg coefficient  $g_1$  for rock samples K<sub>2</sub> and K<sub>4</sub> with increasing sodium content is difficult to explain. Of the preceding six equations, two have a positive coefficient of  $g$  with  $c$  and the remaining have a negative coefficient. It may be suspected that the Warburg coefficient  $g_1$  increases while the very low frequency polarization coefficient,  $g_2$  decreases with increasing sodium content.

#### PHYSICAL SIGNIFICANCE OF $r_1$

The preceding data reveal the interesting finding that  $r_1$  is indeed a polarization resistance. It, therefore, represents the term in which electrode polarization artifacts reside. An equally important conclusion is that electrode impedance is not in series with the sample impedance as has been universally accepted, but appears to be for the most part in parallel with it.

The inherent polarization represented by  $r_1$ , and which constitutes an integral part of the measurement, is evidently responsible for the deviation of the

dielectric from the ideal or Debye behavior. The model has, therefore, permitted for the first time a clarification of the complex polarization term in rock impedance.  $R_p$  is directly determinable from the point of farthest intersection of the experimental circular arc with the  $R_s$  axis. If one corrects for the polarization effects, the time constant or relaxation time,  $\tau$ , for the ideal system is given by the product  $R_p C_p$ . For the real system, the model Equation 7-12 gives a time constant of

$$\tau = R_p C_p \sqrt{1 + K^2} \quad (7-20)$$

where  $K = \cotan \phi$  and  $\phi$  is the rock phase angle. The relaxation time,  $\tau$ , can be determined independently of the model assumptions by plotting  $-X_s$  as a function of  $\log f$ . The maximum in reactance will determine the turnover frequency,  $f_{\max}$ , from which  $\tau$  can be calculated as

$$\tau = \frac{1}{\omega_{\max}} = \frac{1}{2\pi f_{\max}} \quad (7-3)$$

The capacitance of the condenser,  $C_p$ , can thus be calculated from experimental data by Equations (7-3) and (7-20). The model, therefore, permits complete analysis of the rock impedance parameters for estimating its complex dielectric constant,  $\kappa^* = \kappa' - j\kappa''$ . Here  $\kappa'$  will be related to the condenser  $C_p$ , and  $\kappa''$  is related to the rock conductivity as given by the reciprocal of  $R_p$ .

SECTION VIII  
TECHNICAL REPORT SUMMARY AND RECOMMENDATIONS  
FOR FUTURE WORK

TECHNICAL REPORT SUMMARY

This research program was initiated to determine the electric and dielectric properties of rocks with the objective of finding a correlation between these properties and the rock geophysical characteristics and structure. Low-frequency data will eventually be useful to determine the presence of underground water and entrapped oil and gases ahead of excavation, and for underground tunneling. Accurate knowledge of the rock impedance and dielectric properties enables us to determine the attenuation of electromagnetic fields and thus predict the range and frequency for underground communication systems.

For this study program a novel technique of determining the electrical properties of rocks has been used that allows us to directly display complex impedance as a function of frequency. Three characteristic rock samples have been investigated in the frequency range from 0.05 Hz to 2 kHz. The data obtained were displayed in an Argand diagram and could be fitted very closely by an arc of circle with a depressed center.

An equivalent circuit with an RC network was used to determine from the resistivity values at zero and infinite frequencies the dielectric constant at the corresponding frequencies. The method depends on "bracketting" the circular arc in both the Argand and the Cole-Cole plot and on the assumption that a single relaxation time must be the same for both the impedance and the dielectric dispersions. The computer algorithm has been extended to derive the dielectric loss,  $\epsilon''$ , or imaginary part of the dielectric constant,  $\kappa''$ , and the real part of the dielectric constant,  $\kappa'$ , at the frequencies at which

the specific impedance parameters are measured. The conversion technique by rotating the impedance vector from the Argand plane and transforming it to the permittivity vector in the dielectric plane is novel and reported here for the first time. Application of this technique to the impedance data of basalt and quartzite gave dielectric constants that agree reasonably well with those reported in the literature.

The hypothetical electrical model used in this investigation consists of a resistor, which is frequency dependent, in parallel to a capacity. Both are shunted by a resistor. This model successfully describes the detailed experimental results. The polarization effect can be described by a resistor whose value is inversely proportional to frequency with a power between 0.5 and unity.

The electrode impedance effects have been determined from a series of measurements with slices of various thicknesses cut from the same cylindrical sample. The electrode effects are significant for thin rock samples where they may represent a substantial portion of the measured impedance. For long rock samples the electrode correction may be negligible. However, in this case the sample impedance may be comparable or larger than the amplifier impedance preventing a stable measurement.

#### RECOMMENDATIONS FOR FUTURE WORK

It is highly desirable to extend the capability of our on-line computer technique beyond the kilohertz range. Extension to the mega- and gigahertz range has been recommended in Honeywell proposal 1D-E-3, "Effect of Frequency and Temperature on Rock Dielectric Parameters." The effect of temperature on rock impedance is illustrated by the results of the following preliminary tests.

Experiments were performed on basalt (IV) to determine the effect of temperature on rock impedance. The basaltic sample (IV) used in this experiment was a large circular disc 0.54 cm in thickness and 5.21 cm in diameter. It differed from the previous Dresser basalts (I), (II), and (III) used in previous experiment in both color and grain size. The new sample was darker in its greenish tint than the former samples. The change in texture may be attributed to a different phase of rock formation. Impedance was measured at both room temperature (22°C) and the melting point of ice (0°C). At the low frequency of 0.1 Hz, the impedance at the ice point is considerably higher than that at room temperature. As the frequency increases, the temperature effect becomes less pronounced. Table 8-1 gives the resistive and reactive impedance components at room temperature and at nominal frequencies ranging from 0.1 to 2000 Hz. The variation of the series reactance at room temperature,  $X_s$ , with log frequency is shown as curve A of Figure 8-1, while curve B shows the variation of the rock series resistance,  $R_s$ . Both curves indicate a turnover frequency,  $f_{\max}$ , of 9.96 Hz, which corresponds to a room temperature relaxation time,  $\tau$ , of

$$\tau = \frac{1}{\omega_{\max}} = \frac{1}{2\pi f_{\max}} = 15.9 \text{ milliseconds} \quad (8-1)$$

When the previous experiment was repeated at the melting point of ice, the data in Table 8-2 were obtained. Variation of the impedance parameters, at room temperature with log frequency, is shown in Figure 8-2, where a turnover frequency,  $f'_{\max}$ , of 2.00 Hz is determined. At 0°C, the relaxation time is given by

$$\tau' = \frac{1}{2\pi f'_{\max}} = 79.5 \text{ milliseconds} \quad (8-2)$$

Table 8-1. Impedance Data on Basalt (IV) at 22°C

LAST RECORD IS T4- 2 4/23/71  
ZEEGO MOD I

B6-1 4/26/71

ENTER RCAL/UNITS  
20.  
MEGS

FRQ	RES	RAEC	PHI
0.09	32.6651	-3.5772	-6.25
0.50	26.5789	-4.5407	-9.70
0.99	24.4720	-5.3178	-12.26
2.00	21.8083	-6.1671	-15.79
5.02	17.6153	-7.0980	-21.95
7.95	15.2352	-7.2887	-25.57
9.96	14.0585	-7.2072	-27.43
14.97	11.9454	-7.1602	-30.90
20.02	10.4838	-6.9575	-33.57
30.03	8.5419	-6.5137	-37.33
40.16	7.2568	-6.1103	-40.10
50.10	6.3452	-5.7679	-42.27
99.50	4.0188	-4.5073	-48.28
200.27	2.3545	-3.2393	-53.99
503.36	1.1232	-1.8585	-58.86
998.19	0.6598	-1.1528	-60.22
2022.06	0.4074	-0.6540	-58.00

17 SAMPLES

CIRCLE CENTER = 16.9612 20.4344  
RADIUS = 27.6828  
ERROR 0.88188 REDUCED TO 0.58838  
IN 17 STEPS

Table 8-2. Impedance Data on Basalt (IV) at 0°C

## CRT CALIBRATION

DATA TAPE ON UNIT 2 - PUSH START

\*\*\*\*\* PAUS \*\*\*\*\*

LAST RECORD IS B6-1 4/26/71

ZEEGO MOD I

B7-1 4/26/71

ENTER RCAL/UNITS

20.

MEGS

FRQ	RES	RAEC	PHI
0.09	160.3149	-26.5281	-9.40
0.50	110.5509	-36.2007	-18.16
0.99	92.3657	-39.2870	-23.04
2.00	72.3747	-39.8985	-28.87
5.00	47.1312	-36.0387	-37.41
7.96	35.9375	-32.2504	-41.91
9.95	31.1345	-30.1291	-44.06
20.02	19.0096	-22.9683	-50.39
30.08	13.8184	-18.9881	-53.96
40.23	10.8011	-16.3439	-56.54
50.05	8.8994	-14.4474	-58.37
99.50	4.7105	-9.4347	-63.47
200.27	2.3633	-5.7473	-67.65
504.20	0.9996	-2.7933	-70.32
998.19	0.5700	-1.5737	-70.10
2018.35	0.3682	-0.8424	-66.40

16 SAMPLES

CIRCLE CENTER = 91.5041 87.5214  
 RADIUS = 129.8529  
 ERROR 5.15521 REDUCED TO 2.35518  
 IN 11 STEPS

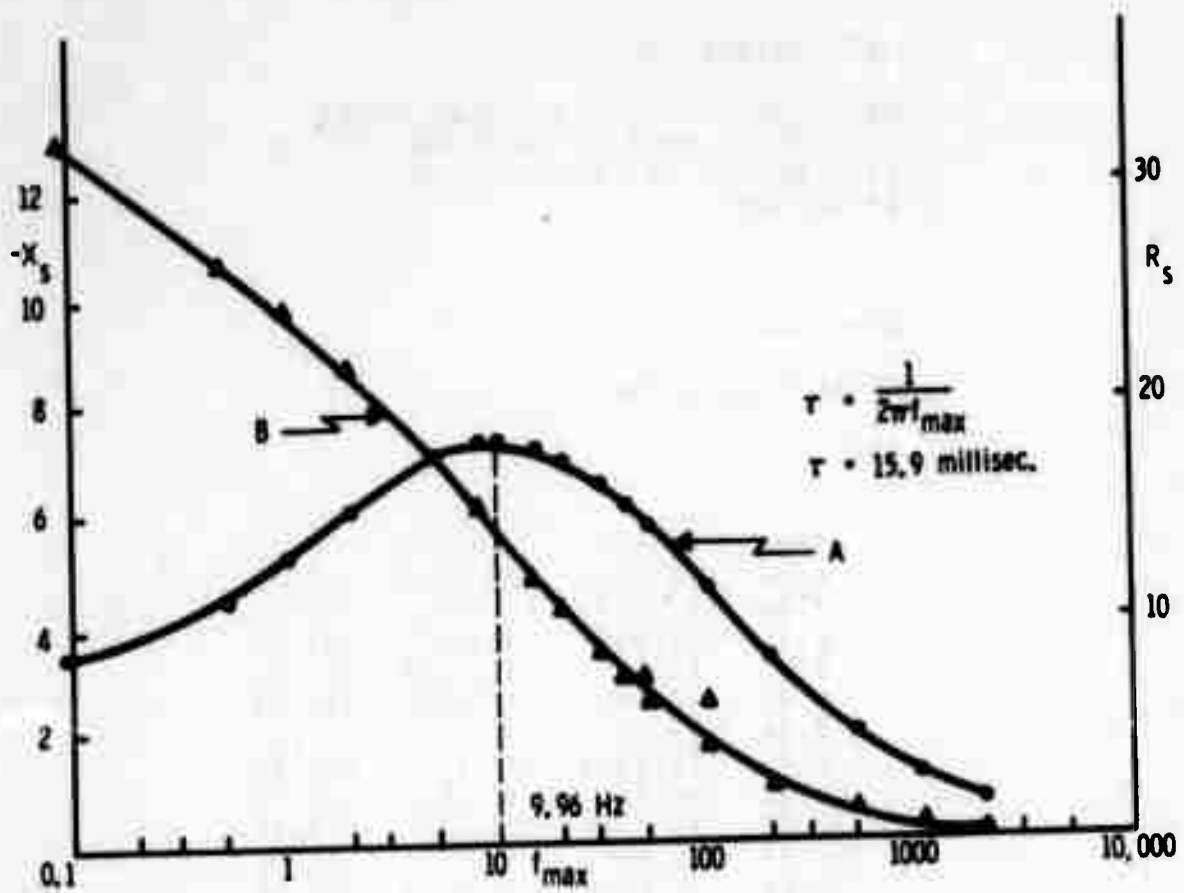


Figure 8-1. Variation of Impedance Parameters with Log Frequency for Dresser Basalt (IV) at Room Temperature, 22°C



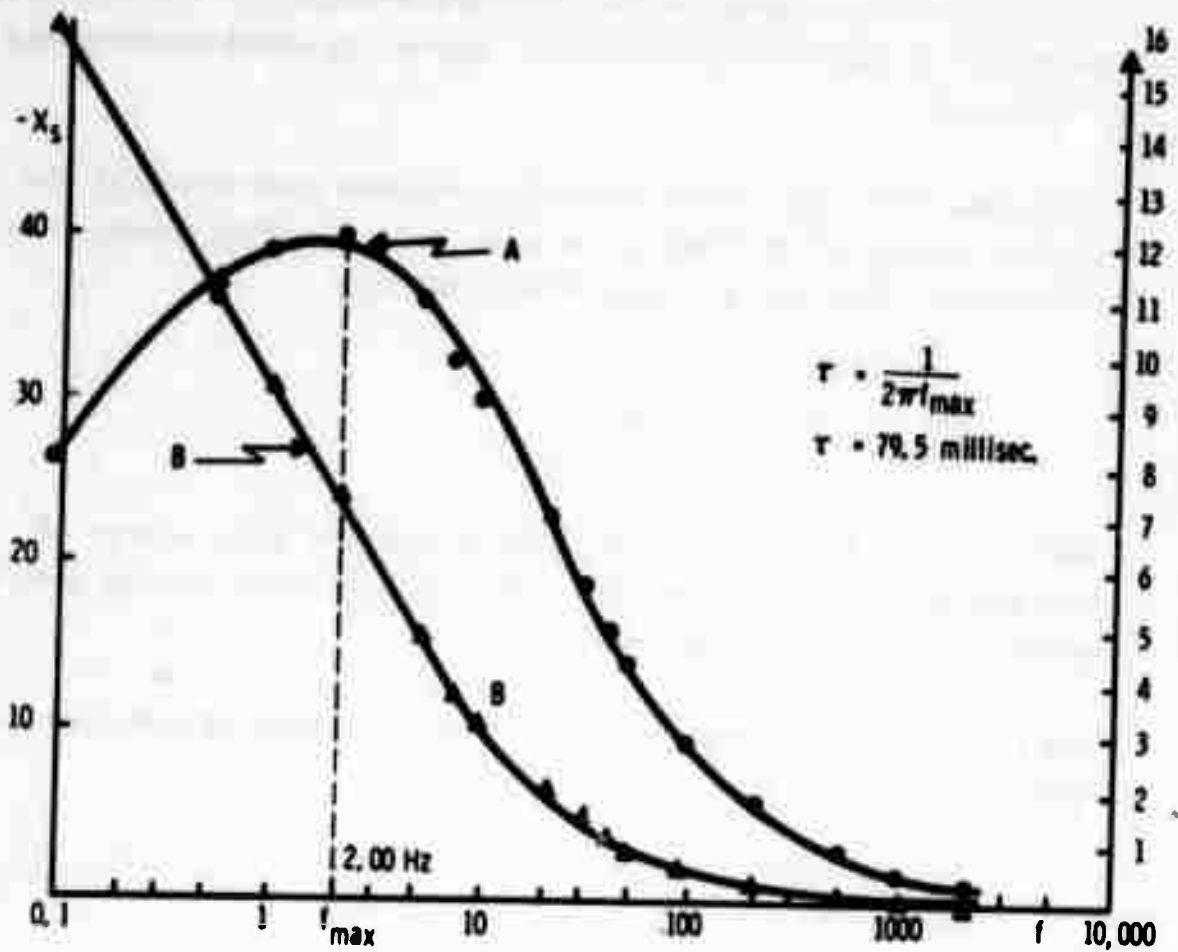


Figure 8-2. Variation of Impedance Parameters with Log Frequency for Dresser Basalt (IV) at 0°C

The rock d-c resistance,  $R_0$ , at 0°C is 191.8 megohms, which should be compared to the room temperature value of 37.3 megohm. Thus both rock d-c resistance and relaxation time decrease significantly with rise in temperature. At higher frequencies, the temperature effect becomes less pronounced.

According to Eyring's theory of absolute reaction rates (Ref. 26), the turn-over or characteristic frequency is equal to the universal frequency ( $kT/h$ ), modified by a free energy of activation term; thus

$$f_{\max} = \left( \frac{kT}{h} \right) e^{-\Delta F^\dagger / RT} \quad (8-3)$$

where  $k$  is Boltzmann's constant,  $T$  is the absolute temperature,  $\Delta F^\dagger$  is the free energy of activation per mole of the relaxing unit within the rock matrix, and  $R$  is the molar gas constant.

The free energy of activation is related to the enthalpy of activation,  $\Delta H$ , per mole of relaxing units by

$$\Delta F^\dagger = \Delta H^\dagger - T\Delta S^\dagger \quad (8-4)$$

where  $\Delta S^\dagger$  is the entropy of activation. Applying Equation (8-4) into (8-3), one obtains

$$f_{\max} = \left( \frac{kT}{h} \right) e^{\Delta S^\dagger / R} e^{-\Delta H^\dagger / RT} \quad (8-5)$$

or

$$\ln (f_{\max}/T) = \ln \frac{k}{h} + \frac{\Delta S^\ddagger}{R} - \frac{\Delta H^\ddagger}{RT} \quad (8-6)$$

Normally one determines  $f_{\max}$  at a series of temperatures and establishes the validity of the foregoing equations by ascertaining that the plot of  $\ln (f_{\max}/T)$  against  $(1/T)$  is linear. From the slope of this linear plot one determines the enthalpy or heat of activation,  $\Delta H^\ddagger$ ; thus,

$$\text{Slope} = - \frac{\Delta H^\ddagger}{R} \quad (8-7)$$

and from the intercept of the linear plot with the ordinate, one can determine the entropy of activation,  $\Delta S^\ddagger$ ; thus,

$$\text{Intercept} = \ln \left( \frac{k}{h} \right) + \frac{\Delta S^\ddagger}{R} \quad (8-8)$$

Applying Equation (8-5) to the data obtained in this preliminary work, and remembering that  $T = 295^\circ\text{K}$  for room temperature ( $22^\circ\text{C}$ ), and  $T = 273^\circ\text{K}$  for the ice point, then

$$\frac{(f_{\max}/T)}{(f'_{\max}/T')} = e^{-\frac{\Delta H^\ddagger}{R} \left( \frac{1}{T} - \frac{1}{T'} \right)}$$

or

$$\ln \left[ \frac{f_{\max} T'}{f'_{\max} T} \right] = \frac{\Delta H^\ddagger}{R} \left[ \frac{1}{T'} - \frac{1}{T} \right] \quad (8-9)$$

The enthalpy of activation,  $\Delta H^\dagger$ , is calculated from Equation (8-9); thus

$$\Delta H^\dagger = 2.303R \frac{TT'}{(T - T')} \log \left[ \frac{f_{\max} T'}{f'_{\max} T} \right] = 10,700 \text{ calories}$$

For one mole of the relaxing unit within the rock (92 grams for the  $\text{SiO}_4$  tetrahedron).

Hence, it is estimated that the activation energy for the relaxation process in basalt is about 11 Kcal per mole of relaxing units, or about 0.5 ev (1 ev = 23.05 Kcal/mole).

Future work in this area will further investigate the influence of temperature on the relaxation process and utilize it to compute both the enthalpy and entropy of activation. Further studies of the pressure effect should yield more information on the volume of activation and entropy of activation of aggregate interactions. This new set of data should yield deeper insights in rocks' ultimate structure and their petrogenesis.

The complex impedance of rock samples at a range of frequencies that brackets their turnover frequency would yield valuable information on the relaxation time(s) of the silica tetrahedra and other structural groups within the rock, and the presence or absence of conductive materials. In general, a Cole-Cole circular-arc plot would be obtained in the complex dielectric diagram. With complex structures, the resulting figure may be analyzed into a series of nearby semicircular arcs, each describing a given relaxation mechanism with some interaction coefficients among the various aggregates (Refs. 27 and 28). The same Cole-Cole plot can be obtained in a complex impedance diagram, sometimes called Argand diagram. Sinbel (Khalafalla) (Ref. 20) showed that the plot of the series reactance,  $X_g$ , against the series resistance,  $R_g$  (both determined at a given frequency), in a complex system should yield a semicircle arc. The intersection of this circular arc with the real (resistive)

axis will define the d-c resistance,  $R_0$  (at the farthest right end). Any point on the arc will define the impedance radius vector with both its reactive and resistive components readily available.

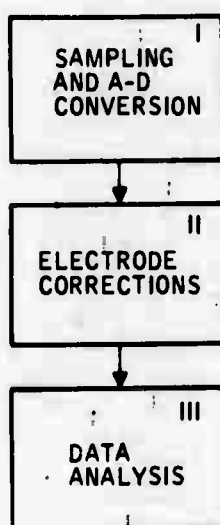
Structural relaxation times in rocks can also provide valuable information in rock elastic moduli. Debye (Ref. 18) related relaxation times to viscosity in liquid systems. Elasticity corresponds to mechanically recoverable energy and viscous flow or friction to the conversion of mechanical energy into heat. Because of the similarity between viscous resistance to flow and friction between solid surfaces, the resistance to flow of a fluid is the analogue to internal friction or shear within a solid. These areas of endeavor in rock dielectric relaxation constitute our long range research goals.

In his opening remarks for "tables of dielectric materials" Professor Arthur R. Von Hippel (Ref. 9), a leading authority who heads this country's clearing house for information about dielectrics since World War II, states "We are fully aware that these data should be expanded, especially towards higher temperatures and frequencies; that a real dielectric analysis of the materials should be undertaken, linking the dielectric response to composition and structure..." We believe the rock data in this research are a step toward achieving these goals.

## SECTION IX COMPUTER ALGORITHMS

### DATA PROCESSING AND COMPUTER PROGRAMS

The system is composed of three main programs:



These three programs are described in further detail on the following pages. Program listings are included for programs II and III. Program I contains much machine language code; therefore, its listing was not included.

#### SAMPLING AND A-D CONVERSION

##### Description

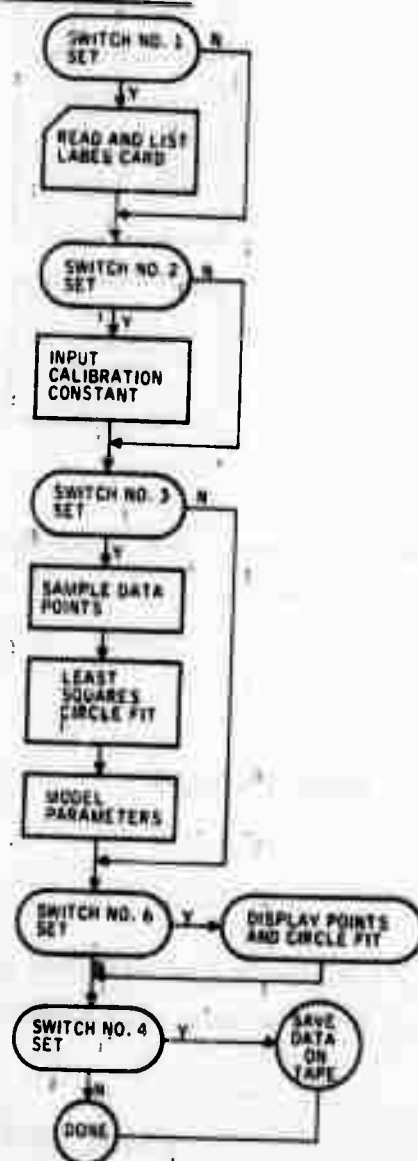
The output of the rock amplifier is sampled and converted to digital form. Provision is made to enter a calibration constant for the circuit. At each

frequency the series resistance  $R_s$ , series reactance  $X_s$ , series reactance  $X_s$ , and phase, angle are listed.

When all points have been sampled, a least-squares fit is made to the  $R_s$ ,  $X_s$  data. This arc and the data points are optionally displayed on a CRT screen.

The data can also be stored on magnetic tape to be used by other programs in the system.

### Flow Chart - Sampling and A-D Conversion



## ELECTRODE CORRECTIONS

Description

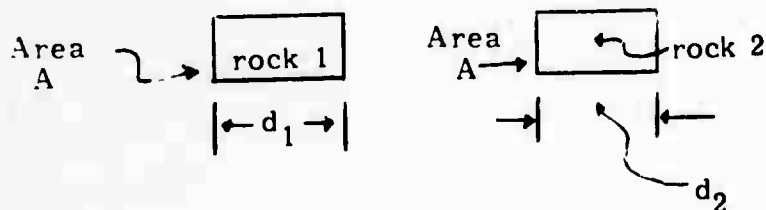
This program calculates the electrode corrections based on the  $R_s$ ,  $R_s$  data from two samples. As a further refinement in the correction technique, all pairs of three racks taken two at a time are averaged to yield a better correction for each rack.

For example,

- 1) Compute correction for K1 and K2
- 2) Compute correction for K2 and K4

Average results of (1) and (2) yield correction for K2.

The correction formula is derived as follows: consider two samples of the same rock,



For rock alone,

$$Z_R \propto \frac{d}{A}$$

$$\text{i.e., } R_R \propto \frac{d}{A}, X_R \propto \frac{d}{A}$$



Thus for two rocks,

$$\frac{R_{R_1}}{R_{R_2}} = \frac{X_{R_1}}{X_{R_2}} = \frac{d_1}{d_2} = \frac{1}{\beta} \quad (9-1)$$

We measure  $R_m$ ,  $\overline{X}_m$ , which include electrode polarization effects.

Thus,

$$\left. \begin{aligned} R_{m_1} &= R_{R_1} + R_{e_1} \\ R_{m_2} &= R_{R_2} + R_{e_2} \end{aligned} \right\} \quad (9-2)$$

from (9-1) one gets

$$\frac{R_{m_1} - R_{e_1}}{R_{m_2} - R_{e_2}} = \frac{1}{\beta} \quad (9-3)$$

assuming

$$R_{e_1} = R_{e_2} = R_e$$

then  $R_e$  can be calculated as a correction to  $R_m$ ; thus,

$$\frac{R_{m_1} - R_e}{R_{m_2} - R_e} = \frac{1}{\beta} \quad (9-4)$$

yields

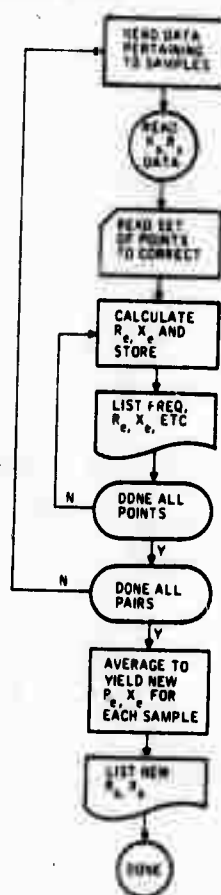
$$R_e = \frac{R_{m2} - \beta R_{m1}}{1 - \beta} \quad (9-5)$$

similarly

$$X_e = \frac{X_{m2} - \beta X_{m1}}{1 - \beta} \quad (9-6)$$

The electrode corrections  $R_e$ ,  $X_e$  arrived at in this manner are listed on the console typewriter. Cards with these correction factors can then be punched to be used by the data analysis program.

#### Flow Chart -- Electrode Correction



The Data Analysis Program consists of the main program and 5 subroutines. In brief the program does the following:

- Recalls, from magnetic tape, data points resulting from a specified experimental run.
- Selects some or all of the data points for further analysis.
- Makes phase, amplitude, and, optionally, electrode corrections to the data points before further analysis.
- Fits a "best" circle to the data points
- Determines parameters of our model from this circle.
- Determines miscellaneous parameter from the data points.

Each of these is described in more detail in the following pages, with a general flow chart of the program and a program listing.

#### LOADING EXPERIMENTAL DATA

The data from each experiment consists of 5 physical records on magnetic tape. To locate required data, the appropriate number of records is skipped and the desired 5 data records are read. The following is a brief description of these records.

- Record 1, 8 words
- Words 1-4 - label describing experiment (e. g., K4 9/17/71 77 Hr)
- Words 5, 6 - unused

- - Word 7 - N = number of data points
- Word 8 - unused.
- Record 2, 50 words (2 words/data point)

Frequency:

$$F(I) = I = 1, \dots, N \quad N \leq 25$$

- Record 3, 50 words (2 words/data point)

$R_s$ :

$$R_s(I) \quad I = 1, \dots, N \quad N \leq 25$$

- Record 4, 50 words, (2 words/data point)

$N_s$ :

$$Y(I) \quad I = 1, \dots, N \quad N \leq 25$$

- Record 5, 80 words (2 words/data point)

Working array Q:

$$Q(I) \quad I = 1, \dots, 40$$

This is an array where intermediate information is stored for communication between the main program and its subroutines. For example,  $Q(40)$  is the calibration constant used in the experiment.

## DATA SELECTION

Selection of the data points is done by the following technique.

A card is read containing the number of points to delete from further analysis  $NDEL \ 0 \leq NDEL \leq N$ .  $N$  is then decreased by this amount;  $N = N - NDEL$ .

Another card is then read specifying which points to select for this run. The points must be in ascending order and the total number of points must equal this revised N. The F, X, and Y arrays are then "compressed" (i. e., any points not selected are deleted) for ease of processing by the rest of program.

For example, assume original N = 7 and we wish to delete 2 points (2, 5):

- Card 1 contains  $\phi_2$
- Card 2 contains  $\phi_1 \phi_3 \phi_4 \phi_6 \phi_7$

## CORRECTIONS TO DATA

Uncorrected phase angle PHIM is corrected to PHI. The following equation is used.

To correct for phase X frequency errors from the frequency generator used in the experiment.

$$R_s = \frac{X(I) \cos (PHI)}{\cos (PHIM)}$$

$$X_s = \frac{Y(I) \sin (PHI)}{\sin (PHIM)}$$

In addition,  $X_s$ ,  $R_s$  are further corrected if the frequency F(I) is >1000 Hz.

Optional electrode corrections  $R_e$ ,  $X_e$  are read in on cards.

$$R_s = R'_s - R_e$$

$$X_s = X'_s - X_e$$

$$Z = \sqrt{X_s^2 + R_s^2}$$

The corrected  $X_s$ ,  $R_s$  are then stored back into  $X(I)$ ,  $Y(I)$ ;  $X_s$ ,  $R_s$ ,  $Z$  are all multiplied by  $A/d$  (AOD) for the given sample

The following are listed if desired on the console typewriter.

$$F(I), R_s, X_s R * \frac{A}{d}, X * \frac{A}{d}, PHI, Z, Z * \frac{A}{d}$$

#### FITTING CIRCLE TO DATA POINTS

Subroutine CENTER and EVAL are used together to fit a circle to  $X(I)$ ,  $Y(I)$   
 $I = 1, \dots, N$ .

Subroutine EVAL(CX, CY, R, RV, NSTEPS) does the following:

find

$$T_i = [CX - X(I)]^2 + [CY - Y(I)]^2$$

and

$$R = \sum_{i=1}^N T_i / N$$

$$RV = \left[ \sum_{i=1}^N T_i^2 / N - R^2 \right]^{1/2} \quad RV \geq 0$$

That is, it calculates the mean and standard deviation of the data points about a given center (CX, CY).

If the standard deviation is less than the previous standard deviation, the new center coordinates are stored along with the new mean and standard deviation. NSTEPS is increased by 1 and the subroutine is exited.

Subroutine CENTER utilizes subroutine EVAL as follows. A guess is made for the initial CX, CY and a counter Ns is set to zero. Call EVAL and store CX, CY, and standard deviation.

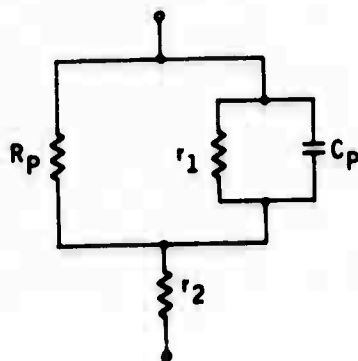
By successively modifying CX, CY and calling EVAL, a search is made for the CX, CY yielding the lowest standard deviation. These coordinate CX, CY, the radius, and

$$\text{FIT} = \frac{100 * \text{standard deviation}}{R}$$

is printed and control returns to the main program

#### MODEL PARAMETERS

Having found the "best" circle fit to the data points, the following parameters are calculated and printed.



$R_p$ ,  $r_2$ ,  $r_1$  are determined from the circular arc.

In addition

$$C_p = \frac{\sum_{i=2}^N \frac{1}{2} (f_i - f_{i-1}) \times (C_i - C_{i-1})}{f_n - f_1}$$

where  $f_i$  is frequency at point i,

and

$$C_i = - \frac{X_{s_i}}{2\pi f_i \left[ (R_{s_i} - R_2)^2 + X_s^2 \right]}$$

$$RHO = R_o \left( \frac{A}{d} \right) \quad \text{ohm-cm is also printed.}$$

Also calculated and printed in subroutine EPSILN are the following:

$$\tau = (R_o - R_\infty) C_p \sqrt{1 + \cotan^2 \varphi}$$

where

$$\varphi = \sin^{-1} \left[ \frac{R_o - R_\infty}{2r} \right], \quad r = \text{radius of circle}$$

$$\epsilon_o = \frac{\tau}{\frac{A}{d} R_\infty}, \quad \epsilon_\infty = \frac{\tau}{\frac{A}{d} R_o}$$

also printed for each frequency  $f_i$

$$\epsilon' = \epsilon_\infty + \frac{\epsilon_o - \epsilon_\infty}{2} \left[ 1 - \frac{\sin h(1-\alpha) s}{\cos h(1-\alpha) s + \cos \frac{\alpha \pi}{2}} \right]$$



and

$$\epsilon'' = \frac{\frac{1}{2} (\epsilon_0 - \epsilon_\infty) \cos \left( \frac{\alpha\pi}{2} \right)}{\cosh(1-\alpha)s + \sin \frac{\alpha\pi}{2}}$$

where  $s = \log_e (\omega\tau)$  and Cole-Cole parameter  $\alpha$  is related to the rock phase angle  $\varphi$ ; thus

$$\varphi = \frac{\pi}{2} (1-\alpha)$$

### MISCELLANEOUS PARAMETERS

For each of the samples K1, K2, K4 under various conditions, the following calculations were made on the uncorrected data for each frequency

$$r_1 = \frac{R_o [X_s^2 + (R_s^2 - R_\omega)^2]}{R_o [R_s - R_\omega] - [X_s^2 + (R_s - R_\omega)^2]} \quad (9-7)$$

An equation of the form

$$r_1 = \frac{g}{f^n}$$

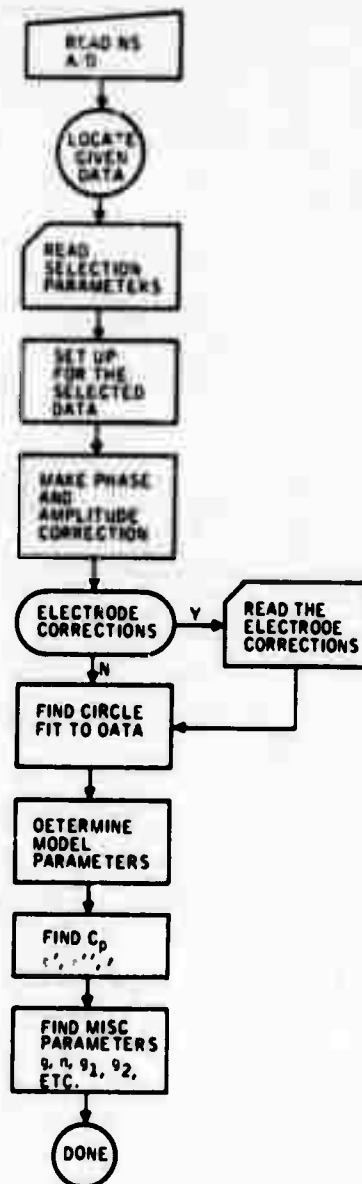
was assumed and a least-squares fit was done on the points calculated from (9-7).

An equation of form

$$r_1 = \frac{g_1}{\sqrt{f}} + \frac{g_2}{f} \quad (9-9)$$

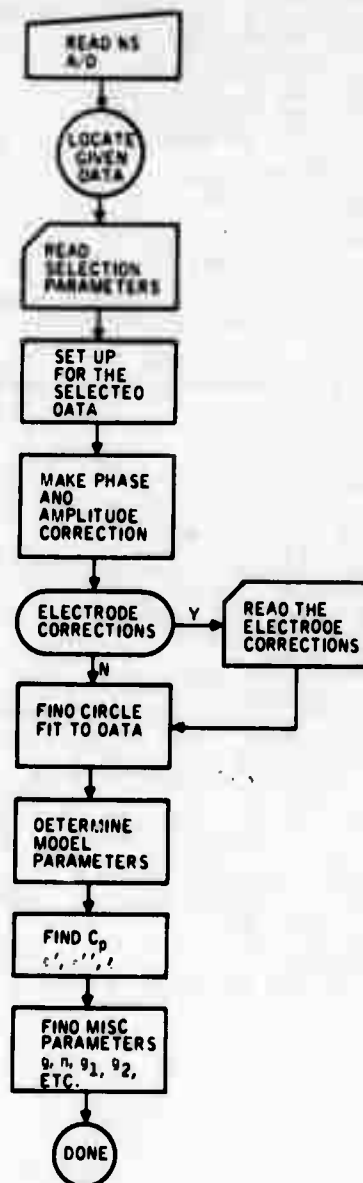
was also assumed and another least-squares fit was done on points from (9-7).

# DATA PROCESSING FLOW DIAGRAM PROGRAM LOGIC



was also assumed and another least-squares fit was done on points from (9-7).

# DATA PROCESSING FLOW DIAGRAM PROGRAM LOGIC



```

C      ELECTROE CORRECTION PROGRAM
      DIMENSION XE1(25),XE2(25),XE3(25)
      DIMENSION RE1(25),RE2(25),RE3(25)
      DIMENSION RM1(25),XM1(25),M1(25),M2(25),
      COMMON F(25),X(25),Y(25),N,3(40)
      DIMENSION LABEL(4),U(25),V(25),M(8)
      EQUIVALENCE (M(1),LABEL(1)),(M(5),UNITS),(M(7),N)
      L=0
90     L=L+1
      READ(3,103) NS1,NS2,01,02
103    FORMAT(2I3,2F10.0)
      NSKIP=5*NS1
      IF(NS1.GT.0) CALL SKIPR(2,NSKIP)
1     CALL TARO (2,M,8,4,E)
      IF(IE.EQ.3) GO TO 10
      CALL TARO (2,F,50,4,E)
      CALL TARC (2,X,50,4,E)
      CALL TARC (2,Y,50,4,E)
      CALL TARC (2,Z,80,4,E)
      REWIND 6
      WRITE(1,104) LABEL
104    FORMAT( /10X,A4)
      DO 3 I=1,N
      PHIM = ATAN2(Y(I),X(I))
      Z = SQRT(X(I)**2+Y(I)**2)
      G = Z/Q(40)
      PHI = PHIM + (7.0*ALOG10(G) + 15.0)*F(I)*0.00001
      RS = X(I)*COS(PHI)/COS(PHIM)
      XS = Y(I)*SIN(PHI)/SIN(PHIM)
      IF(F(I).LE.1000.) GO TO 4
2     CF = *(1.9*EXP(ALOG10(G)) + 4.45)*(F(I)-1000.)*0.00001 + 1.
      RS=RS/CF
      XS=XS/CF
4     RM1(I)=RS
3     XM1(I)=XS
      NSKIP=5*NS2
      IF(NS2.GT.0) CALL SKIPR(2,NSKIP)
      CALL TARC (2,M,8,4,E)
      IF(IE.EQ.3) GO TO 10
      CALL TARO (2,F,50,4,E)
      CALL TARO (2,X,50,4,E)
      CALL TARO (2,Y,50,4,E)
      CALL TARO (2,Z,80,4,E)
      REWIND 6
      WRITE(1,104) LABEL
      WRITE(1,110)
110    FORMAT(/8X1HF,11X2HRE,8X2HXE,8X2HRI,9X2HX1,9X2HR2,9X2HX2)
      DO 8 I=1,N
      PHIM = ATAN2(Y(I),X(I))
      Z = SQRT(X(I)**2+Y(I)**2)
      G = Z/Q(40)
      PHI = PHIM + (7.0*ALOG10(G) + 15.0)*F(I)*0.00001
      X(I)=X(I)*COS(PHI)/COS(PHIM)
      Y(I)=Y(I)*SIN(PHI)/SIN(PHIM)
      IF(F(I).LE.1000.) GO TO 8
      CF = *(1.9*EXP(ALOG10(G)) + 4.45)*(F(I)-1000.)*0.00001 + 1.
      X(I)=X(I)/CF
      Y(I)=Y(I)/CF
8     CONTINUE
C      RM2 AND XM2 ARE NOW IN X AND Y

```

```

      READ(3,105) NN
105  FORMAT(2E12)
      READ(3,105) (M1(J),J=1,25),
      READ(3,105) (M2(J),J=1,25)
      DO 5 I=1,NN
        J=M1(I)
        K=M2(I)
        XX=RM1(J)
        YY=X(K)
        OBO=D2/D1
        RE=(YY-D80*XX)/(1.-D80)
        XX=XM1(J)
        YY=Y(K)
        XE=(YY-D80*XX)/(1.-D80)
        RR1=RM1(J)-RE
        RR2=X(K)-RE
        XR1=XM1(J)-XE
        XR2=Y(K)-XE
        IF(L=2) 200,300,400
500  RE1(I)=RE
        XE1(I)=XE
        GO TO 500
300  RE2(I)=RE
        XE2(I)=XE
        GO TO 500
400  RE3(I)=RE
        XE3(I)=XE
500  CONTINUE
      WRITE(1,106) F(K),RE,XE,RR1,XR1,RR2,XR2
15  CONTINUE
106  FORMAT(3XF9.3,3X2F10.3,4F11.4)
      IF(L=2) 90,90,550
550  CONTINUE
      DO 1000 L=1,3
        DO 1000 I=1,NN
          IF(L=2) 600,700,800
600  RE=.5*(RE1(I)+RE2(I))
        XE=.5*(XE1(I)+XE2(I))
        GO TO 900
700  RE=.5*(RE2(I)+RE3(I))
        XE=.5*(XE2(I)+XE3(I))
        GO TO 900
900  RE=.5*(RE1(I)+RE3(I))
        XE=.5*(XE1(I)+XE3(I))
900  CONTINUE
      WRITE(1,8000) RE,XE
8000  FORMAT(2F11.5)
1000 CONTINUE
10  STOP
      END

```

\*FORTMAN LS

```

1: C  MAKES PHASE AND AMPLITUDE CORRECTIONS TO RAW DATA
2: C  MAKES ELECTRODE CORRECTIONS (SSW 1)
3: C  CIRCLE FITS CORRECTED DATA
4: C  CALCULATES PERMITTIVITY AND LOSS FACTOR
5:    COMMON F(25),X(25),Y(25),N,Q(40),CP
6:    DIMENSION LABEL(4),U(25),V(25),M(8)
7:    EQUIVALENCE (M(1),LABEL(1)),(M(5),UNITS),(M(7),N)
8:    DIMENSION MAP(25)
9:    DIMENSION REV(25),XEV(25)
10:   WRITE(1,102)
11:   102 FORMAT(51HENTER NS,A00 PUT SSW1 UP FOR ELECTRODE CORRECTION)
12:   READ(1,103) NS,A00
13:   103 FORMAT(13,F10.0)
14:   NSKIP=5*NS
15:   IF(NS.GT.0)CALL SKIPR(2,NSKIP)
16:   1 CALL TARO (2,M,8,4,E)
17:   IF(IE.EQ.3) GO TO 10
18:   CALL TARO (2,F,50,4,E)
19:   CALL TARO (2,X,50,4,E)
20:   CALL TARO (2,Y,50,4,E)
21:   CALL TARO (2,Q,80,4,E)
22:   REWIND 6
23:   READ(3,8000) NOEL
24:   N=N+NDEL
25:   READ(3,8000) MAP
26:   8000 FORMAT(25I2)
27:   DO 300 I=1,N
28:   J=MAP(I)
29:   IF(I=J) 290,300,290
30:   290 F(I)=F(J)
31:   X(I)=X(J)
32:   Y(I)=Y(J)
33:   300 CONTINUE
34:   WRITE(1,104) LABEL,A00
35:   104 FORMAT(//10X4A4,10X4MA00=F9.5,5X29HPHASE AND AMPLITUDE CORRECTED/)
36:   CALL SSWTCH(5,15)
37:   IF(15.EQ.1) GO TO 50
38:   WRITE(1,101)
39:   101 FORMAT(//8X3HFRQ,8X2HRS,10X2HXS,9X4HMA00,10X4HXA00, 8X3HPMI,10X1HZ,
40:   18X4ZA00)
41:   50 CONTINUE
42:   DO 3 I=1,N
43:   PHIM = ATAN2(Y(I),X(I))
44:   Z = SQRT(X(I)**2+Y(I)**2)
45:   G = Z/Q(40)
46:   PHI = PHIM + (7.0*ALOG10(G) + 15.0)*F(I)*0.00001
47:   RS = X(I)*COS(PHI)/COS(PHIM)
48:   XS = Y(I)*SIN(PHI)/SIN(PHIM)
49:   IF(F(I).LE.1000.) GO TO 4
50:   2 CF = ((1.9*EXP(ALOG10(G)) + 4.45)*(F(I)-1000.)*0.00001 + 1.
51:   RS=RS/CF
52:   XS=XS/CF
53:   Z=Z/CF
54:   4 CALL SSWTCH(1,11)
55:   REV(I)=0.
56:   XEV(I)=0.
57:   IF(11.EQ.2) GO TO 6
58:   READ(3,106) RE,XE
59:   106 FORMAT(2F10.0)

```

```

60:      RS=NS-RE
61:      XS=XS-XE
62:      REV(1)=RE
63:      XEV(1)=XE
64:      PH1=ATAN2(XS,RS)
65:      Z=SCAT(XS**2+RS**2)
66:      PHI=PH1-57.3
67:      RABD=RS*ABD
68:      XABD=XS*ABD
69:      ZABD=Z*ABD
70:      X(1)=R8
71:      Y(1)=XS
72:      CALL SWITCH(5,15)
73:      IF(15.EC+1) GO TO 3
74:      WRITE(1,105) F(1),R5,XS,RABD,XABD,PH1,Z,ZABD
75:      105 FORMAT(3XF9.3,2XF10.4,2XF10.4,2XF10.4,2XF10.4,2XF10.4,4XF10.4,2X,
76:      1F10.4)
77:      3 CONTINUE
78:      CALL CENTER
79:      CALL MODEL
80:      RMD=Q(5)*ABD*.1E+8
81:      WRITE(1,8030) RMD
82:      8030 FORMAT(/6H RMD =,E12.5,7H 6MM=CM )
83:      CALL CAP
84:      CALL EPB(LN(ABD))
85:      WRITE(1,8060)
86:      8060 FORMAT(/23H DET. G.M FOR R103/F00N,/)
87:      C=0.0 UNCORRECT
88:      DO 150 I=1,N
89:      X(I)=X(I)*REV(I)
90:      150 Y(I)=Y(I)*XEV(I)
91:      CALL CENTER
92:      CALL MODEL
93:      SX=0.
94:      SY=0.
95:      SXY=0.
96:      SX2=0.
97:      WRITE(1,8040)
98:      8040 FORMAT(/7H 1MF,8X,6H F=1/2,7X,2HR1,9X,2HXP,6X,2HCP,/)
99:      DO 200 I=1,N
100:      TEMP=Y(I)**2*(X(I)-Q(6))**2
101:      R1=Q(5)*TEMP/(Q(5)*(X(I)-Q(6))-Y(I)**2-(X(I)-Q(6))**2)
102:      XP=TEMP/Y(I)
103:      CP=Y(I)/(6.283*F(I)*TEMP)
104:      SQF=1./SQRT(F(I))
105:      WRITE(1,8010) F(I),SQF,R1,XP,CP
106:      8010 FORMAT(4F11.4,E12.4)
107:      SX=3X*ALOG(F(I))
108:      SY=5Y*ALOG(M1)
109:      SX2=5X2*ALOG(F(I))**2
110:      SXY=5XY*ALOG(R1)*ALOG(F(I))
111:      200 CONTINUE
112:      XN=N
113:      BOT=SX**2-XN*SX2
114:      A=(8X*SXY-BY*SX2)/BOT
115:      A=EXP(A)
116:      B=(XN*8XY-BY*SX)/BOT
117:      WRITE(1,8020) A,B
118:      8020 FORMAT(/ 3H G=,E12.5,3H N=,E12.5)
119:      C=0.0 CORRECT
120:      DO 250 I=1,N
121:      X(I)=X(I)*REV(I)
122:      250 Y(I)=Y(I)*XEV(I)
123:      10 STOP
124:      ENO

```

```

1:      SUBROUTINE EPSILN(A00)
2:      COMMON F(25),X(25),Y(25),N,Q(40),CP
3:      DIMENSION EP(25),EPP(25)
4:      ARG=(Q(5)-Q(6))/2./Q(4)
5:      P=ATAN(ARG/SQRT(1.-ARG**2))
6:      AP=1.5708-P
7:      A= 1.-P/1.5708
8:      TAU=(Q(5)-Q(6))*CP*SQRT(1.+(COS(P)/SIN(P))**2)
9:      EA=8.85E-06*A00
10:     EO=TAU/(EA*Q(6))
11:     EINF=TAU/(EA*Q(5))
12:     C=COS(AP)
13:     S=SIN(AP)
14:     E=.5*(EO-EINF)
15:     T1=TAU*1.0E+03
16:     WRITE(1,202) T1,EO,EINF
17: 202   FORMAT(/ 4HTAU=F10.5,4HMSEC,10X3HEO=F10.5,10X5HEINF=F10.5)
18:     WRITE(1,201)
19: 201   FORMAT(/ 8X3HFRQ,8X2HEP,10X3HEPP,/)
20:     DO 10 I=1,N
21:     S=ALOG(6.283.F(I),TAU)
22:     SH=.5*(EXP((1.-A)*S)+EXP(-(1.-A)*S))
23:     CH=.5*(EXP((1.-A)*S)+EXP(-(1.-A)*S))
24:     EP(I)=EINF+E*(1.-SH/(CH+C))
25:     EPP(I)=E*C/(CH+S)
26:     WS=1./(6.28*F(I))**2
27:     WRITE(1,200) F(I),EP(I),EPP(I)
28: 200   FORMAT(3X,F9.3,3E15.6)
29: 10    CONTINUE
30:     RETURN
31:     END

```



```

11: SUBROUTINE CENTER
12: COMMON F(25),X(25),Y(25),N,Q(40),CP
13: NC=1+N/2
14: X1=(X(1)+X(NC))/2.
15: X2=(X(NC)+X(N))/2.
16: Y1=(Y(1)+Y(NC))/2.
17: Y2=(Y(NC)+Y(N))/2.
18: S1=(X(1)-X(NC))/(Y(NC)-Y(1))
19: S2=(X(NC)-X(N))/(Y(N)-Y(NC))
20: CX=(Y1-Y2-S1*X1-S2*X2)/(S2-S1)
21: CY=S1*(CX-X1)+Y1
22: AS=D
23: CALL EVAL(CX,CY,R,RV,NS)
24: Q(1)=CX
25: Q(2)=CY
26: Q(3)=RV
27: D=R
28: DO 6 IG=1,10
29: D=D/2.
30: CX=Q(1)
31: CY=Q(2)
32: RV=Q(3)
33: CXP=CX*D
34: CXM=CX*D
35: CYP=CY*D
36: CYM=CY*D
37: CALL EVAL(CXP,CY,XXX,RXP,NS)
38: CALL EVAL(CXM,CY,XXX,RXM,NS)
39: CALL EVAL(CX,CYP,XXX,RYP,NS)
40: CALL EVAL(CX,CYM,XXX,RYM,NS)
41: GX=RXP-RXM
42: GY=RYP-RYM
43: XM=SQRT(GX*GX+GY*GY)
44: GX=GX*D
45: GY=GY*D
46: DO 4 I=1,60
47: CXN=CX+GX
48: CYN=CY+GY
49: CALL EVAL(CXN,CYN,RNEW,RVNEW,NS)
50: IF(RVNEW-GE*RV) GO TO 5
51: CX=CXN
52: CY=CYN
53: RV=RVNEW
54: 5 CONTINUE
55: 6 CONTINUE
56: FIT = 100.0*Q(3)/Q(4)
57: WRITE(1,210) Q(1),Q(2),Q(4),FIT
58: 210 FORMAT(//25HRS,XS CIRCLE FIT RESULTS=,2X15HCIRCLE CENTER =2F10.4/3
59: 1,XBHRADIUS =F10.4/3,XBHFIT =F10.4)
60: RETURN
61: END

```

```

1:      SUBROUTINE MODEL
2:      COMMON F(25),X(25),Y(25),N,Q(40),CP
3:      CX=Q(1)
4:      CY=Q(2)
5:      R=Q(4)
6:      A=1.
7:      B=-2.*CX
8:      C=CX*CX+CY*CY-R*R
9:      DET=SQRT(B*B-4.*A*C)
10:     R2=(-B-DET)/(2.*A)
11:     RP=(-B+DET)/(2.*A) - R2
12:     M=1+N/2
13:     W=6.2832*F(M)
14:     RR=X(M)-R2
15:     XW=Y(M)
16:     SQ=RR*RR+XW*XW
17:     GP=(RP*RR-RR*RR-XW*XW)/(SQ*RP*W)
18:     R1=1/(6.2832*GP)
19:     Q(5)=RP*R2
20:     Q(6)=R2
21:     Q(8)=R1
22:     WRITE(1,220) Q(5),R2,R1,RP
23: 220  FORMAT(/3HR0,F11.4,10X5HRINF,F11.4//18HMODEL PARAMETERS -,3X4HR1 ,
24: 1F11.4,4H/FRQ/21X4HRP ,F11.4)
25:     RETURN
26:     END

```

## SECTION X

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# APPENDIX A

## PARALLEL TO SERIES TRANSFORMATION OF ELECTRICAL MODELS WITH A SINGLE TIME CONSTANT AND FREQUENCY-INDEPENDENT COMPONENTS

This appendix presents an analytical proof of the semicircle equation relating  $X_s$  to  $R_s$ . It is easy to show that a transformation of a parallel  $R_p C_p$  unit with frequency-independent components to an isoimpedic  $R_s C_s$  unit with adjustable components will result in a circular plot between  $X_s$  and  $R_s$ .

The impedance of the parallel  $R_p C_p$  unit is given by

$$\begin{aligned} Z_p &= \frac{jR_p X_p}{R_p + jX_p} = \frac{R_p X_p^2 + jR_p^2 X_p}{R_p^2 + X_p^2} \\ &= \frac{R_p X_p^2}{R_p^2 + X_p^2} + j \frac{R_p^2 X_p}{R_p^2 + X_p^2} \end{aligned} \quad (A1)$$

Comparing this equation with the series parameters  $Z_s = R_s + jX_s$ , one obtains

$$R_s = R_p \left/ \left[ 1 + \frac{R_p^2}{X_p^2} \right] \right. \quad (A2)$$

and

$$X_s = \left( \frac{R_p^2}{X_p} \right) \left/ \left[ 1 + \frac{R_p^2}{X_p^2} \right] \right. \quad (A3)$$

From Equations (A2) and (A3), the following identity can be deduced

$$X_s X_p = R_s R_p = R_s^2 + X_s^2 \quad (A4)$$

Let  $R_p$  represent a constant quantity characteristic of the rock system, call it  $2a$ , then according to Equations (A2) and (A4) one has

$$R_p = 2a = R_s \left[ 1 + \frac{R_p^2}{X_s^2} \right] = R_s \left[ 1 + \frac{X_s^2}{R_s^2} \right] \quad (A5)$$

Rearranging Equation (A5), one obtains

$$X_s^2 + R_s^2 = 2a R_s$$

or

$$X_s^2 + R_s^2 - 2a R_s + a^2 - a^2 = 0$$

hence,

$$(R_s - a)^2 + X_s^2 = a^2 \quad (A6)$$

Equation (A6) is the analytical equation of a circle of radius  $a = \frac{1}{2} R_p$ , and whose center has the coordinates  $(0, a)$  in the  $X_s, R_s$  diagram, or the Argand diagram.

The transformation from the parallel to series combination describes a semicircle in the series domain for constant parallel circuit parameters. This condition represents an ideal situation in which the system has no polarization and in which the capacitance  $C_p$  is regarded as a perfect condenser, and hence the semicircle has its center on the real axis and will pass through the origin. In all rock systems studied thus far, one always obtained a circular arc; i. e., the semicircle was translated vertically downwards, so that its center has the coordinates  $(m, -n)$ . This situation can be described as follows

$$(R_s - m)^2 + (X_s + n)^2 = a^2 \quad (A7)$$

The phase angle,  $\varphi$ , of the rock system is defined such that

$$\cos \varphi = \frac{n}{a} \quad (A8)$$

Note that  $\varphi$  is not the same as the impedance phase angle,  $\phi$ , defined by

$$\tan \phi = \frac{X_s}{R_s} = \frac{R_p}{X_p} \quad (A9)$$

The attachment of a "leak" resistance,  $r_2$ , in series with the parallel  $R_p C_p$  unit, as shown in Figure 4-1a of Section IV will also result in a semicircle with radius  $\frac{1}{2} R_p$ , and whose center has the coordinates  $(\frac{1}{2} R_p + r_2)$  and 0. This is because the impedance of this system is given by

$$\begin{aligned} Z_p &= r_2 + \frac{jX_p R_p}{R_p + jX_p} \\ &= r_2 + \frac{R_p}{\left[1 + \frac{X_p^2}{R_p^2}\right]} + j \frac{R_p^2/X_p}{\left[1 + \frac{X_p^2}{R_p^2}\right]} \end{aligned} \quad (A10)$$

Comparing Equation (A10) with the isoimpedic series parameters  $Z_s = R_s + jX_s$ , one obtains

$$R_s - r_2 = R_p / \left[1 + \frac{R_p^2}{X_p^2}\right] \quad (A11)$$

and

$$X_s = \frac{R_p^2}{X_p} / \left[1 + \frac{R_p^2}{X_p^2}\right] \quad (A12)$$

These relationships lead to

$$\frac{X_s X_p}{R_p} = R_s - r_2$$

or

$$\frac{R_p}{X_p} = \frac{X_s}{R_s - r_2} \quad (A13)$$

Combining Equations (A11), (A12) and (A13) and letting  $R_p = 2a$ , one obtains

$$(R_s - r_2) \left[ 1 + \frac{X_s^2}{(R_s - r_2)^2} \right] = 2a$$

or

$$(R_s - r_2)^2 + X_s^2 = 2a (R_s - r_2)$$

hence

$$(R_s - r_2)^2 + X_s^2 - 2a (R_s - r_2) + a^2 = a^2$$

and

$$\left[ R_s - (r_2 + a) \right]^2 + X_s^2 = a^2 \quad (A14)$$

This equation represents a circle with radius  $a = \frac{1}{2} R_p$ , and center at  $(a + r_2) = \left( \frac{R_p}{2} + r_2 \right)$ , located on the real axis.



# APPENDIX B

## RELAXATION TIME AND TURNOVER FREQUENCY OF A MODEL WITH A SINGLE TIME CONSTANT AND ONE FREQUENCY- DEPENDENT POLARIZATION RESISTANCE

Using the model in Figure 7-1, and starting with Equation (7-8) one has

$$X_s = \frac{r_1^2 R_p^2 X_p}{r_1^2 R_p^2 + X_p^2 (r_1 + R_p)^2}$$

The objective is to maximize  $X_s$  with respect to  $\omega$  (or  $f$ ). The various components are given by:

$$r_1 = \frac{g}{f}; \quad X_p = \frac{-1}{\omega C_p} = \frac{-1}{2\pi f C_p}; \quad \text{and } R_p \text{ is independent of } f.$$

$$\begin{aligned} \frac{1}{X_s} &= \frac{1}{X_p} + X_p \frac{(r_1 + R_p)^2}{r_1^2 R_p^2} \\ &= \frac{1}{X_p} + X_p \left[ \frac{1}{R_p} + \frac{1}{r_1} \right]^2 \\ &= \frac{1}{X_p} + \frac{X_p}{R_p^2} + \frac{X_p}{r_1^2} + \frac{2X_p}{r_1 R_p} \end{aligned} \tag{B1}$$

Substituting the values of  $r$ , and  $X_p$  in Equation (B1), one obtains

$$-\frac{1}{X_s} = 2\pi f C_p + \frac{1}{2\pi f C_p R_p^2} + \frac{f}{2\pi g^2 C_p} + \frac{2}{2\pi g R_p C_p} \tag{B2}$$

$$-\frac{d \left[ \frac{1}{X_s} \right]}{df} = 2\pi C_p + \frac{1}{2\pi g^2 C_p} + \frac{1}{2\pi C_p R_p^2 f^2} \tag{B3}$$

$X_s$  will be a maximum when  $\frac{1}{X_s}$  is a minimum. This happens at the turn-over frequency,  $f_{\max}$ , which is given by

$$\frac{1}{2\pi C_p R_p^2 f_{\max}^2} = \frac{4\pi^2 g^2 C_p^2 + 1}{2\pi g^2 C_p}$$

or

$$\frac{g^2}{R_p^2 f_{\max}^2} = 1 + 4\pi^2 g^2 C_p^2 \quad (B4)$$

Equation (7-9) defines  $g$  as  $\frac{1}{2\pi K C_p}$  and Equation (7-11) equates  $K$  to  $\cotan \varphi$ . Using these relations in Equation (B4), one obtains

$$\frac{1}{4\pi^2 R_p^2 C_p^2 f_{\max}^2} = 1 + K^2$$

or

$$\begin{aligned} \frac{1}{4\pi^2 f_{\max}^2} &= R_p^2 C_p^2 (1 + K^2) \\ &= R_p^2 C_p^2 (1 + \cotan^2 \varphi) \end{aligned} \quad (B5)$$

The relaxation time  $\tau = \frac{1}{\omega_{\max}} = \frac{1}{2\pi f_{\max}}$

$$\text{hence; } \tau^2 = R_p^2 C_p^2 (1 + \cotan^2 \varphi)$$

$$\text{and } \tau = R_p C_p \sqrt{1 + \cotan^2 \varphi} \quad (B6)$$

One chooses the positive root because  $\tau$  is always greater than zero.

From the experimental data,  
one measures  $R_o$ ,  $R_\infty$  and  $\varphi$ .

$$R_p = (R_o - R_\infty)$$

Hence  $\tau$  can be calculated as

$$\tau = (R_o - R_\infty) C_p \sqrt{1 + \cot^2 \varphi}$$

